

RL78/D1A RENESAS MCU

R01DS0463EJ0110
Rev. 1.10
Dec 27, 2024

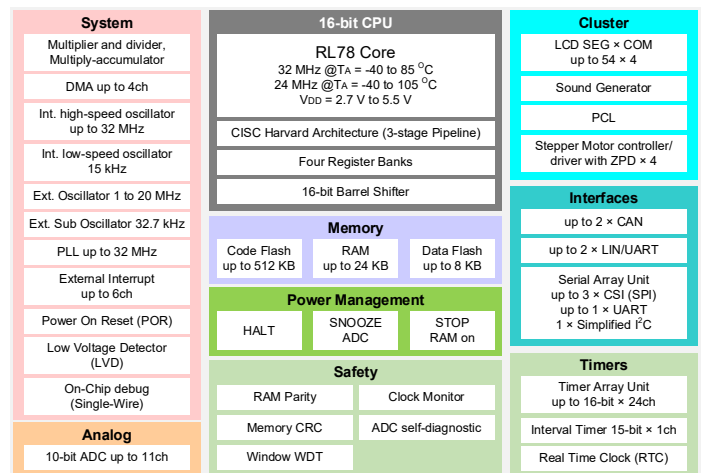
RL78/D1A microcontrollers have a built-in sound generator which can set a volume level and tone frequency of 100 Hz to 6 kHz and has an automatic volume decrement function, up to four channels of stepper motor controller/driver which can set an 8-bit precision (pseudo 9-bit precision using a 1-bit addition function) pulse width (PWM output), and an LCD controller/driver which supports up to 216 segments. The 128-pin version has a built-in LCD bus interface and two channels of CAN, and expanded flash memory/RAM up to a maximum of 512 KB/24 KB, making these microcontrollers ideal for low-end instrument cluster.

1. OUTLINE

1.1 Features

- Minimum instruction execution time can be changed from high speed (0.03125 μ s: @ 32 MHz operation with high-speed on-chip oscillator clock) to ultra low-speed (30.5 μ s: @ 32.768 kHz operation with subsystem clock)
- General-purpose register: 8 bits \times 32 registers (8 bits \times 8 registers \times 4 banks)
- ROM: 24 to 512 KB
- RAM: 2 to 24 KB
- Data flash memory: 8 KB
- On-chip high-speed on-chip oscillator clocks
Select from 32 MHz (TYP.), 24 MHz (TYP.), 16 MHz (TYP.), 8 MHz (TYP.), and 4 MHz (TYP.)
- On-chip single-power-supply flash memory (with prohibition of block erase/writing function)
- Self-programming (with boot swap function/flash shield window function)
- On-chip debug function
- On-chip power-on-reset (POR) circuit and voltage detector (LVD)
- On-chip watchdog timer (operable with the dedicated low-speed on-chip oscillator clock)
- On-chip multiplier and divider/multiply-accumulator
16 bits \times 16 bits = 32 bits (Unsigned or signed)
32 bits \div 32 bits = 32 bits (Unsigned)
16 bits \times 16 bits + 32 bits = 32 bits (Unsigned or signed)
- On-chip clock output/buzzer output controller
- On-chip BCD adjustment
- I/O ports: 38 to 112
CMOS I/O port: 35 to 107 (LED direct drive port: 9 to 16, N-ch OD selectable port: 4 to 6)
CMOS input port: 5
CMOS output port: 0 to 1
- Timer
 - 16-bit timer: 24 channels
 - Watchdog timer: 1 channel
 - Real-time clock: 1 channel
 - Interval timer: 1 channel

- Serial interface
 - CSI
 - UART (LIN-bus supported)
 - Simplified I²C communication
 - aFCAN controller
- Stepper motor controller/driver with zero point detection (ZPD): 1, 2, 4-channels
- LCD controller/driver (seg \times com): 27 \times 4, 39 \times 4, 48 \times 4, 53 \times 4 and 54 \times 4
- LCD Bus I/F
- RESET output
- STOP status output
- Sound generator
- 8/10-bit resolution A/D converter ($V_{DD} = EV_{DD} = 2.7$ to 5.5 V): 3+2 to 9+2 channels
- Standby function: HALT, STOP, SNOOZE mode
- Power supply voltage: $V_{DD} = 2.7$ to 5.5 V
- Operating ambient temperature:
 - J grade products $T_A = -40$ to $+85^\circ\text{C}$,
 - L grade products $T_A = -40$ to $+105^\circ\text{C}$



RL78/D1A Block Diagram (Outline)

Remark The functions mounted depend on the product. See 1.7 Outline of Functions.

Table 1-1. ROM, RAM capacities

Flash ROM	Data flash	RAM	48-pin		64-pin		80-pin	
512 KB	8 KB	24 KB	–	–	–	–	–	–
384 KB		20 KB	–	–	–	–	–	–
256 KB		16 KB	–	–	–	–	–	R5F10DMJxFB
128 KB		8 KB	–	–	–	–	–	R5F10DMGxFB
96 KB		6 KB	–	–	–	–	–	R5F10DMFxFB
64 KB		4 KB	–	R5F10DGE _x FB	–	R5F10DLE _x FB	R5F10CME _x FB	R5F10DME _x FB
48 KB		3 KB	R5F10CGD _x FB	R5F10DGD _x FB	R5F10CLD _x FB	R5F10DL _x FB	R5F10CMD _x FB	R5F10DMD _x FB
32 KB		2 KB	R5F10CGC _x FB	R5F10DGC _x FB	–	–	–	–
24 KB		2 KB	R5F10CGB _x FB	–	–	–	–	–
CAN (ch)			0	1	0	1	0	1
Stepper Motor (ch)			1		2		4	
LCD (seg × com)			27 × 4		39 × 4		48 × 4	

Flash ROM	Data flash	RAM	100-pin		128-pin
512 KB	8 KB	24 KB	–	R5F10DPL _x FB	R5F10DSL _x FB
384 KB		20 KB	–	R5F10DPK _x FB	R5F10DSK _x FB
256 KB		16 KB	R5F10TPJ _x FB	R5F10DPJ _x FB	R5F10DSJ _x FB
128 KB		8 KB	R5F10DPG _x FB	–	–
96 KB		6 KB	R5F10DPF _x FB	–	–
64 KB		4 KB	R5F10DPE _x FB	–	–
48 KB		3 KB	–	–	–
32 KB		2 KB	–	–	–
24 KB		2 KB	–	–	–
CAN (ch)			1	2	2
Stepper Motor (ch)			4		4
LCD (seg × com)			53 × 4		54 × 4

1.2 Applications

Automotive electrical appliances (instrument cluster)

1.3 Ordering Information

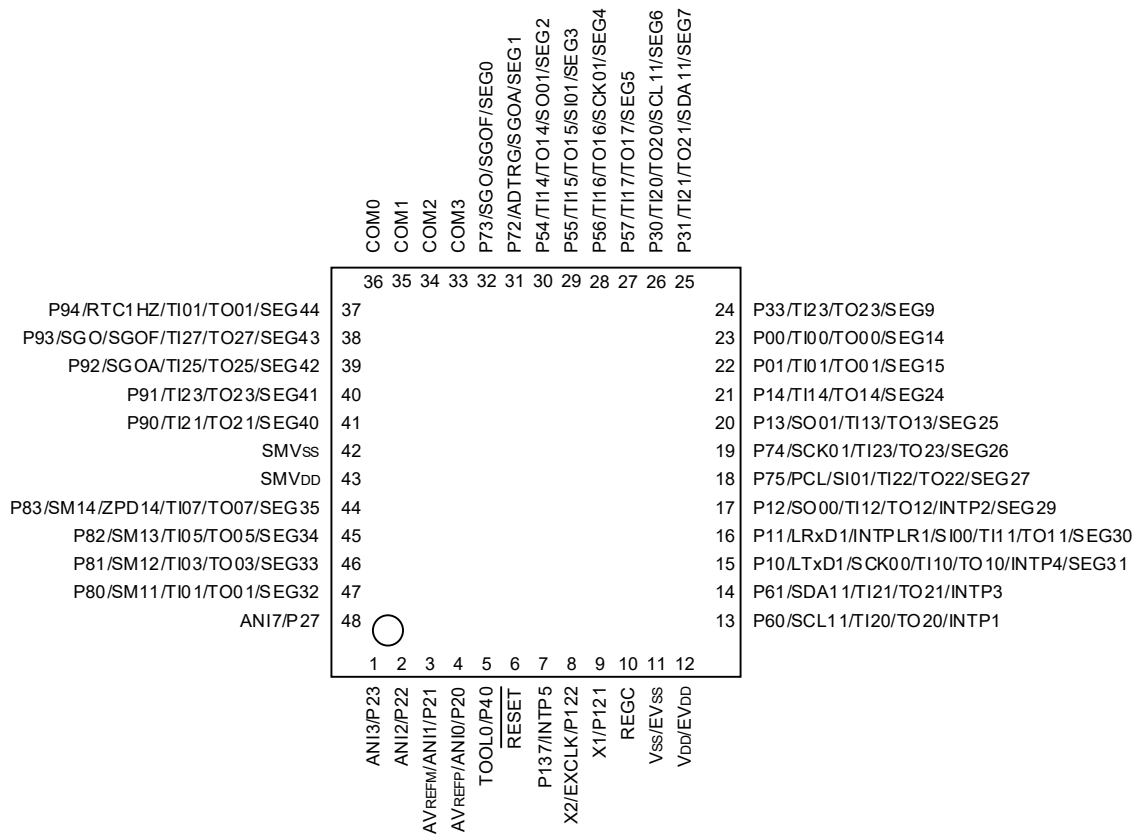
[List of Part Number]

Pin count	Package	Part Number	
		Operating ambient temperature J grade (TA = -40 to +85 °C)	Operating ambient temperature L grade (TA = -40 to +105 °C)
48-pin	48-pin plastic LQFP (fine pitch) (7 × 7)	R5F10CGBCJFB R5F10CGCCJFB R5F10CGDCJFB R5F10DGCCJFB R5F10DGDCJFB R5F10DGECJFB	R5F10CGBCLFB R5F10CGCCLFB R5F10CGDCLFB R5F10DGCCLFB R5F10DGDCLFB R5F10DGECLFB
64-pin	64-pin plastic LQFP (fine pitch) (10 × 10)	R5F10CLDCJFB R5F10DLDCJFB R5F10DLECJFB	R5F10CLDCLFB R5F10DLDCLFB R5F10DLECLFB
80-pin	80-pin plastic LQFP (fine pitch) (12 × 12)	R5F10CMDJFB R5F10CMCJFB R5F10DMDJFB R5F10DMCJFB R5F10DMFCJFB R5F10DMGCJFB R5F10DMJCJFB	R5F10CMDCLFB R5F10CMECLFB R5F10DMDCLFB R5F10DMECLFB R5F10DMFCLFB R5F10DMGCLFB R5F10DMJCLFB
100-pin	100-pin plastic LQFP (fine pitch) (14 × 14)	R5F10DPECJFB R5F10DPFCJFB R5F10DPGCJFB R5F10TPJCJFB R5F10DPJCJFB R5F10DPKJFB R5F10DPLJFB	R5F10DPECLFB R5F10DPFCLFB R5F10DPGCLFB R5F10TPJCLFB R5F10DPJCLFB R5F10DPKCLFB R5F10DPLLFB
128-pin	128-pin plastic LQFP (fine pitch) (14 × 20)	R5F10DSLJFB R5F10DSKJFB R5F10DSJJFB	R5F10DSSLFB R5F10DSKCLFB R5F10DSJCLFB

1.4 Pin Configuration (Top View)

1.4.1 48-pin products (R5F10CGBxFB, R5F10CGCxFB, R5F10CGDxFB: with no CAN)

48-pin plastic LQFP (fine pitch) (7 × 7)

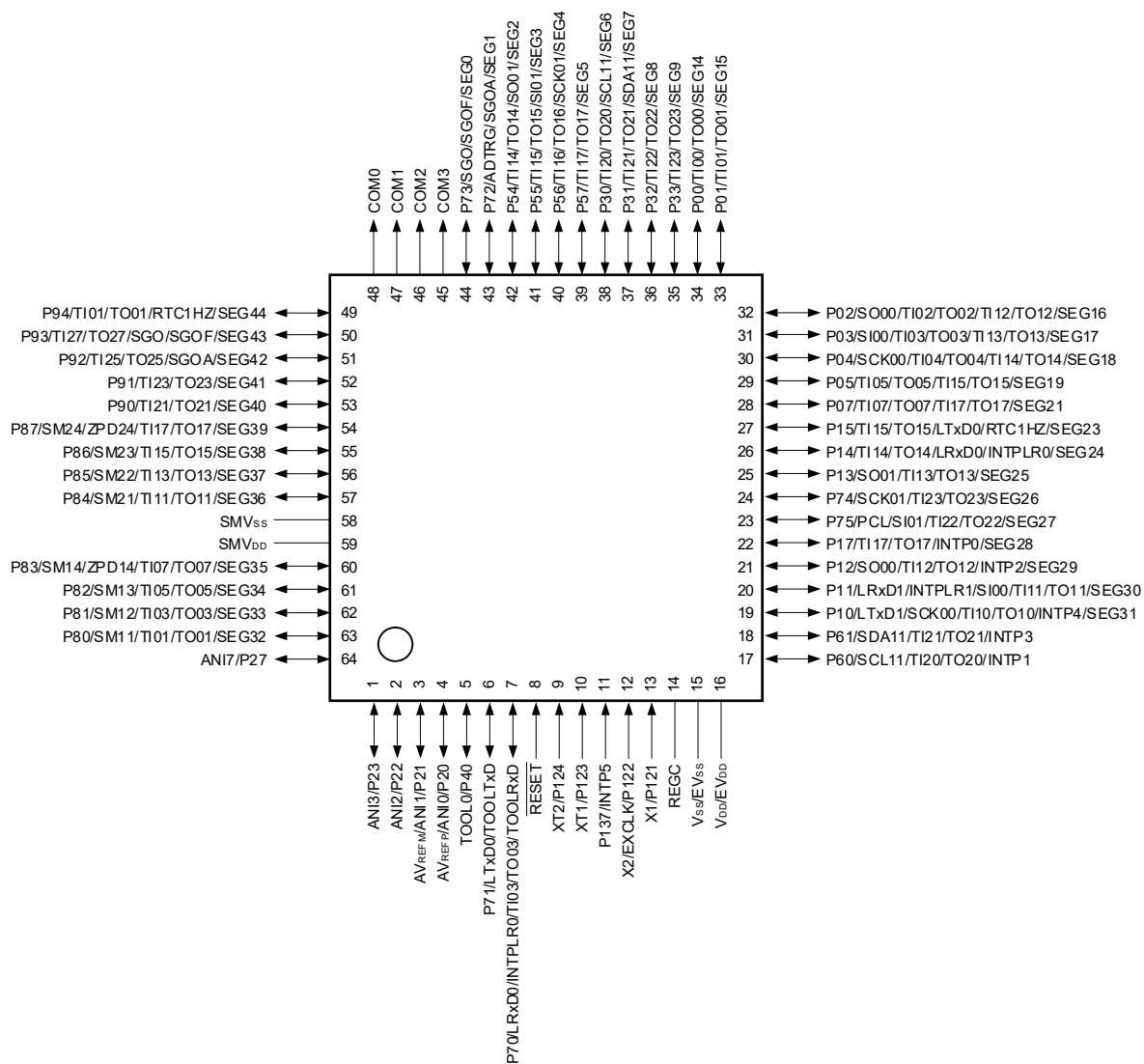


Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.3 64-pin products (R5F10CLDxFB: with no CAN)

64-pin plastic LQFP (fine pitch) (10 × 10)

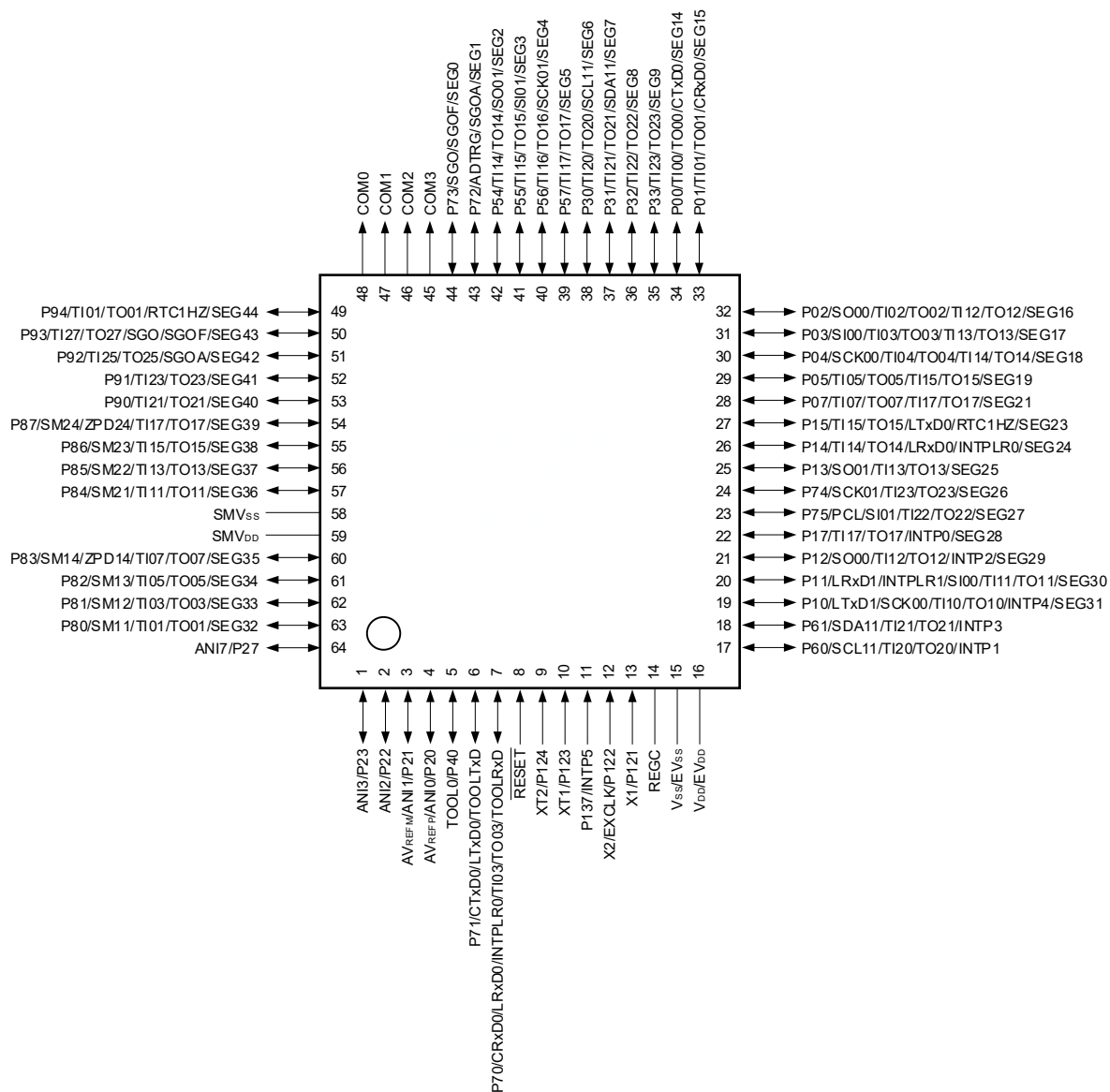


Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.4 64-pin products (R5F10DLxFB, R5F10DLExFB: with CAN)

64-pin plastic LQFP (fine pitch) (10 × 10)

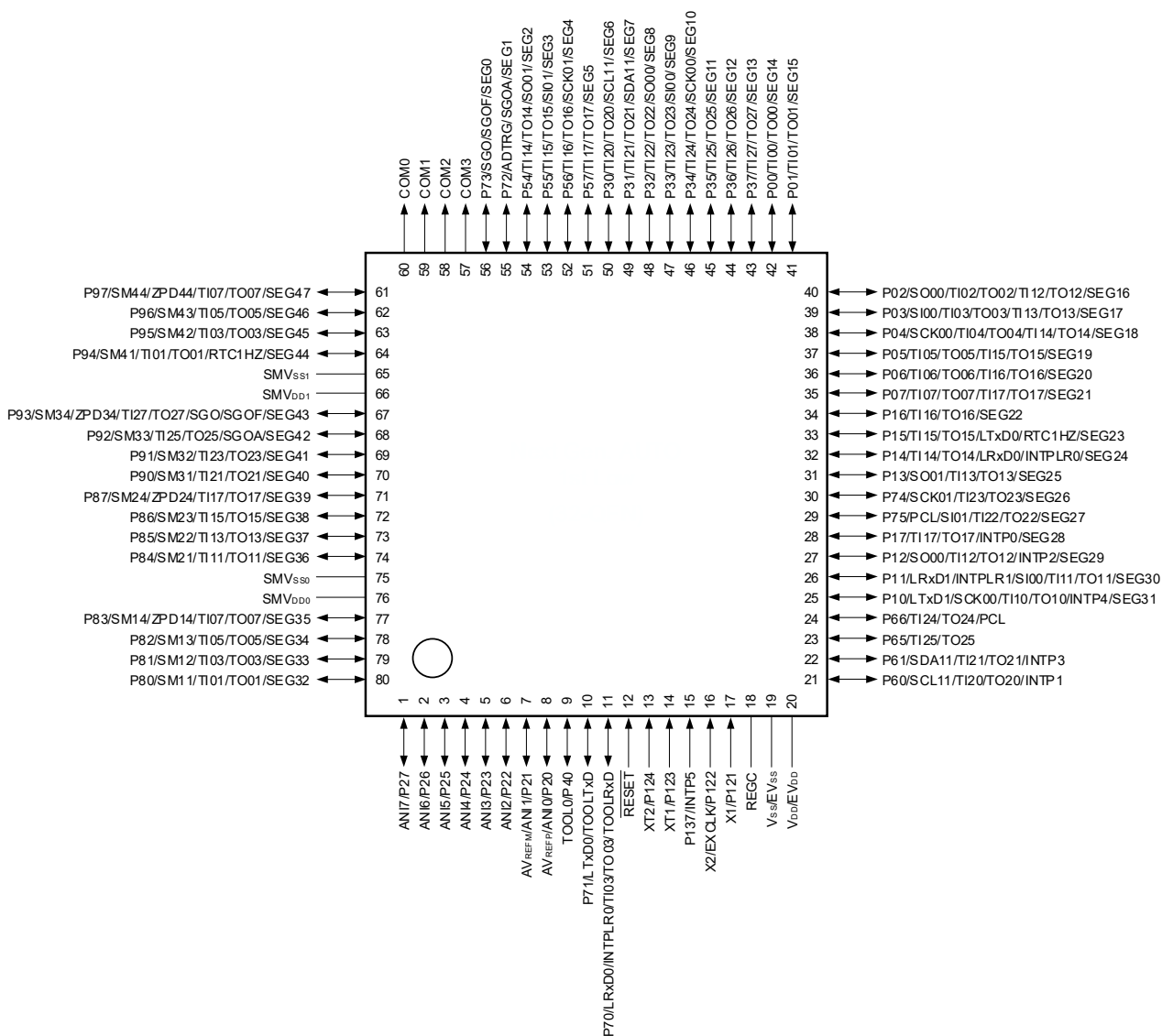


Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.5 80-pin products (R5F10CMDxFB, R5F10CMEExFB: with no CAN)

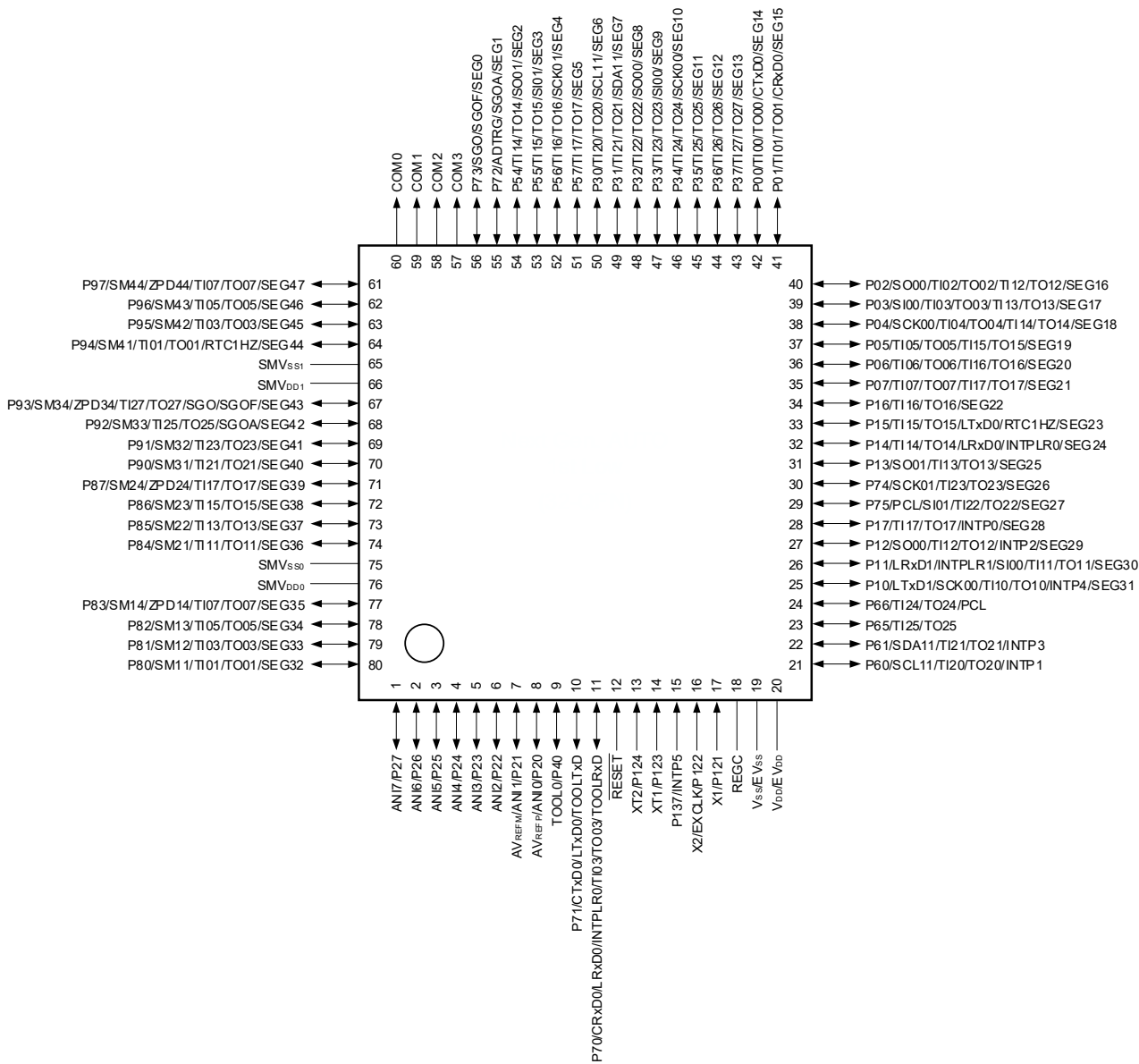
80-pin plastic LQFP (fine pitch) (12 × 12)



Caution Connect the REGC pin to V_{SS} via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.6 80-pin products (R5F10DMDxFB, R5F10DMExFB, R5F10DMFxFB, R5F10DMGxFB, R5F10DMJxFB: with CAN)
 80-pin plastic LQFP (fine pitch) (12 × 12)

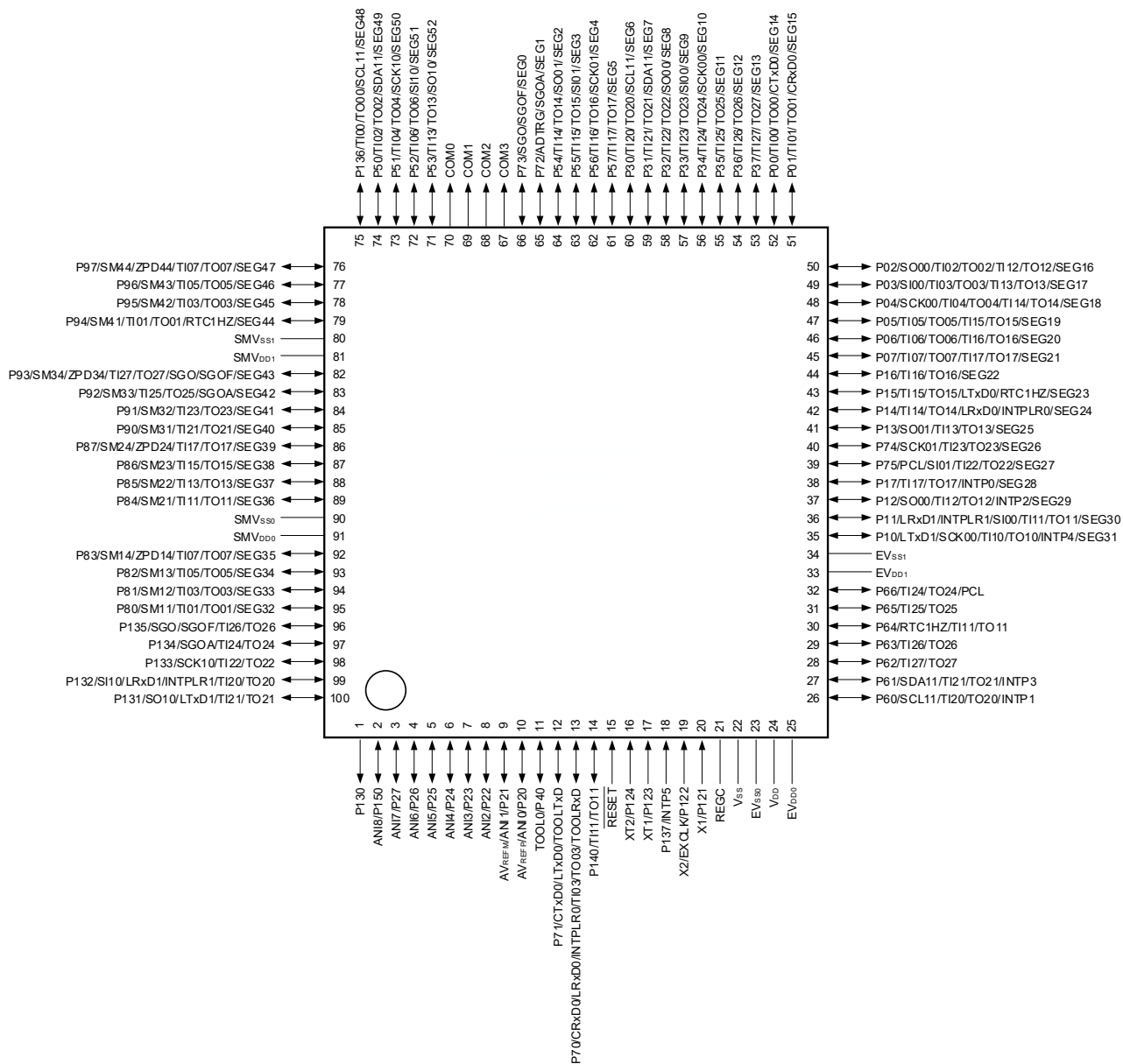


Caution Connect the REGC pin to V_{SS} via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.7 100-pin products (R5F10DPExFB, R5F10DPFxFB, R5F10DPGXFB, R5F10TPJxFB: with 1 ch of CAN)

100-pin plastic LQFP (fine pitch) (14 × 14)

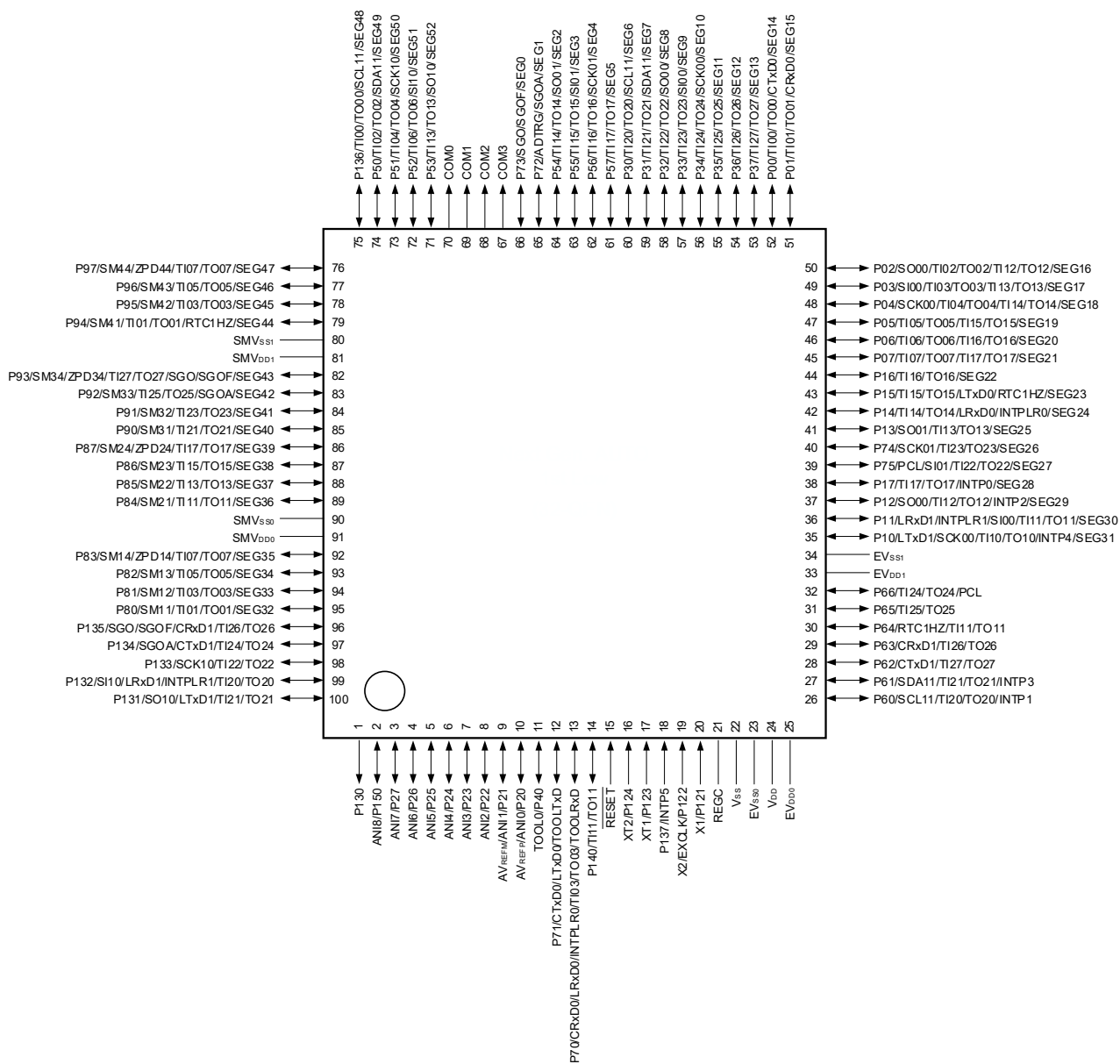


Caution Connect the REGC pin to V_{SS} via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.8 100-pin products (R5F10DPJxFB, R5F10DPKxFB, R5F10DPLxFB: with 2 ch of CAN)

100-pin plastic LQFP (fine pitch) (14 × 14)

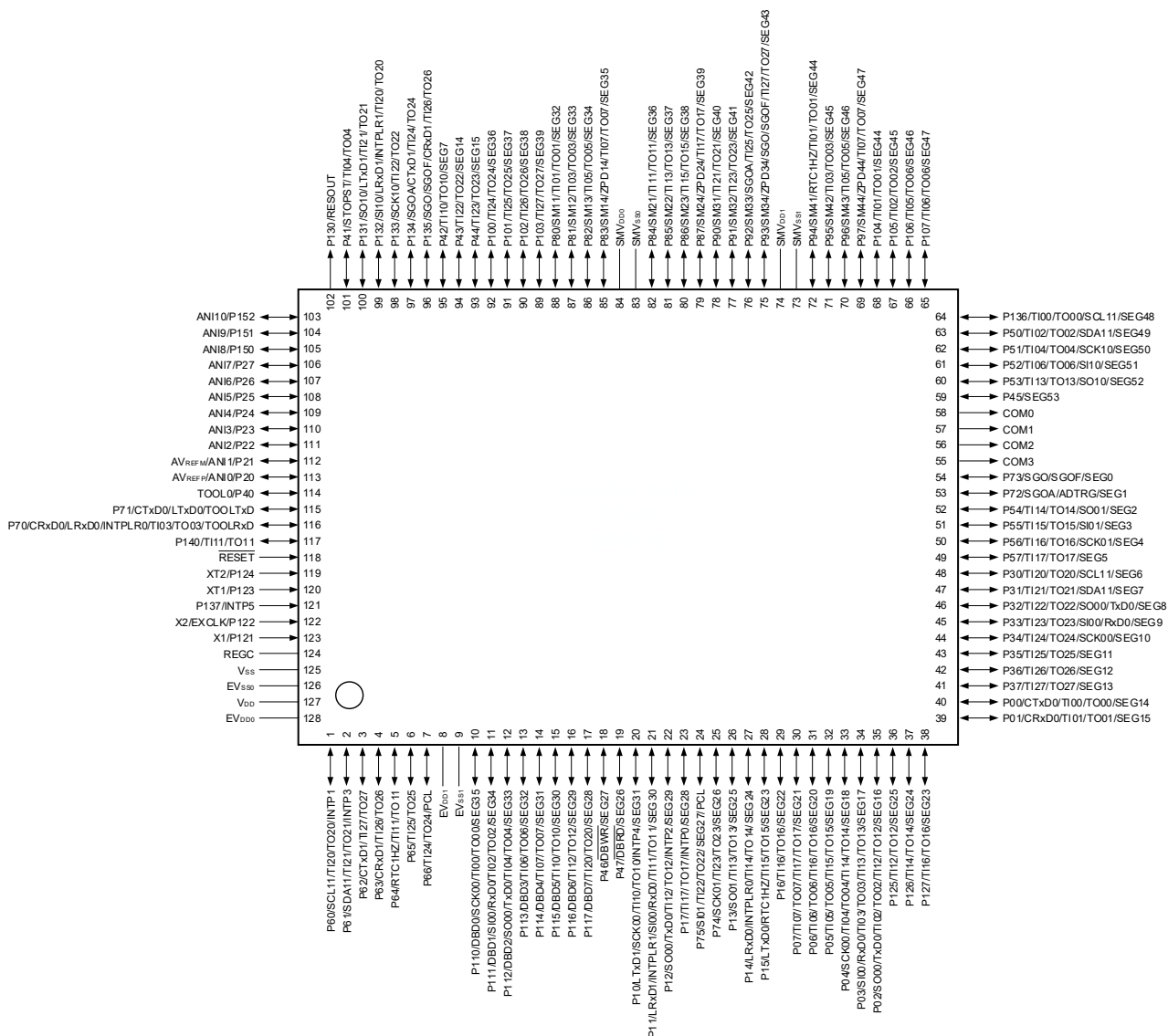


Caution Connect the REGC pin to V_{SS} via a capacitor (0.47 to 1 μF)

Remark For pin identification, see 1.5 Pin Identification.

1.4.9 128-pin products (R5F10DSLxxFB, R5F10DSKxxFB, R5F10DSJxxFB)

128-pin plastic LFQFP (fine pitch) (14 × 20)



Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μF)

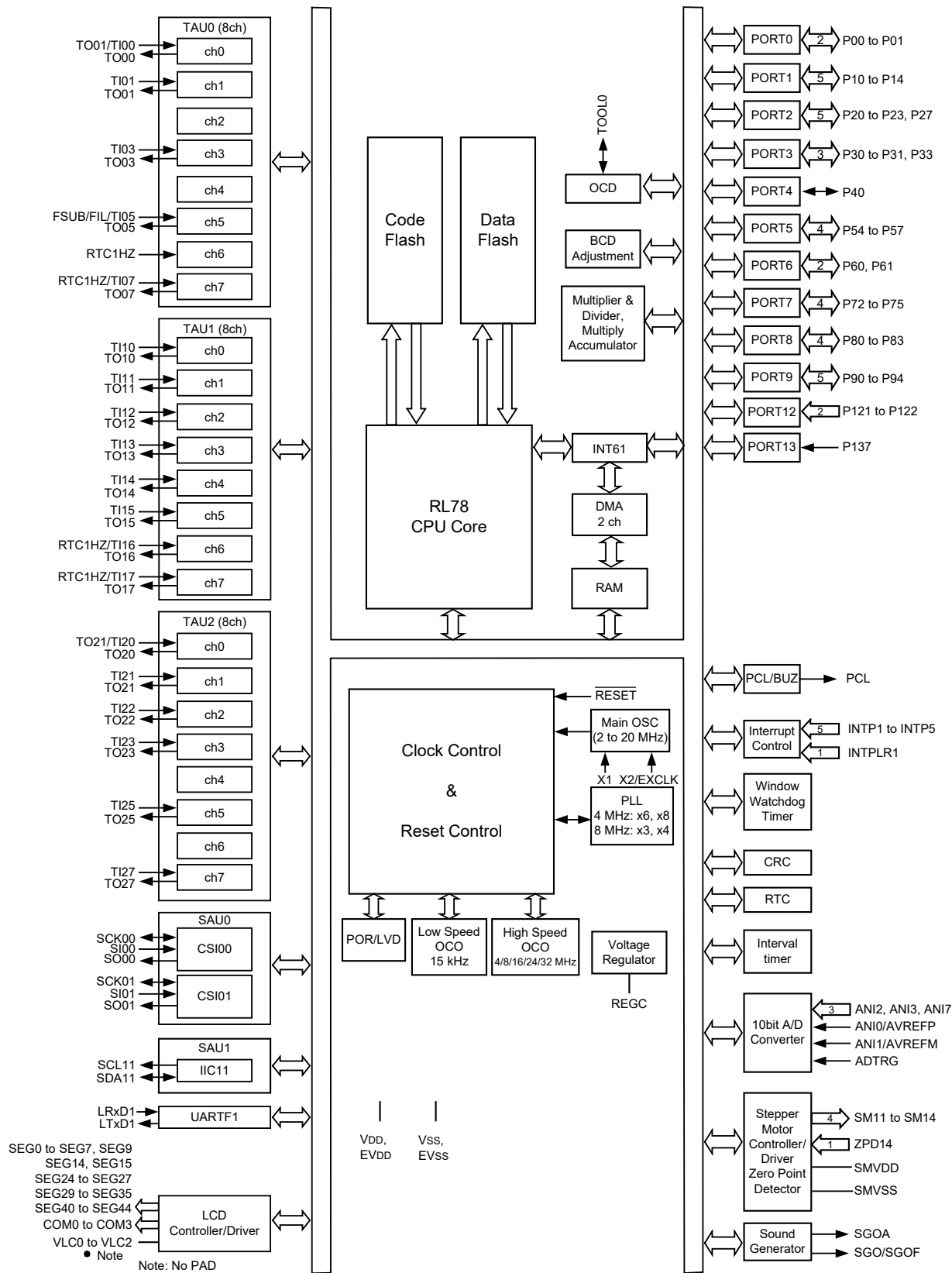
Remark For pin identification, see 1.5 Pin Identification.

1.5 Pin Identification

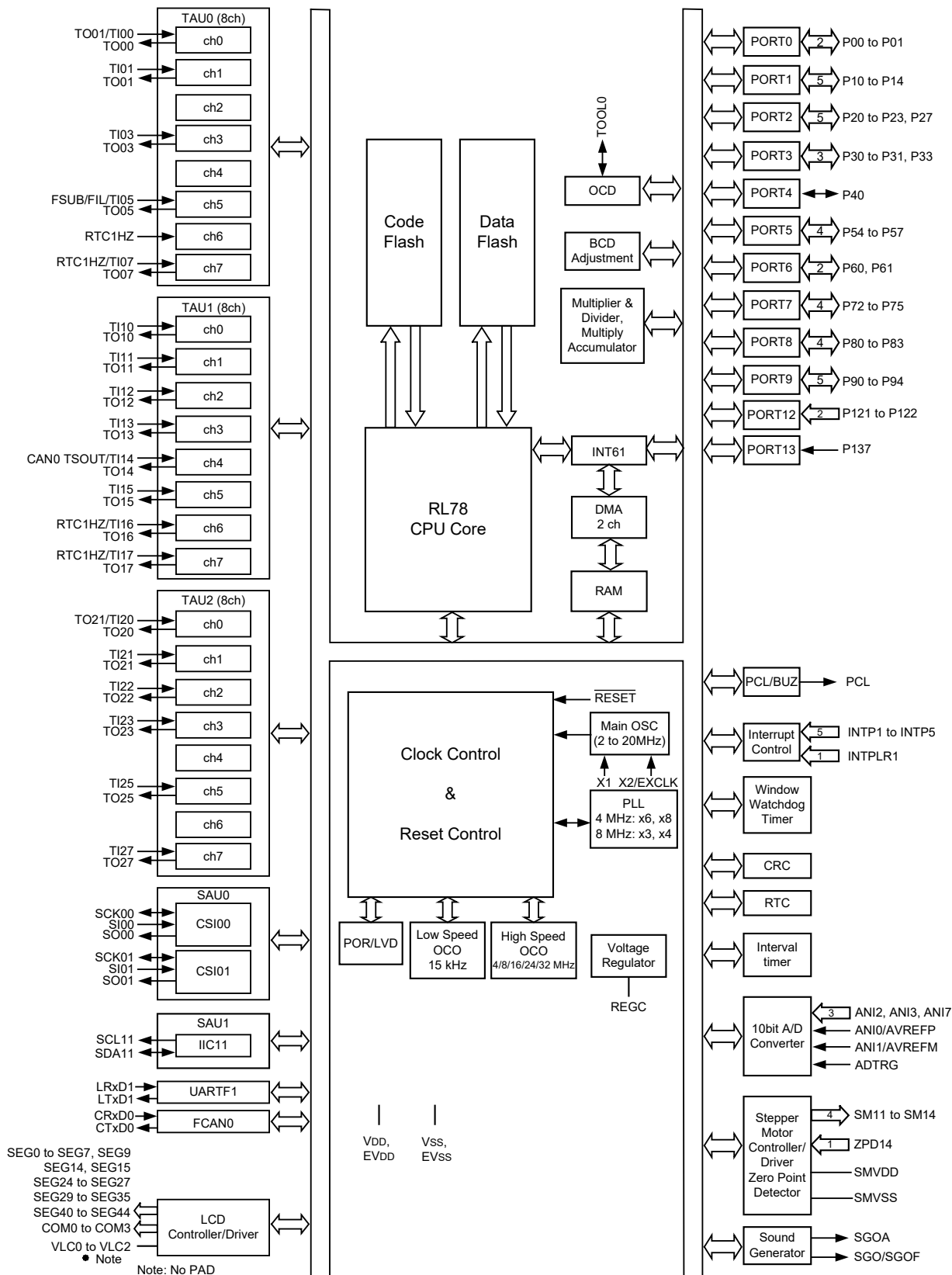
ANI0 to ANI10:	Analog input	RxD0:	Receive data for UART
ADTRG:	A/D conversion start trigger external input	SCK00, SCK01, SCK10:	Serial clock input/output
AV _{REFM} :	A/D converter reference potential (– side) input	SCL11:	Serial clock input/output
AV _{REFP} :	A/D converter reference potential (+ side) input	SDA11:	Serial data input/output
COM0 to COM3:	Common output	SEG0 to SEG53:	Segment output
CRxD0, CRxD1:	Receive data for CAN	SGO:	Sound generator output
CTxD0, CTxD1:	Transmit data for CAN	SGOA:	Sound generator amplitude PWM output
DBD0 to DBD7:	LCD Bus I/F data lines	SGOF:	Sound generator frequency output
$\overline{\text{DBWR}}$:	LCD Bus I/F write strobe	SI00, SI01, SI10:	Serial data input
$\overline{\text{DBRD}}$:	LCD Bus I/F read strobe	SM11 to SM14, SM21 to SM24, SM31 to SM34, SM41 to SM44:	Stepper motor outputs
EV _{DD} , EV _{DD0} , EV _{DD1} :	Power supply for port	SMV _{DD} , SMV _{DD0} , SMV _{DD1} :	Stepper motor controller/driver supply voltage
EV _{SS} , EV _{SS0} , EV _{SS1} :	Ground for port	SMV _{SS} , SMV _{SS0} , SMV _{SS1} :	Stepper motor controller/driver ground
EXCLK:	External clock input (main system clock)	SO00, SO01, SO10:	Serial data output
INTP0 to INTP5:	External interrupt input	STOPST:	STOP status output
INTPLR0, INTPLR1:	External interrupt input for LIN	TI00 to TI07, TI10 to TI17, TI20 to TI27:	Timer input
LRxD0, LRxD1:	Serial data input to LIN	TO00 to TO07, TO10 to TO17, TO20 to TO27:	Timer output
LTxD0, LTxD1:	Serial data output from LIN	TOOL0:	Data input/output for tool
P00 to P07:	Port 0	TOOLRxD, TOOLTxD:	Data input/output for external device
P10 to P17:	Port 1	TxD0:	Transmit data for UART
P20 to P27:	Port 2	V _{DD} :	Power supply
P30 to P37:	Port 3	V _{SS} :	Ground
P40:	Port 4	X1, X2:	Crystal oscillator (Main system clock)
P50 to P57:	Port 5	XT1, XT2:	Crystal oscillator (Sub system clock)
P60 to P66:	Port 6	ZPD14, ZPD24, ZPD34, ZPD44:	Zero point detection input
P70 to P75:	Port 7		
P80 to P87:	Port 8		
P90 to P97:	Port 9		
P121 to P124:	Port 12		
P130 to P137:	Port 13		
P140:	Port 14		
P150 to P152:	Port 15		
PCL:	Programmable clock output		
REGC:	Regulator capacitance		
$\overline{\text{RESET}}$:	Reset		
RESOUT:	Reset output signal		
RTC1HZ:	Real-time clock correction clock (1 Hz) output		

1.6 Block Diagram

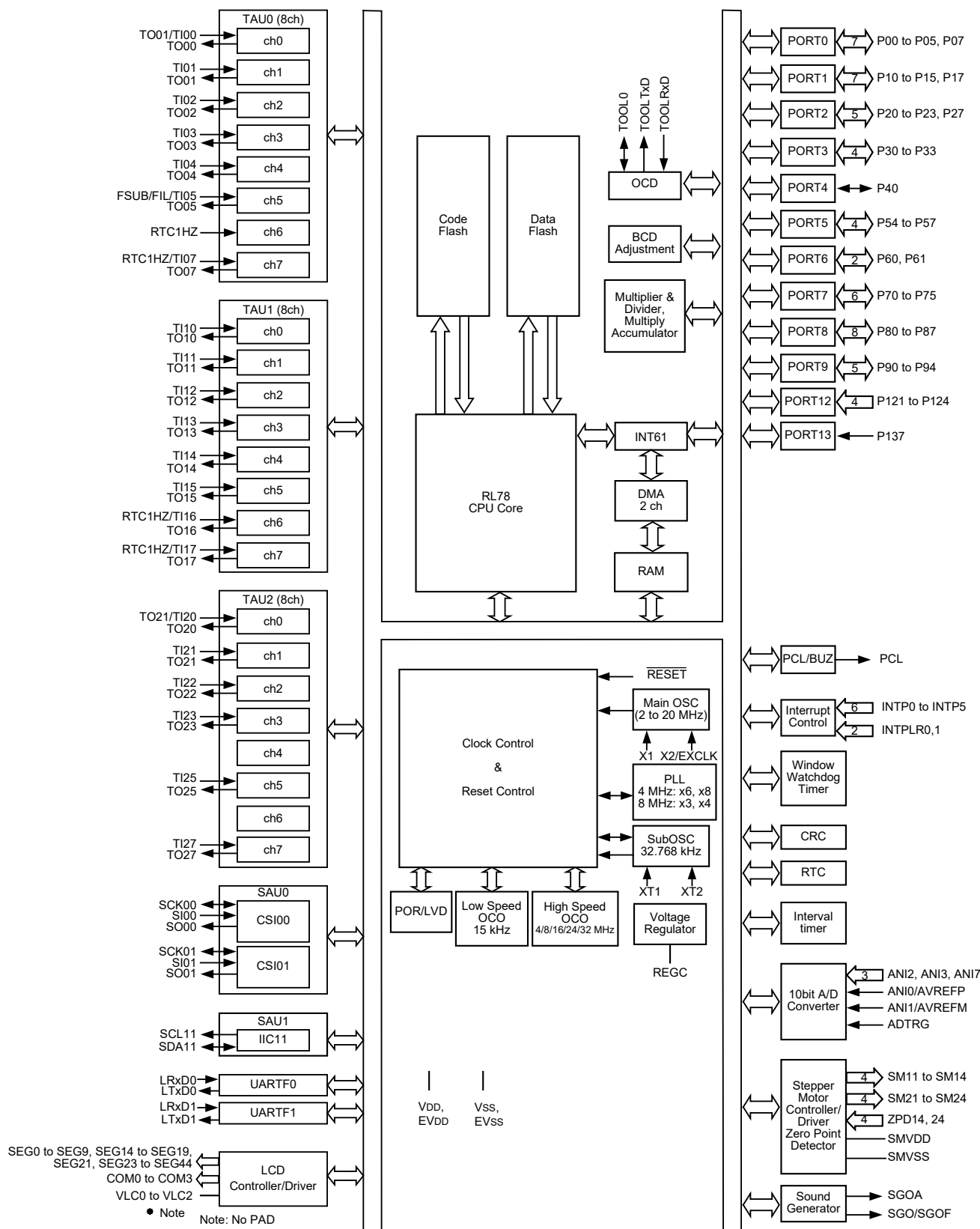
1.6.1 48-pin products (R5F10CGBxFB, R5F10CGCxFB, R5F10CGDxFB: with no CAN)



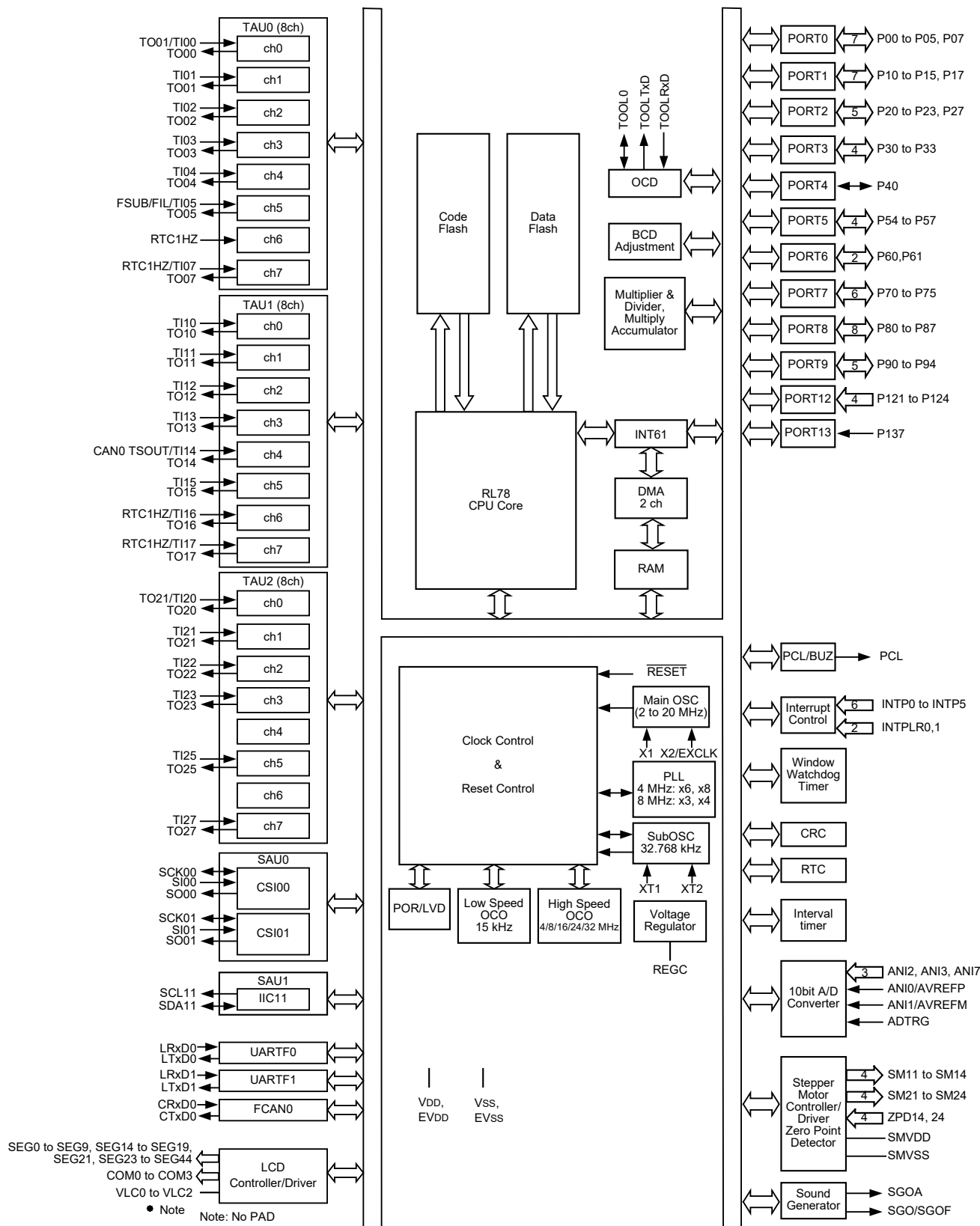
1.6.2 48-pin products (R5F10DGCxFB, R5F10DGDxFB, R5F10DGExFB: with CAN)



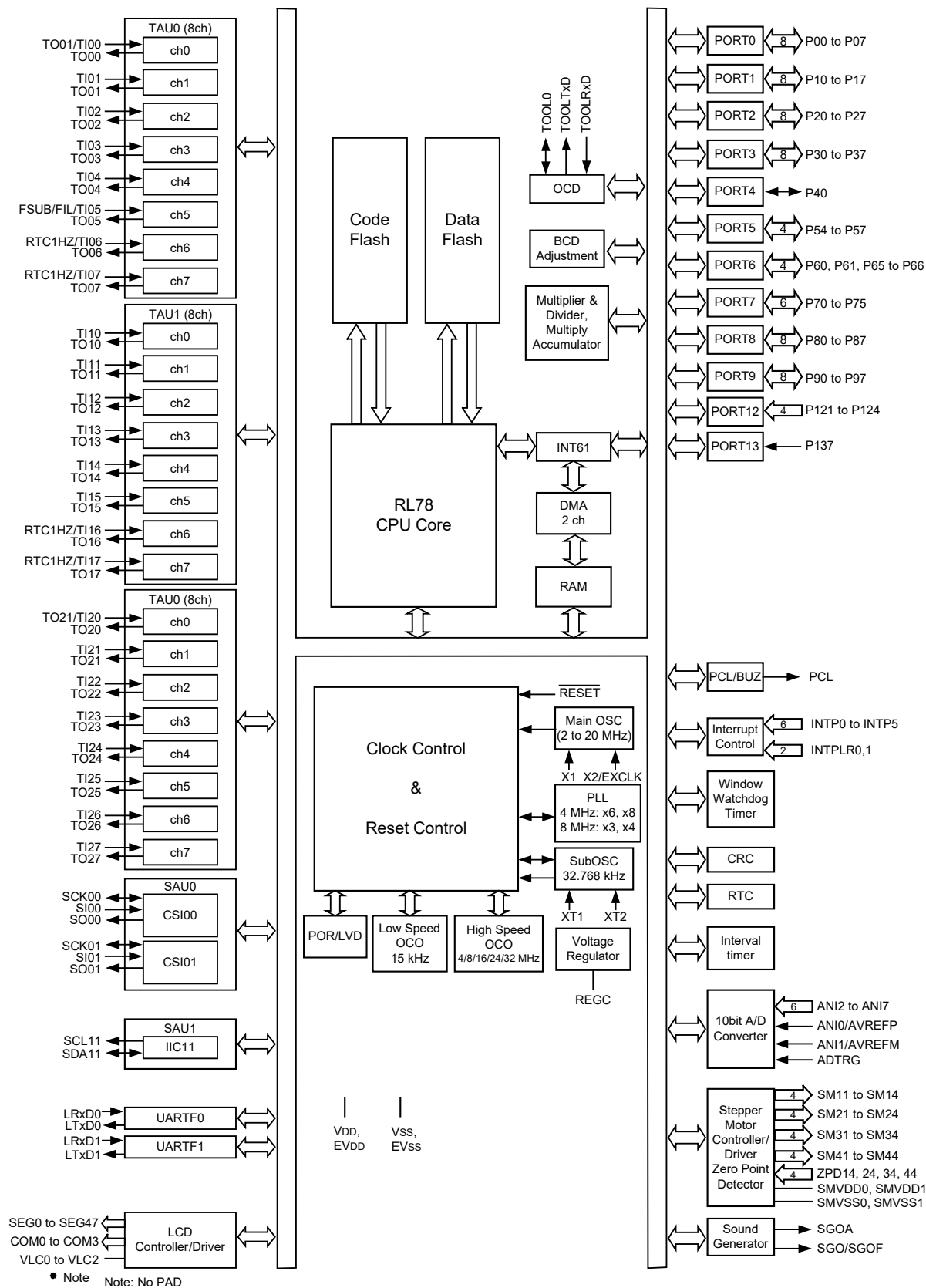
1.6.3 64-pin products (R5F10CLDxFB: with no CAN)



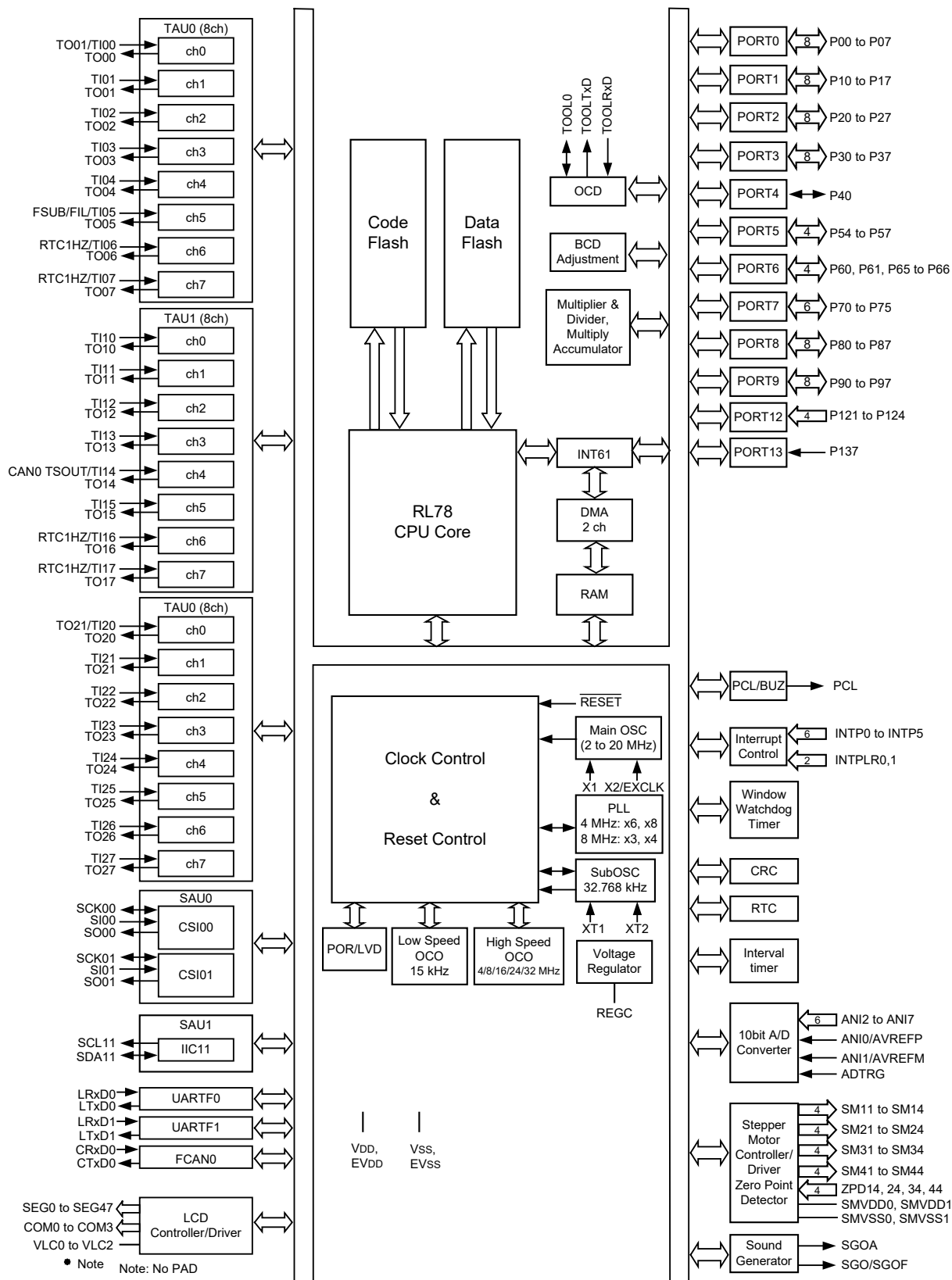
1.6.4 64-pin products (R5F10DLxFB, R5F10DLExFB: with CAN)



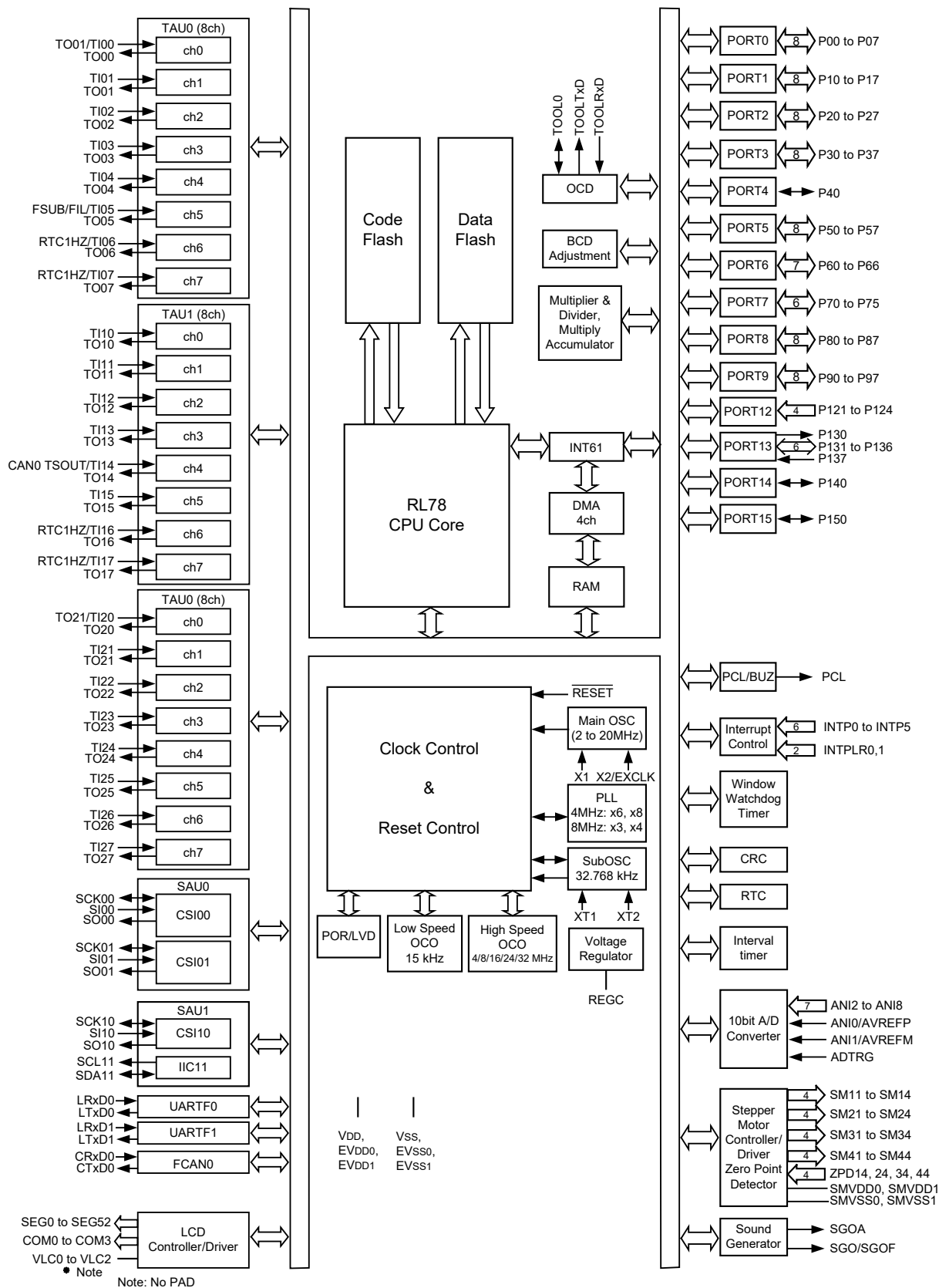
1.6.5 80-pin products (R5F10CMDxFB, R5F10CMExFB: with no CAN)



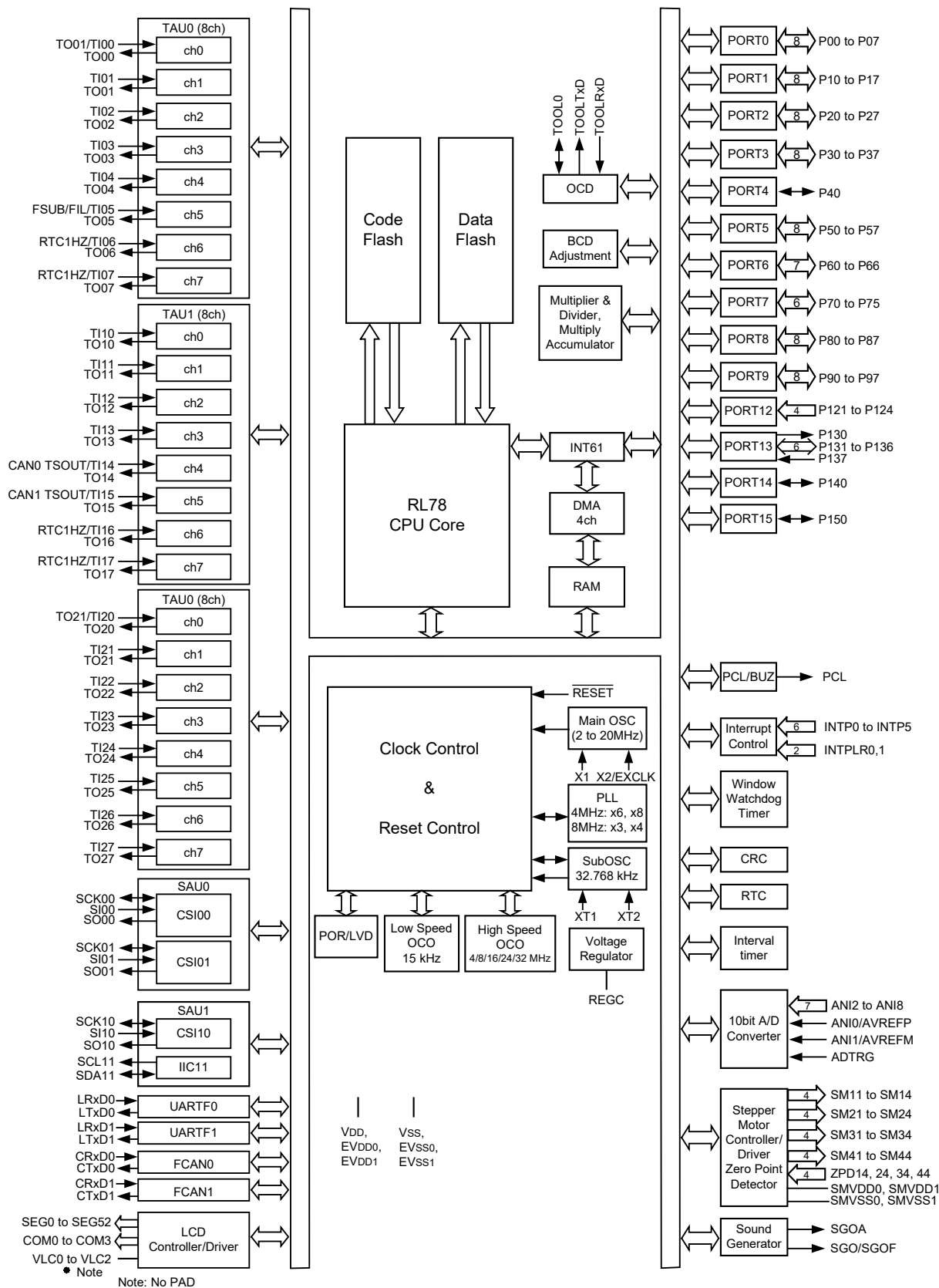
1.6.6 80-pin products (R5F10DMDxFB, R5F10DMEExFB, R5F10DMFxB, R5F10DMGxB, R5F10DMJxB: with CAN)



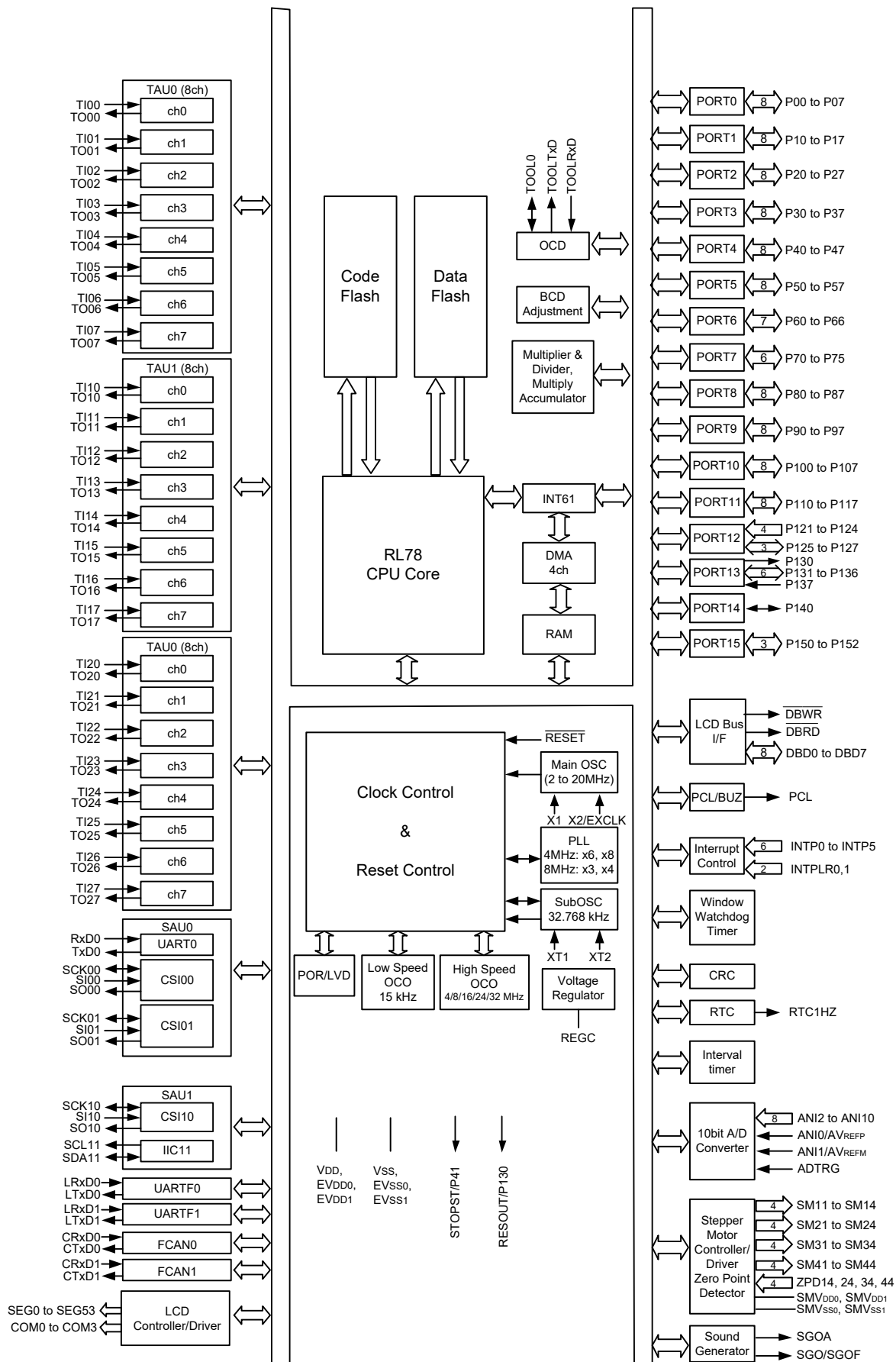
1.6.7 100-pin products (R5F10DPExFB, R5F10DPFxFB, R5F10DPGxFB, R5F10TPJxFB: with 1 ch of CAN)



1.6.8 100-pin products (R5F10DPJxFB, R5F10DPKxFB, R5F10DPLxFB: with 2 ch of CAN)



1.6.9 128-pin products (R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB)



1.7 Outline of Functions

(1/4)

Item			48-pin						64-pin			80-pin					
			R5F10CGBxFB	R5F10CGCxFB	R5F10CGDxFB	R5F10DGCxFB	R5F10DGDxFB	R5F10DGExFB	R5F10CLDxFB	R5F10DLExFB	R5F10DLExFB	R5F10CMDxFB	R5F10CMExFB	R5F10MDxFB	R5F10DMExFB	R5F10DMFxFB	R5F10DMGxFB
ROM/ RAM capacities	ROM	RAM															
	512 KB	24 KB															
	384 KB	20 KB															
	256 KB	16 KB															√
	128 KB	8 KB														√	
	96 KB	6 KB													√		
	64 KB	4 KB						√			√		√		√		
	48 KB	3 KB			√		√		√	√		√		√			
	32 KB	2 KB		√		√											
24 KB	2 KB	√															
Data flash memory			8 KB														
Memory space			1 MB														
General-purpose register			8 bits × 32 registers (8 bits × 8 registers × 4 banks)														
Main System clock	High-speed system clock		1 to 20 MHz (VDD = 2.7 V to 5.5 V)														
	High-speed on-chip oscillation clock		4/8/16/24/32 MHz (TA = -40 to 85°C) 4/8/16/24 MHz (TA = -40 to 105°C)														
PLL			4 MHz × 16/2 = 32 MHz, 8 MHz × 16/4 = 32 MHz (TA = -40 to 85°C) 4 MHz × 12/2 = 24 MHz, 8 MHz × 12/4 = 24 MHz (TA = -40 to 105°C)														
Subsystem clock			32.768kHz														
Low-speed on-chip oscillation clock			15 kHz														
Minimum instruction execution time			0.03125 μs (Main system clock 32 MHz TA = -40 to +85°C) 0.04167 μs (Main system clock 24 MHz TA = -40 to 105°C) 30.5 μs (Subsystem clock 32.768 kHz operation)														
Instruction set			<ul style="list-style-type: none"> • 8-bit operation, 16-bit operation • Multiplication (8 bits × 8 bits) • Bit manipulation (Set, reset, test, and Boolean operation), etc. 														
I/O port	Total number of port		38						54			68					
	CMOS I/O port		35						49			63					
	N-ch open-drain Selectable port		4														
	LED direct drive port		9						13			16					
	CMOS input port		3									5					
	CMOS output port		0														
Timer	16-bit timer		8 ch × 3 units														
	Real-time clock (RTC)		1 ch														
	Interval timer		1 ch														
	Watchdog timer (WDT)		1 ch														
	Timer output		19						21			24					
	RTC output		1														
Clock output/buzzer output			1														
10-bit resolution A/D converter			3+2									6+2					

(2/4)

Item		48-pin					64-pin			80-pin						
		R5F10CGBxFB	R5F10CGCxFB	R5F10CGDxFB	R5F10DGCxFB	R5F10DGDxFB	R5F10DGExFB	R5F10CLDxFB	R5F10DLDxFB	R5F10DLExFB	R5F10CMDxFB	R5F10CMExFB	R5F10DM DxFB	R5F10DMExFB	R5F10DMFxFB	R5F10DMGxFB
Serial interface	CSI	2 ch														
	UART	-														
	Simplified IIC	1 ch														
	LIN-UART	1 ch					2 ch									
	aFCAN	0 ch		1 ch			0 ch		1 ch		0 ch		1 ch			
Multiplier and divider/multiply accumulator		<ul style="list-style-type: none"> • 16-bits × 16 bits = 32 bits (Unsigned or signed) • 32-bits ÷ 32 bits = 32 bits (Unsigned) • 16-bits × 16 bits + 32 bits = 32 bits (Unsigned or signed) 														
DMA controller		2 ch														
Vectored interrupt sources	Internal	39		43			42		46		42		46			
	External	6					8									
	Software	1														
	Debugger	1														
LCD controller driver	Bias	Static, 1/3 bias, 1/3 or 1/4 duty														
	SEG × COM	27 × 4					39 × 4			48 × 4						
Sound generator		1 channel														
Stepper motor controller/driver (with ZPD)		1 ch					2 ch			4 ch						
Safety function	FLASH memory CRC calculation	Provided														
	RAM parity bit error detection	Provided														
	Illegal-memory access detection	Provided														
	Frequency detection	Provided														
	Clock monitor	Provided														
Reset		<ul style="list-style-type: none"> • Reset by RESET pin • Internal reset by watchdog timer • Internal reset by power-on-reset • Internal reset by voltage detector • Internal reset by illegal instruction execution • Internal reset by RAM parity error • Internal reset by illegal-memory access • Internal reset by clock monitor 														
Power on reset (POR)		Power on reset: 1.51 V ± 0.06 V Power down reset: 1.50 V ± 0.06 V														
Voltage detector		Rising edge detection voltage = 2.81 to 4.06 V (6 step) Falling edge detection voltage = 2.75 to 3.98 V (6 step)														
On-chip debug function		Provided														
Power supply voltage		V _{DD} = 2.7 to 5.5 V														
Operating ambient temperature		J grade products: T _A = -40 to +85 °C, L grade products: T _A = -40 to +105 °C														

(3/4)

Item			100-pin							128-pin		
			R5F10DPEXFB	R5F10DPFXFB	R5F10DPGXFB	R5F10TPJXFB	R5F10DPJXFB	R5F10DPKXFB	R5F10DPLXFB	R5F10DSJXFB	R5F10DSKXFB	R5F10DSLXFB
	ROM	RAM										
ROM/ RAM capacities	512 KB	24 KB							√			√
	384 KB	20 KB						√		√		
	256 KB	16 KB				√	√			√		
	128 KB	8 KB			√							
	96 KB	6 KB		√								
	64 KB	4 KB	√									
	48 KB	3 KB										
	32 KB	2 KB										
	24 KB	2 KB										
Data flash memory			8 KB									
Memory space			1 MB									
General-purpose register			8 bits × 32 registers (8 bits × 8 registers × 4 banks)									
Main System clock	High-speed system clock		1 to 20 MHz (VDD = 2.7 V to 5.5 V)									
	High-speed on-chip oscillation clock		4/8/16/24/32 MHz (T _A = -40 to 85°C) 4/8/16/24 MHz (T _A = -40 to 105°C)									
PLL			4 MHz × 16/2 = 32 MHz, 8 MHz × 16/4 = 32 MHz (T _A = -40 to 85°C) 4 MHz × 12/2 = 24 MHz, 8 MHz × 12/4 = 24 MHz (T _A = -40 to 105°C)									
Subsystem clock			32.768kHz									
Low-speed on-chip oscillation clock			15 kHz									
Minimum instruction execution time			0.03125 μs (Main system clock 32 MHz T _A = -40 to +85°C) 0.04167 μs (Main system clock 24 MHz T _A = -40 to 105°C) 30.5 μs (Subsystem clock 32.768 kHz operation)									
Instruction set			<ul style="list-style-type: none"> • 8-bit operation, 16-bit operation • Multiplication (8 bits × 8 bits) • Bit manipulation (Set, reset, test, and Boolean operation), etc. 									
I/O port	Total number of port		84							112		
	CMOS I/O port		78							107		
	N-ch open-drain Selectable port		6									
	LED direct drive port		16									
	CMOS input port		5									
	CMOS output port		1									
Timer	16-bit timer		8 ch × 3 units									
	Real-time clock (RTC)		1 ch									
	Interval timer		1 ch									
	Watchdog timer (WDT)		1 ch									
	Timer output		24									
	RTC output		1									
Clock output/buzzer output			1									
10-bit resolution A/D converter			7+2							9+2		
Reset output			Can be output from P130									
STOP status output			Can be output from P41									

(4/4)

Item		100-pin						128-pin		
		R5F10DPEXFB	R5F10DPFXFB	R5F10DPGXFB	R5F10TPJXFB	R5F10DPJXFB	R5F10DPKXFB	R5F10DPLXFB	R5F10DSJXFB	R5F10DSKXFB
Serial interface	CSI	3 ch								
	UART	—						1 ch		
	Simplified IIC	1 ch								
	LIN-UART	2 ch								
	aFCAN	1 ch				2 ch				
Multiplier and divider/multiply accumulator		<ul style="list-style-type: none"> • 16-bits × 16 bits = 32 bits (Unsigned or signed) • 32-bits ÷ 32 bits = 32 bits (Unsigned) • 16-bits × 16 bits + 32 bits = 32 bits (Unsigned or signed) 								
DMA controller		4 ch								
Vectored interrupt sources	Internal	53								
	External	8								
	Software	1								
	Debugger	1								
LCD controller driver	Bias	Static, 1/3 bias, 1/3 or 1/4 duty								
	SEG × COM	53 × 4						54 × 4		
LCD Bus I/F		—						Provided (8 bit, RD, WR)		
Sound generator		1 channel								
Stepper motor controller/driver (with ZPD)		4 ch								
Safety function	FLASH memory CRC calculation	Provided								
	RAM parity bit error detection	Provided								
	Illegal-memory access detection	Provided								
	Frequency detection	Provided								
	Clock monitor	Provided								
Reset		<ul style="list-style-type: none"> • Reset by RESET pin • Internal reset by watchdog timer • Internal reset by power-on-reset • Internal reset by voltage detector • Internal reset by illegal instruction execution • Internal reset by RAM parity error • Internal reset by illegal-memory access • Internal reset by clock monitor 								
Power on reset (POR)		Power on reset: 1.51 V ± 0.06 V Power down reset: 1.50 V ± 0.06 V								
Voltage detector		Rising edge detection voltage = 2.81 to 4.06 V (6 step) Falling edge detection voltage = 2.75 to 3.98 V (6 step)								
On-chip debug function		Provided								
Power supply voltage		V _{DD} = 2.7 to 5.5 V								
Operating ambient temperature		J grade products: T _A = -40 to +85 °C, L grade products: T _A = -40 to +105 °C								

2. PIN FUNCTIONS

2.1 Pin Function List

Pin I/O buffer power supplies depend on the product. The relationship between these power supplies and the pins is shown below.

Table 2-1. Pin I/O Buffer Power Supplies

(1) 48-pin products

Power Supply	Corresponding Pins
V_{DD}/EV_{DD}	Port pins other than P80 to P83 and P90 to P94
SMV_{DD}	P80 to P83, P90 to P94

(2) 64-pin products

Power Supply	Corresponding Pins
V_{DD}/EV_{DD}	Port pins other than P80 to P87 and P90 to P94
SMV_{DD}	P80 to P87, P90 to P94

(3) 80-pin products

Power Supply	Corresponding Pins
V_{DD}/EV_{DD}	Port pins other than P80 to P87 and P90 to P97
SMV_{DD0}, SMV_{DD1}	P80 to P87, P90 to P97

(4) 100-pin products

Power Supply	Corresponding Pins
V_{DD}	P20 to P27, P150, P137, P121 to P124, \overline{RESET}
EV_{DD0}, EV_{DD1}	P00 to P07, P10 to P17, P30 to P37, P40, P50 to P57, P60 to P66, P70 to P75, P130 to P136, P140
SMV_{DD0}, SMV_{DD1}	P80 to P87, P90 to P97

(5) 128-pin products

Power Supply	Corresponding Pins
V_{DD}	P20 to P27, P150 to P152, P137, P121 to P124, \overline{RESET}
EV_{DD0}, EV_{DD1}	P00 to P07, P10 to P17, P30 to P37, P40 to P47, P50 to P57, P60 to P66, P70 to P75, P100 to P107, P110 to P117, P125 to P127, P130 to P136, and P140
SMV_{DD0}, SMV_{DD1}	P80 to P87, P90 to P97

The setting of I/O, buffer and pull-up resistor in each port is also valid for alternate functions.

2.1.1 48-pin products

Table 2-2. Port Pins for R5F10CGBxFB, R5F10CGCxFB, R5F10CGDxFB, R5F10DGCxFB, R5F10DGDxFB, R5F10DGEExFB (1/2)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P00	I/O	Port 0. 2-bit I/O port.	Ext.: PD	Input	TI00/TO00/CTxD0/SEG14 ^{Note1}
P01		Input of P01 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Int.: HZ		TI01/TO01/CRxD0/SEG15 ^{Note1}
P10	I/O	Port 1. 5-bit I/O port.	Ext.: PD	Input	LTxD1/SCK00/TI10/TO10/INTP4/SEG31
P11		Input of P10 and P11 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Int.: HZ		LRxD1/INTPLR1/SI00/TI11/TO11/SEG30
P12					SO00/TI12/TO12/INTP2/SEG29
P13					SO01/TI13/TO13/SEG25
P14					TI14/TO14/SEG24
P20	I/O	Port 2. 5-bit I/O port.	HZ	Analog Input	AVREFP/ANI0
P21		Can be set to analog input ^{Note2}			AVREFM/ANI1
P22		Input/output can be specified in 1-bit units.			ANI2
P23					ANI3
P27					ANI7
P30	I/O	Port 3. 3-bit I/O port.	Ext.: PD	Input	TI20/TO20/SCL11/SEG6
P31		Input of P31 can be set to schmitt 1 input buffer.	Int.: HZ		TI21/TO21/SDA11/SEG7
P33		Output of P30 and P31 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.			TI23/TO23/SEG9
P40	I/O	Port 4. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: HZ Int.: PU	Input	TOOL0
P54	I/O	Port 5. 4-bit I/O port.	Ext.: PD	Input	TI14/TO14/SO01/SEG2
P55		Input of P55 to P57 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Int.: HZ		TI15/TO15/SI01/SEG3
P56					TI16/TO16/SCK01/SEG4
P57					TI17/TO17/SEG5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, PU: Pull up, HZ: High impedance

- Notes 1.** CTxD0 and CRxD0 are not provided for R5F10CGDxFB, R5F10CGCxFB and R5F10CGBxFB with no CAN channel.
- 2.** Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

**Table 2-2. Port Pins for
R5F10CGBxFB, R5F10CGCxFB, R5F10CGDxFB, R5F10DGCxFB, R5F10DGDxFB, R5F10DGEExFB (2/2)**

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P60	I/O	Port 6. 2-bit I/O port. Input of P61 can be set to schmitt 1 input buffer. Output of P60 and P61 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	SCL11/TI20/TO20/INTP1
P61					SDA11/TI21/TO21/INTP3
P72	I/O	Port 7. 4-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	ADTRG/SGOA/SEG1
P73					SGO/SGOF/SEG0
P74					SCK01/TI23/TO23/SEG26
P75					PCL/SI01/TI22/TO22/SEG27
P80	I/O	Port 8. 4-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	SM11/TI01/TO01/SEG32
P81					SM12/TI03/TO03/SEG33
P82					SM13/TI05/TO05/SEG34
P83					SM14/ZPD14/TI07/TO07/SEG35
P90	I/O	Port 9. 5-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI21/TO21/SEG40
P91					TI23/TO23/SEG41
P92					TI25/TO25/SGOA/SEG42
P93					TI27/TO27/SGO/SGOF/SEG43
P94					TI01/TO01/RTC1HZ/SEG44
P121	I	Port 12. 2-bit Input port.	HZ	Input	X1
P122					X2/EXCLK
P137	I	Port 13. 1-bit Input port.	HZ	Input	INTP5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, HZ: High impedance

2.1.2 64-pin products

Table 2-3. Port Pins for R5F10CLDxFB, R5F10DLDFB, R5F10DLExFB (1/2)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P00	I/O	Port 0. 7-bit I/O port. Input of P01 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI00/TO00/CTxD0/SEG14 ^{Note1}
P01					TI01/TO01/CRxD0/SEG15 ^{Note1}
P02					SO00/TI02/TO02/TI12/TO12/SEG16
P03					SI00/TI03/TO03/TI13/TO13/SEG17
P04					SCK00/TI04/TO04/TI14/TO14/SEG18
P05					TI05/TO05/TI15/TO15/SEG19
P07					TI07/TO07/TI17/TO17/SEG21
P10	I/O	Port 1. 7-bit I/O port. Input of P10, P11, and P17 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	LTxD1/SCK00/TI10/TO10/INTP4/SEG31
P11					LRxD1/INTPLR1/SI00/TI11/TO11/SEG30
P12					SO00/TI12/TO12/INTP2/SEG29
P13					SO01/TI13/TO13/SEG25
P14					TI14/TO14/LRxD0/INTPLR0/SEG24
P15					TI15/TO15/LTxD0/RTC1HZ/SEG23
P17					TI17/TO17/INTP0/SEG28
P20	I/O	Port 2. 5-bit I/O port. Can be set to analog input ^{Note2} Input/output can be specified in 1-bit units.	HZ	Analog Input	AVREFP/ANI0
P21					AVREFM/ANI1
P22					ANI2
P23					ANI3
P27					ANI7
P30	I/O	Port 3. 4-bit I/O port. Input of P31 can be set to schmitt 1 input buffer. Output of P30 and P31 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI20/TO20/SCL11/SEG6
P31					TI21/TO21/SDA11/SEG7
P32					TI22/TO22/SEG8
P33					TI23/TO23/SEG9
P40	I/O	Port 4. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: HZ Int.: PU	Input	TOOL0
P54	I/O	Port 5. 4-bit I/O port. Input of P55 to P57 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI14/TO14/SO01/SEG2
P55					TI15/TO15/SI01/SEG3
P56					TI16/TO16/SCK01/SEG4
P57					TI17/TO17/SEG5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, PU: Pull up, HZ: High impedance

Notes 1. CTxD0 and CRxD0 are not provided for R5F10CLDxFB with no CAN channel.

2. Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

Table 2-3. Port Pins for R5F10CLDxFB, R5F10DLDFB, R5F10DLExFB (2/2)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P60	I/O	Port 6. 2-bit I/O port. Input of P61 can be set to schmitt 1 input buffer. Output of P60 and P61 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	SCL11/TI20/TO20/INTP1
P61					SDA11/TI21/TO21/INTP3
P70	I/O	Port 7. 6-bit I/O port. Input of P70 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	CRxD0/LRxD0/INTPLR0/TI03/TO03/TOOLRXD ^{Note}
P71					CTxD0/LTxD0/TOOLTxD ^{Note}
P72			Ext.: PD		ADTRG/SGOA/SEG1
P73			Int.: HZ		SGO/SGOF/SEG0
P74					SCK01/TI23/TO23/SEG26
P75					PCL/SI01/TI22/TO22/SEG27
P80	I/O	Port 8. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD	Input	SM11/TI01/TO01/SEG32
P81					Int.: HZ
P82			SM13/TI05/TO05/SEG34		
P83			SM14/ZPD14/TI07/TO07/SEG35		
P84			SM21/TI11/TO11/SEG36		
P85			SM22/TI13/TO13/SEG37		
P86			SM23/TI15/TO15/SEG38		
P87			SM24/ZPD24/TI17/TO17/SEG39		
P90	I/O	Port 9. 5-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD	Input	TI21/TO21/SEG40
P91					Int.: HZ
P92			TI25/TO25/SGOA/SEG42		
P93			TI27/TO27/SGO/SGOF/SEG43		
P94			TI01/TO01/RTC1HZ/SEG44		
P121	I	Port 12. 4-bit Input port.	HZ	Input	X1
P122					X2/EXCLK
P123					XT1
P124					XT2
P137	I	Port 13. 1-bit Input port.	HZ	Input	INTP5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, HZ: High impedance

Note CTxD0 and CRxD0 are not provided for R5F10CLDxFB with no CAN channel.

2.1.3 80-pin products

**Table 2-4. Port Pins for R5F10CMDxFB, R5F10CMExFB,
R5F10DMDxFB, R5F10DMExFB, R5F10DMFxFB, R5F10DMGxFB, R5F10DMJxFB (1/2)**

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P00	I/O	Port 0. 8-bit I/O port. Input of P01 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI00/TO00/CTxD0/SEG14 ^{Note1}
P01					TI01/TO01/CRxD0/SEG15 ^{Note1}
P02					SO00/TI02/TO02/TI12/TO12/SEG16
P03					SI00/TI03/TO03/TI13/TO13/SEG17
P04					SCK00/TI04/TO04/TI14/TO14/SEG18
P05					TI05/TO05/TI15/TO15/SEG19
P06					TI06/TO06/TI16/TO16/SEG20
P07					TI07/TO07/TI17/TO17/SEG21
P10	I/O	Port 1. 8-bit I/O port. Input of P10, P11, and P17 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	LTxD1/SCK00/TI10/TO10/INTP4/SEG31
P11					LRxD1/INTPLR1/SI00/TI11/TO11/SEG30
P12					SO00/TI12/TO12/INTP2/SEG29
P13					SO01/TI13/TO13/SEG25
P14					TI14/TO14/LRxD0/INTPLR0/SEG24
P15					TI15/TO15/LTxD0/RTC1HZ/SEG23
P16					TI16/TO16/SEG22
P17					TI17/TO17/INTP0/SEG28
P20	I/O	Port 2. 8-bit I/O port. Can be set to analog input ^{Note2} Input/output can be specified in 1-bit units.	HZ	Analog Input	AVREFP/ANI0
P21					AVREFM/ANI1
P22 to P27					ANI2 to ANI7
P30	I/O	Port 3. 8-bit I/O port. Input of P31 can be set to schmitt 1 input buffer. Output of P30 and P31 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI20/TO20/SCL11/SEG6
P31					TI21/TO21/SDA11/SEG7
P32					TI22/TO22/SO00/SEG8
P33					TI23/TO23/SI00/SEG9
P34					TI24/TO24/SCK00/SEG10
P35					TI25/TO25/SEG11
P36					TI26/TO26/SEG12
P37					TI27/TO27/SEG13
P40	I/O	Port 4. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: HZ Int.: PU	Input	TOOL0
P54	I/O	Port 5. 4-bit I/O port. Input of P55 to P57 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI14/TO14/SO01/SEG2
P55					TI15/TO15/SI01/SEG3
P56					TI16/TO16/SCK01/SEG4
P57					TI17/TO17/SEG5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, PU: Pull up, HZ: High impedance

Notes 1. CTxD0 and CRxD0 are not provided for R5F10CMExFB and R5F10CMDxFB with no CAN channel.
2. Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

**Table 2-4. Port Pins for R5F10CMDxFB, R5F10CMExFB,
R5F10DMDxFB, R5F10DMExFB, R5F10DMFxFB, R5F10DMGxFB, R5F10DMJxFB (2/2)**

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P60	I/O	Port 6. 4-bit I/O port.	HZ	Input	SCL11/TI20/TO20/INTP1
P61		Input of P61 can be set to schmitt 1 input buffer.			SDA11/TI21/TO21/INTP3
P65		Output of P60 and P61 can be set to N-ch open-drain output.			TI25/TO25
P66		Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.			TI24/TO24/PCL
P70	I/O	Port 7. 6-bit I/O port.	HZ	Input	CRxD0/LRxD0/INTPLR0/TI03/TO03/TOOLRXD ^{Note}
P71		Input of P70 can be set to schmitt 1 input buffer.			CTxD0/LTxD0/TOOLTxD ^{Note}
P72		Input/output can be specified in 1-bit units.	Ext.: PD Int.: HZ		ADTRG/SGOA/SEG1
P73					SGO/SGOF/SEG0
P74		Use of an on-chip pull-up resistor can be specified by a software setting.			SCK01/TI23/TO23/SEG26
P75					PCL/SI01/TI22/TO22/SEG27
P80	I/O	Port 8. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	SM11/TI01/TO01/SEG32
P81		Input/output can be specified in 1-bit units.			SM12/TI03/TO03/SEG33
P82		Use of an on-chip pull-up resistor can be specified by a software setting.			SM13/TI05/TO05/SEG34
P83					SM14/ZPD14/TI07/TO07/SEG35
P84					SM21/TI11/TO11/SEG36
P85					SM22/TI13/TO13/SEG37
P86					SM23/TI15/TO15/SEG38
P87					SM24/ZPD24/TI17/TO17/SEG39
P90	I/O	Port 9. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	SM31/TI21/TO21/SEG40
P91		Input/output can be specified in 1-bit units.			SM32/TI23/TO23/SEG41
P92		Use of an on-chip pull-up resistor can be specified by a software setting.			SM33/TI25/TO25/SGOA/SEG42
P93					SM34/ZPD34/TI27/TO27/SGO/SGOF/SEG43
P94					SM41/TI01/TO01/RTC1HZ/SEG44
P95					SM42/TI03/TO03/SEG45
P96					SM43/TI05/TO05/SEG46
P97					SM44/ZPD44/TI07/TO07/SEG47
P121	I	Port 12. 4-bit Input port.	HZ	Input	X1
P122					X2/EXCLK
P123					XT1
P124					XT2
P137	I	Port 13. 1-bit Input port.	HZ	Input	INTP5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, HZ: High impedance

Note CTxD0 and CRxD0 are not provided for R5F10CMExFB and R5F10CMDxFB with no CAN channel.

2.1.4 100-pin products

Table 2-5. Port Pins for R5F10DPExFB, R5F10DPFxFB, R5F10DPGxFB, R5F10TPJxFB, R5F10DPJxFB (1/3)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function	
P00	I/O	Port 0. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	TI00/TO00/CTxD0/SEG14	
P01		Input of P01 can be set to schmitt 1 input buffer.			TI01/TO01/CRxD0/SEG15	
P02		Input/output can be specified in 1-bit units.			SO00/TI02/TO02/TI12/TO12/SEG16	
P03					SI00/TI03/TO03/TI13/TO13/SEG17	
P04		Use of an on-chip pull-up resistor can be specified by a software setting.				SCK00/TI04/TO04/TI14/TO14/SEG18
P05						TI05/TO05/TI15/TO15/SEG19
P06						TI06/TO06/TI16/TO16/SEG20
P07						TI07/TO07/TI17/TO17/SEG21
P10	I/O	Port 1. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	LTxD1/SCK00/TI10/TO10/INTP4/SEG31	
P11		Input of P10, P11, and P17 can be set to schmitt 1 input buffer.			LRxD1/INTPLR1/SI00/TI11/TO11/SEG30	
P12		Input/output can be specified in 1-bit units.			SO00/TI12/TO12/INTP2/SEG29	
P13					SO01/TI13/TO13/SEG25	
P14		Use of an on-chip pull-up resistor can be specified by a software setting.				TI14/TO14/LRxD0/INTPLR0/SEG24
P15						TI15/TO15/LTxD0/RTC1HZ/SEG23
P16						TI16/TO16/SEG22
P17						TI17/TO17/INTP0/SEG28
P20	I/O	Port 2. 8-bit I/O port.	HZ	Analog Input	AVREFP/ANI0	
P21		Can be set to analog input ^{Note}			AVREFM/ANI1	
P22 to P27		Input/output can be specified in 1-bit units.			ANI2 to ANI7	
P30	I/O	Port 3. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	TI20/TO20/SCL11/SEG6	
P31		Input of P31 can be set to schmitt 1 input buffer.			TI21/TO21/SDA11/SEG7	
P32		Output of P30 and P31 can be set to N-ch open-drain output.			TI22/TO22/SO00/SEG8	
P33					TI23/TO23/SI00/SEG9	
P34		Input/output can be specified in 1-bit units.				TI24/TO24/SCK00/SEG10
P35						TI25/TO25/SEG11
P36		Use of an on-chip pull-up resistor can be specified by a software setting.				TI26/TO26/SEG12
P37						TI27/TO27/SEG13
P40	I/O	Port 4. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: HZ Int.: PU	Input	TOOL0	
P50	I/O	Port 5. 8-bit I/O port.	Ext.: PD Int.: HZ	Input	TI02/TO02/SDA11/SEG49	
P51		Input of P50 to P52 and P55 to P57 can be set to schmitt 1 input buffer.			TI04/TO04/SCK10/SEG50	
P52		Output of P50 can be set to N-ch open-drain output.			TI06/TO06/SI10/SEG51	
P53					TI13/TO13/SO10/SEG52	
P54		Input/output can be specified in 1-bit units.				TI14/TO14/SO01/SEG2
P55						TI15/TO15/SI01/SEG3
P56		Use of an on-chip pull-up resistor can be specified by a software setting.				TI16/TO16/SCK01/SEG4
P57						TI17/TO17/SEG5

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, PU: Pull up, HZ: High impedance

Note Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

Table 2-5. Port Pins for R5F10DPExFB, R5F10DPFxFB, R5F10DPGxFB, R5F10TPJxFB, R5F10DPJxFB (2/3)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P60	I/O	Port 6. 4-bit I/O port. Input of P61, P63 can be set to schmitt 1 input buffer. Output of P60 and P61 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	SCL11/TI20/TO20/INTP1
P61					SDA11/TI21/TO21/INTP3
P62					CTxD1/TI27/TO27 ^{Note}
P63					CRxD1/TI26/TO26 ^{Note}
P64					RTC1HZ/TI11/TO11
P65					TI25/TO25
P66					TI24/TO24/PCL
P70	I/O	Port 7. 6-bit I/O port. Input of P70 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	CRxD0/LRxD0/INTPLR0/TI03/TO03/TOOLRXD
P71					CTxD0/LTxD0/TOOLTxD
P72					ADTRG/SGOA/SEG1
P73			SGO/SGOF/SEG0		
P74			SCK01/TI23/TO23/SEG26		
P75			PCL/SI01/TI22/TO22/SEG27		
P80	I/O	Port 8. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	SM11/TI01/TO01/SEG32
P81					SM12/TI03/TO03/SEG33
P82					SM13/TI05/TO05/SEG34
P83					SM14/ZPD14/TI07/TO07/SEG35
P84			SM21/TI11/TO11/SEG36		
P85			SM22/TI13/TO13/SEG37		
P86			SM23/TI15/TO15/SEG38		
P87			SM24/ZPD24/TI17/TO17/SEG39		
P90	I/O	Port 9. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	SM31/TI21/TO21/SEG40
P91					SM32/TI23/TO23/SEG41
P92					SM33/TI25/TO25/SGOA/SEG42
P93					SM34/ZPD34/TI27/TO27/SGO/SGOF/SEG43
P94			SM41/TI01/TO01/RTC1HZ/SEG44		
P95			SM42/TI03/TO03/SEG45		
P96			SM43/TI05/TO05/SEG46		
P97			SM44/ZPD44/TI07/TO07/SEG47		
P121	I	Port 12. 4-bit Input port.	HZ	Input	X1
P122					X2/EXCLK
P123					XT1
P124					XT2

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, HZ: High impedance

Note CTxD1 and CRxD1 are not provided for R5F10TPJxFB, R5F10DPGxFB, R5F10DPFxFB and R5F10DPExFB with a CAN channel.

Table 2-5. Port Pins for R5F10DPExFB, R5F10DPFxFB, R5F10DPGxFB, R5F10TPJxFB, R5F10DPJxFB (3/3)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P130	O	Port 13. 1-bit output port, 1-bit input port and 6-bit I/O port. Input of P135 can be set to schmitt 1 input buffer. Output of P136 can be set to N-ch open-drain output. Input/output of P131 to P136 can be specified in 1-bit units. Use of an on-chip pull-up resistor of P131 to P136 can be specified by a software setting	Output Low	Output	–
P131	I/O		HZ	Input	SO10/LTxD1/TI21/TO21
P132					SI10/LRxD1/INTPLR1/TI20/TO20
P133					SCK10/TI22/TO22
P134					SGOA/CTxD1/TI24/TO24 ^{Note1}
P135					SGO/SGOF/CRxD1/TI26/TO26 ^{Note1}
P136					Ext.: PD Int.: HZ
P137	I		HZ	Input	INTP5
P140	I/O	Port 14. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting	HZ	Input	TI11/TO11
P150	I/O	Port 14. 1-bit I/O port. Can be set to analog input ^{Note2} Input/output can be specified.	HZ	Analog Input	ANI8

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, HZ: High impedance

Notes 1. CTxD1 and CRxD1 are not provided for R5F10TPJxFB, R5F10DPGxFB, R5F10DPFxFB and R5F10DPExFB with a CAN channel.

2. Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

2.1.5 128-pin products

Table 2-6. R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB (1/4)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P00	I/O	Port 0. 8-bit I/O port. Input of P01 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	CTxD0/TI00/TO00/SEG14
P01					CRxD0/TI01/TO01/SEG15
P02					SO00/TxD0/TI02/TO02/TI12/TO12/SEG16
P03					SI00/RxD0/TI03/TO03/TI13/TO13/SEG17
P04					SCK00/TI04/TO04/TI14/TO14/SEG18
P05					TI05/TO05/TI15/TO15/SEG19
P06					TI06/TO06/TI16/TO16/SEG20
P07					TI07/TO07/TI17/TO17/SEG21
P10	I/O	Port 1. 8-bit I/O port. Input of P10, P11, and P17 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	LTXD1/SCK00/TI10/TO10/INTP4/SEG31
P11					LRxD1/INTPLR1/SI00/RxD0/TI11/TO11/SEG30
P12					SO00/TxD0/TI12/TO12/INTP2/SEG29
P13					SO01/TI13/TO13/SEG25
P14					LRxD0/INTPLR0/TI14/TO14/SEG24
P15					LTXD0/RTC1HZ/TI15/TO15/SEG23
P16					TI16/TO16/SEG22
P17					TI17/TO17/INTP0/SEG28
P20	I/O	Port 2. 8-bit I/O port. Can be set to analog input ^{Note} Input/output can be specified in 1-bit units.	HZ	Analog Input	AV _{REFP} /ANI0
P21					AV _{REFM} /ANI1
P22 to P27					ANI2 to ANI7
P30	I/O	Port 3. 8-bit I/O port. Input of P31 can be set to schmitt 1 input buffer. Output of P30 and P31 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI20/TO20/SCL11/SEG6
P31					TI21/TO21/SDA11/SEG7
P32					TI22/TO22/SO00/TxD0/SEG8
P33					TI23/TO23/SI00/RxD0/SEG9
P34					TI24/TO24/SCK00/SEG10
P35					TI25/TO25/SEG11
P36					TI26/TO26/SEG12
P37					TI27/TO27/SEG13
P40	I/O	Port 4. 8-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: HZ	Input	TOOL0
P41			Int.: PU		STOPST/TI04/TO04
P42			HZ		TI10/TO10/SEG7
P43			Ext.: PD		TI22/TO22/SEG14
P44			Int.: HZ		TI23/TO23/SEG15
P45					SEG53
P46					DBWR/SEG27
P47					DBRD/SEG26

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, PU: Pull up, HZ: High impedance

Note Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

Table 2-6. R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB (2/4)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P50	I/O	Port 5. 8-bit I/O port. Input of P50 to P52 and P55 to P57 can be set to schmitt 1 input buffer. Output of P50 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI02/TO02/SDA11/SEG49
P51					TI04/TO04/SCK10/SEG50
P52					TI06/TO06/SI10/SEG51
P53					TI13/TO13/SO10/SEG52
P54					TI14/TO14/SO01/SEG2
P55					TI15/TO15/SI01/SEG3
P56					TI16/TO16/SCK01/SEG4
P57					TI17/TO17/SEG5
P60	I/O	Port 6. 7-bit I/O port. Input of P61, P63 can be set to schmitt 1 input buffer. Output of P60 and P61 can be set to N-ch open-drain output. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	SCL11/TI20/TO20/INTP1
P61					SDA11/TI21/TO21/INTP3
P62					CTxD1/TI27/TO27
P63					CRxD1/TI26/TO26
P64					RTC1HZ/TI11/TO11
P65					TI25/TO25
P66					TI24/TO24/PCL
P70	I/O	Port 7. 6-bit I/O port. Input of P70 can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	HZ	Input	CRxD0/LRxD0/INTPLR0/TI03/TO03/TOOLRxD
P71					CTxD0/LTxD0/TOOLTxD
P72					SGOA/ADTRG/SEG1
P73			SGO/SGOF/SEG0		
P74			SCK01/TI23/TO23/SEG26		
P75			SI01/TI22/TO22/SEG27/PCL		
P80	I/O	Port 8. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	SM11/TI01/TO01/SEG32
P81					SM12/TI03/TO03/SEG33
P82					SM13/TI05/TO05/SEG34
P83					SM14/ZPD14/TI07/TO07/SEG35
P84					SM21/TI11/TO11/SEG36
P85					SM22/TI13/TO13/SEG37
P86					SM23/TI15/TO15/SEG38
P87					SM24/ZPD24/TI17/TO17/SEG39

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset,
PD: Pull down, HZ: High impedance

Table 2-6. R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB (3/4)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function		
P90	I/O	Port 9. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	SM31/TI21/TO21/SEG40		
P91					SM32/TI23/TO23/SEG41		
P92					SM33/SGOA/TI25/TO25/SEG42		
P93					SM34/ZPD34/SGO/SGOF/TI27/TO27/SEG43		
P94					SM41/RTC1HZ/TI01/TO01/SEG44		
P95					SM42/TI03/TO03/SEG45		
P96					SM43/TI05/TO05/SEG46		
P97					SM44/ZPD44/TI07/TO07/SEG47		
P100	I/O	Port 10. 8-bit I/O port. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	TI24/TO24/SEG36		
P101					TI25/TO25/SEG37		
P102					TI26/TO26/SEG38		
P103					TI27/TO27/SEG39		
P104					TI01/TO01/SEG44		
P105					TI02/TO02/SEG45		
P106					TI05/TO05/SEG46		
P107					TI06/TO06/SEG47		
P110	I/O	Port 10. 8-bit I/O port. Input can be set to schmitt 1 input buffer. Input/output can be specified in 1-bit units. Use of an on-chip pull-up resistor can be specified by a software setting.	Ext.: PD Int.: HZ	Input	DBD0/SCK00/TI00/TO00/SEG35		
P111					DBD1/SI00/RxD0/TI02/TO02/SEG34		
P112					DBD2/SO00/TxD0/TI04/TO04/SEG33		
P113					DBD3/TI06/TO06/SEG32		
P114					DBD4/TI07/TO07/SEG31		
P115					DBD5/TI10/TO10/SEG30		
P116					DBD6/TI12/TO12/SEG29		
P117					DBD7/TI20/TO20/SEG28		
P121	I	Port 12. 4-bit Input port, 3-bit I/O port. Input/output of P125 to P127 can be specified in 1-bit units. Use of an on-chip pull-up resistor of P125 to P127 can be specified by a software setting.	HZ	Input	X1		
P122					X2/EXCLK		
P123					XT1		
P124					XT2		
P125					I/O	Ext.: PD Int.: HZ	TI12/TO12/SEG25
P126							TI14/TO14/SEG24
P127							TI16/TO16/SEG23

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, HZ: High impedance

Table 2-6. R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB (4/4)

Pin Name	I/O	Function	During Reset	After Reset	Alternate Function
P130	O	Port 13. 1-bit output port, 1-bit input port and 6-bit I/O port. Input of P135 can be set to schmitt 1 input buffer. Output of P136 can be set to N-ch open-drain output. Input/output of P131 to P136 can be specified in 1-bit units. Use of an on-chip pull-up resistor of P131 to P136 can be specified by a software setting	Output Low	Output	RESOUT
P131	I/O		HZ	Input	SO10/LTxD1/TI21/TO21
P132					SI10/LRxD1/INTPLR1/TI20/TO20
P133					SCK10/TI22/TO22
P134					SGOA/CTxD1/TI24/TO24
P135					SGO/SGOF/CRxD1/TI26/TO26
P136					TI00/TO00/SCL11/SEG48
P137	I		Ext.: PD Int.: HZ	Input	INTP5
P140	I/O	Port 14. 1-bit I/O port. Input/output can be specified. Use of an on-chip pull-up resistor can be specified by a software setting	HZ	Input	TI11/TO11
P150	I/O	Port 15. 3-bit I/O port.	HZ	Analog	ANI8
P151		Can be set to analog input ^{Note}		Input	ANI9
P152		Input/output can be specified.			ANI10

Remark Ext. (external reset): POR reset or pin reset, Int. (internal reset): WDT reset or LVD reset, PD: Pull down, HZ: High impedance

Note Setting digital or analog to each pin can be done in A/D port configuration register (ADPC).

2.1.6 Pins for each product (pins other than port pins)

(1/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
ADTRG	Input	A/D conversion start trigger external input	31	43	55	65	53
ANI0/AVREFF		A/D converter analog input	4	4	8	10	113
ANI1/AVREFM			3	3	7	9	112
ANI2			2	2	6	8	111
ANI3			1	1	5	7	110
ANI4			–	–	4	6	109
ANI5			–	–	3	5	108
ANI6			–	–	2	4	107
ANI7			48	64	1	3	106
ANI8			–	–	–	2	105
ANI9			–	–	–	–	104
ANI10			–	–	–	–	103
COM0	Output	LCD common output 0	36	48	60	70	58
COM1		LCD common output 1	35	47	59	69	57
COM2		LCD common output 2	34	46	58	68	56
COM3		LCD common output 3	33	45	57	67	55
SEG0	Output	LCD segment output 0	32	44	56	66	54
SEG1		LCD segment output 1	31	43	55	65	53
SEG2		LCD segment output 2	30	42	54	64	52
SEG3		LCD segment output 3	29	41	53	63	51
SEG4		LCD segment output 4	28	40	52	62	50
SEG5		LCD segment output 5	27	39	51	61	49
SEG6		LCD segment output 6	26	38	50	60	48
SEG7		LCD segment output 7	25	37	49	59	47, 95
SEG8		LCD segment output 8	–	36	48	58	46
SEG9		LCD segment output 9	24	35	47	57	45
SEG10		LCD segment output 10	–	–	46	56	44
SEG11		LCD segment output 11	–	–	45	55	43
SEG12		LCD segment output 12	–	–	44	54	42
SEG13		LCD segment output 13	–	–	43	53	41
SEG14		LCD segment output 14	23	34	42	52	40, 94
SEG15		LCD segment output 15	22	33	41	51	39, 93
SEG16		LCD segment output 16	–	32	40	50	35
SEG17		LCD segment output 17	–	31	39	49	34
SEG18		LCD segment output 18	–	30	38	48	33
SEG19		LCD segment output 19	–	29	37	47	32
SEG20		LCD segment output 20	–	–	36	46	31
SEG21		LCD segment output 21	–	28	35	45	30
SEG22		LCD segment output 22	–	–	34	44	29
SEG23		LCD segment output 23	–	27	33	43	28, 38
SEG24		LCD segment output 24	21	26	32	42	27, 37
SEG25		LCD segment output 25	20	25	31	41	26, 36
SEG26		LCD segment output 26	19	24	30	40	25, 19

(2/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
SEG27	Output	LCD segment output 27	18	23	29	39	24, 18
SEG28		LCD segment output 28	–	22	28	38	23, 17
SEG29		LCD segment output 29	17	21	27	37	22, 16
SEG30		LCD segment output 30	16	20	26	36	21, 15
SEG31		LCD segment output 31	15	19	25	35	20, 14
SEG32		LCD segment output 32	47	63	80	95	88, 13
SEG33		LCD segment output 33	46	62	79	94	87, 12
SEG34		LCD segment output 34	45	61	78	93	86, 11
SEG35		LCD segment output 35	44	60	77	92	85, 10
SEG36		LCD segment output 36	–	57	74	89	82, 92
SEG37		LCD segment output 37	–	56	73	88	81, 91
SEG38		LCD segment output 38	–	55	72	87	80, 90
SEG39		LCD segment output 39	–	54	71	86	79, 89
SEG40		LCD segment output 40	41	53	70	85	78
SEG41		LCD segment output 41	40	52	69	84	77
SEG42		LCD segment output 42	39	51	68	83	76
SEG43		LCD segment output 43	38	50	67	82	75
SEG44		LCD segment output 44	37	49	64	79	72, 68
SEG45		LCD segment output 45	–	–	63	78	71, 67
SEG46		LCD segment output 46	–	–	62	77	70, 66
SEG47		LCD segment output 47	–	–	61	76	69, 65
SEG48		LCD segment output 48	–	–	–	75	64
SEG49		LCD segment output 49	–	–	–	74	63
SEG50		LCD segment output 50	–	–	–	73	62
SEG51		LCD segment output 51	–	–	–	72	61
SEG52		LCD segment output 52	–	–	–	71	60
SEG53		LCD segment output 53	–	–	–	–	59
TI00		Input	External count clock input/capture trigger to 16-bit timer 00 to 07	23	34	42	75,52
TI01	22, 37, 47			63,49,33	80,64,41	95,79,51	39, 88, 72, 68
TI02	–			32	40	74,50	35, 63, 67, 11
TI03	46			62,7,31	79,63,11,39	94,78,49,13	34, 87, 71, 116
TI04	–			30	38	48,73	33, 62, 12, 101
TI05	45			61, 29	78,62,37	93,77,47	32, 86, 70, 66
TI06	–			–	36	46,72	31, 61, 65, 13
TI07	44			60,28	77,61,35	92,76,45	30, 85, 69, 14
TO00	Output	16-bit timer 00 to 07 output	23	34	42	75,52	40, 64, 10
TO01			22, 37, 47	63,49,33	80,64,41	95,79,51	39, 88, 72, 68
TO02			–	32	40	74,50	35, 63, 67, 11
TO03			46	62,7, 31	79,63,11,39	94,78,49,13	34, 87, 71, 116
TO04			–	30	38	48,73	33, 62, 12, 101
TO05			45	61,29	78,62,37	93,77,47	32, 86, 70, 66
TO06			–	–	36	46,72	31, 61, 65, 13
TO07			44	60,28	77,61,35	92,76,45	30, 85, 69, 14

(3/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
TI10	Input	External count clock input/capture trigger to 16-bit timer 10 to 17	15	19	25	35	20, 15, 95
TI11			16	57, 20	74, 26	89, 14, 30, 36	21, 82, 117, 5
TI12			17	32, 21	40, 27	50, 37	22, 36, 35, 16
TI13			20	56, 25, 31	73, 31, 39	88, 71, 41, 49	34, 26, 60, 81
TI14			21, 30	30, 26, 42	38, 32, 54	48, 42, 64	27, 37, 52, 33
TI15			29	55, 41, 27, 29	72, 53, 33, 37	87, 63, 43, 47	28, 32, 51, 80
TI16			28	40	36, 34, 52	46, 44, 62	29, 38, 50, 31
TI17			27	54, 39, 22, 28	71, 51, 28, 35	86, 61, 38, 45	23, 30, 79, 49
TO10	Output	16-bit timer 10 to 17 output	15	19	25	35	20, 15, 95
TO11			16	57, 20	74, 26	89, 14, 30, 36	21, 82, 117, 5
TO12			17	32, 21	40, 27	50, 37	22, 36, 35, 16
TO13			20	56, 25, 31	73, 31, 39	88, 71, 41, 49	34, 26, 60, 81
TO14			21, 30	30, 26, 42	38, 32, 54	48, 42, 64	27, 37, 52, 33
TO15			29	55, 41, 27, 29	72, 53, 33, 37	87, 63, 43, 47	28, 32, 51, 80
TO16			28	40	36, 34, 52	46, 44, 62	29, 38, 50, 31
TO17			27	54, 39, 22, 28	71, 51, 28, 35	86, 61, 38, 45	23, 30, 79, 49
TI20	Input	External count clock input/capture trigger to 16-bit timer 20 to 27	13, 26	17, 38	21, 50	26, 60, 99	1, 48, 99, 17
TI21			14, 25, 41	53, 37, 18	70, 49, 22	100, 85, 59, 27	2, 47, 100, 78
TI22			18	23, 36	29, 48	39, 58, 98	24, 46, 98, 94
TI23			19, 24, 40	52, 35, 24	69, 47, 30	84, 57, 40	25, 45, 77, 93
TI24			–	–	24, 46	32, 56, 97	7, 44, 97, 92
TI25			39	51	68, 45, 23	83, 55, 31	6, 76, 43, 91
TI26			–	–	44	29, 54, 96	4, 42, 96, 90
TI27			38	50	67, 43	82, 53, 28	75, 3, 41, 89
TO20	Output	16-bit timer 20 to 27 output	13, 26	17, 38	21, 50	26, 60, 99	1, 48, 99, 17
TO21			14, 25, 41	53, 37, 18	70, 49, 22	100, 85, 59, 27	2, 47, 100, 78
TO22			18	23, 36	29, 48	39, 58, 98	24, 46, 98, 94
TO23			19, 24, 40	52, 35, 24	69, 47, 30	84, 57, 40	25, 45, 77, 93
TO24			–	–	24, 46	32, 56, 97	7, 44, 97, 92
TO25			39	51	68, 45, 23	83, 55, 31	6, 76, 43, 91
TO26			–	–	44	29, 54, 96	4, 42, 96, 90
TO27			38	50	67, 43	82, 53, 28	75, 3, 41, 89
SCK00	Input/ Output	Clock input/output for CSI00	15	19, 30	46, 25, 38	56, 35, 48	20, 33, 44, 10
SI00	Input	Serial data input to CSI00	16	20, 31	47, 26, 39	57, 36, 49	21, 34, 45, 11
SO00	Output	Serial data output from CSI00	17	21, 32	48, 27, 40	58, 37, 50	22, 35, 46, 12
SCK01	Input/ Output	Clock input/output for CSI01	19, 28	40, 24	52, 30	62, 40	50, 25
SI01	Input	Serial data input to CSI01	18, 29	41, 23	53, 29	63, 39	51, 24
SO01	Output	Serial data output from CSI01	20, 30	42, 25	54, 31	64, 41	52, 26

(4/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
RxD0	Input	Serial data input to UART0	–	–	–	–	21, 34, 45, 11
TxD0	Output	Serial data output from UART0	–	–	–	–	22, 35, 46, 12
SCK10	Input/ Output	Clock input/output for CSI10	–	–	–	98,73	98, 62
SI10	Input	Serial data input to CSI10	–	–	–	99,72	99, 61
SO10	Output	Serial data output from CSI10	–	–	–	100,71	100, 60
SCL11	Output	Clock output for simplified I ² C	13, 26	38,17	50,21	75,60,26	64, 48, 1
SDA11	Input/ Output	Serial data I/O for simplified I ² C	14, 25	37,18	49,22	74,59,27	63, 47, 2
LRxD0	Input	Serial data input to LIN-UART0	–	26,7	32,11	42,13	27, 116
INTPLR0	Input	External interrupt request input for which the valid edge for LIN-UART0	–	26,7	32,11	42,13	27, 116
LTxD0	Output	Serial data output from LIN-UART0	–	27,6	33,10	43,12	28, 115
LRxD1	Input	Serial data input to LIN-UART1	16	20	26	99,36	99, 21
INTPLR1	Input	External interrupt request input for which the valid edge for LIN-UART1	16	20	26	99,36	99, 21
LTxD1	Output	Serial data output from LIN-UART1	15	19	25	100,35	100, 20
CRxD0	Input	CAN receive data input 0	22 ^{Note1}	33,7 ^{Note1}	41,11 ^{Note1}	51,13	39, 116
CTxD0	Output	CAN transmit data output 0	23 ^{Note1}	34,6 ^{Note1}	42,10 ^{Note1}	52,12	40, 115
CRxD1	Input	CAN receive data input 1	–	–	–	96,29 ^{Note2}	96, 4
CTxD1	Output	CAN transmit data output 1	–	–	–	97,28 ^{Note2}	97, 3
RTC1Hz	Output	Realtime clock calibration output (1Hz)	37	49,27	64,33	79,30,43	72, 28, 5
SGOA	Output	SG output(Amplitude PWM)	31, 39	51,43	68,55	97,83,65	97, 76, 53
SGO/SGOF	Output	SG output (AND with PWM & Frequency) / SG output (Frequency)	32, 38	50,44	67, 56	96,82,66	96, 75, 54
SM11	Output	Stepper motor output 11	47	63	80	95	88
SM12	Output	Stepper motor output 12	46	62	79	94	87
SM13	Output	Stepper motor output 13	45	61	78	93	86
SM14	Output	Stepper motor output 14	44	60	77	92	85
ZPD14	Input	Zero point detection input 14	44	60	77	92	85

Notes 1. These pins are only for the following products:

- R5F10DGE, R5F10DGD, R5F10DGC (48 pin products)
- R5F10DLE, R5F10DLD (64 pin products)
- R5F10DMJ, R5F10DMG, R5F10DMF, R5F10DME, R5F10DMD (80 pin products)
- R5F10TPJ, R5F10DPG, R5F10DPF, R5F10DPE, R5F10DPL, R5F10DPK, R5F10DPJ (100-pin products)

2. These pins are only for R5F10DPL, R5F10DPK, R5F10DPJ.

(5/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
SM21	Output	Stepper motor output 21	–	57	74	89	82
SM22	Output	Stepper motor output 22	–	56	73	88	81
SM23	Output	Stepper motor output 23	–	55	72	87	80
SM24	Output	Stepper motor output 24	–	54	71	86	79
ZPD24	Input	Zero point detection input 24	–	54	71	86	79
SM31	Output	Stepper motor output 31	–	–	70	85	78
SM32	Output	Stepper motor output 32	–	–	69	84	77
SM33	Output	Stepper motor output 33	–	–	68	83	76
SM34	Output	Stepper motor output 34	–	–	67	82	75
ZPD34	Input	Zero point detection input 34	–	–	67	82	75
SM41	Output	Stepper motor output 41	–	–	64	79	72
SM42	Output	Stepper motor output 42	–	–	63	78	71
SM43	Output	Stepper motor output 43	–	–	62	77	70
SM44	Output	Stepper motor output 44	–	–	61	76	69
ZPD44	Input	Zero point detection input 44	–	–	61	76	69
DBD0	Input/ Output	LCD Bus I/F data lines 0	–	–	–	–	10
DBD1	Input/ Output	LCD Bus I/F data lines 1	–	–	–	–	11
DBD2	Input/ Output	LCD Bus I/F data lines 2	–	–	–	–	12
DBD3	Input/ Output	LCD Bus I/F data lines 3	–	–	–	–	13
DBD4	Input/ Output	LCD Bus I/F data lines 4	–	–	–	–	14
DBD5	Input/ Output	LCD Bus I/F data lines 5	–	–	–	–	15
DBD6	Input/ Output	LCD Bus I/F data lines 6	–	–	–	–	16
DBD7	Input/ Output	LCD Bus I/F data lines 7	–	–	–	–	17
DBWR	Output	LCD Bus I/F write strobe	–	–	–	–	18
DBRD	Output	LCD Bus I/F read strobe	–	–	–	–	19
STOPST	Output	STOP status output	–	–	–	–	101
RESOUT	Output	Reset output signal	–	–	–	–	102
PCL	Output	Clock output	18	23	24,29	32,39	24, 7
INTP0	Input	Interrupt from peripheral 0	–	22	28	38	23
INTP1	Input	Interrupt from peripheral 1	13	17	21	26	1
INTP2	Input	Interrupt from peripheral 2	17	21	27	37	22
INTP3	Input	Interrupt from peripheral 3	14	18	22	27	2
INTP4	Input	Interrupt from peripheral 4	15	19	25	35	20
INTP5	Input	Interrupt from peripheral 5	7	11	15	18	121

(6/6)

Function Name	I/O	Function	48-pin	64-pin	80-pin	100-pin	128-pin
			R5F10CGx/ R5F10DGx	R5F10CLx/ R5F10DLx	R5F10CMx/ R5F10DMx	R5F10TPx/ R5F10DPx	R5F10DSx
EXCLK	Input	External clock input for main system clock	8	12	16	19	122
X1		Resonator connection for main system clock	9	13	17	20	123
X2			8	12	16	19	122
XT1		Resonator connection for sub clock	–	10	14	17	120
XT2			–	9	13	16	119
RESET	Input	External system reset input	6	8	12	15	118
TOOLRxD	Input	UART reception pin for the external device connection used during flash memory programming	–	7	11	13	116
TOOLTxD	Output	UART transmission pin for the external device connection used during flash memory programming	–	6	10	12	115
TOOL0	Input/ output	Data I/O for flash memory programmer/debugger	5	5	9	11	114
REGC		Connecting regulator output stabilization capacitance for internal operation. Connect to VSS via a capacitor (0.47 to 1 μ F).	10	14	18	21	124
VDD		Power supply for P20 to P27, P150, P137, P121 to P124, RESET	12	16	20	24	127
EVDD, EVDD0, EVDD1		Power supply for P00 to P07, P10 to P17, P30 to P37, P50 to P57, P60 to P66, P70 to P75, P130 to P136 and P140	12	16	20	25, 33	8, 128
SMVDD, SMVDD0, SMVDD1		Power supply for P80 to P87, P90 to P97	43	59	66, 76	81, 91	74, 84
Vss		Ground potential for P20-P27, P150, P137, P121 to P124, RESET	11	15	19	22	125
EVss, EVss0, EVss1		Ground potential for P00 to P07, P10 to P17, P30 to P37, P50 to P57, P60 to P66, P70 to P75, P130 to P136 and P140	11	15	19	23, 34	9, 126
SMVss, SMVss0, SMVss1		Ground potential for P80 to P87, P90 to P97	42	58	65, 75	80, 90	73, 83

3. ELECTRICAL SPECIFICATIONS (J GRADE PRODUCT)

- Cautions**
1. These specifications show target values, which may change after device evaluation.
 2. The RL78/D1A has an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.

Definition of Pin Groups

Definition of pin groups described in this chapter is shown in the following table.

Pin groups		Pin names				
		48-pin products	64-pin products	80-pin products	100-pin products	128-pin products
Pin group 1	Group 1R	P40	P40, P70, P71	P40, P70, P71	P40, P70, P71, P130 to P135, P140	P40 to P44, P70, P71, P100 to P103, P130 to P135, P140
	Group 1L	P00 to P01, P10 to P14, P30 to P33, P54 to P57, P60, P61, P72 to P75	P00 to P05, P07, P10 to P15, P17, P30 to P33, P54 to P57, P60, P61, P72 to P75	P00 to P07, P10 to P17, P30 to P37, P54 to P57, P60, P61, P65, P66, P72 to P75	P00 to P07, P10 to P17, P30 to P37, P50 to P57, P72 to P75, P136	P00 to P07, P10 to P17, P30 to P37, P45 to P47, P50 to P57, P72 to P75, P104 to P107, P110 to P117, P125 to P127 P136
	Group 1C	-	-	-	P60 to P66	P60 to P66
Pin group 2 (ANI pins)		P20 to P23, P27	P20 to P23, P27	P20 to P27	P20 to P27, P150	P20 to P27, P150 to P152
Pin group 3 (SMC pins)	Group 3A	P80 to P83	P80 to P83	P80 to P83	P80 to P83	P80 to P83
	Group 3B	-	P84 to P87	P84 to P87	P84 to P87	P84 to P87
	Group 3C	P90 to P94	P90 to P94	P90 to P93	P90 to P93	P90 to P93
	Group 3D	-	-	P94 to P97	P94 to P97	P94 to P97
	Group 3E	P90 to P94	P84 to P87, P90 to P94	-	-	-
Pin group 4 (System pins)		P121 to P122, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137

Definition of Product Groups

Definition of product groups described in this chapter is shown in the following table.

Product groups	Product names				
	48-pin products	64-pin products	80-pin products	100-pin products	128-pin products
Product Group A	R5F10CGBJFB R5F10CGCJFB R5F10CGDJFB R5F10DGCJFB R5F10DGDJFB R5F10DGEJFB	R5F10CLDJFB R5F10DLDJFB R5F10DLEJFB	R5F10CMDJFB R5F10CMEJFB R5F10DMDJFB R5F10DMEJFB R5F10DMFJFB R5F10DMGJFB R5F10DMJJFB	R5F10DPEJFB R5F10DPFJFB R5F10DPGJFB R5F10DPJJFB R5F10TPJJFB	-
Product Group B	-	-	-	R5F10DPKJFB R5F10DPLJFB	R5F10DSJJFB R5F10DSKJFB R5F10DSLJFB

3.1 Absolute Maximum Ratings

T_A = +25 °C

Parameter	Symbols	Conditions	Ratings	Unit
Supply voltage	V _{DD}	V _{DD}	-0.5 to +6.5	V
	EV _{DD0} EV _{DD1}	EV _{DD0} = EV _{DD1}	-0.5 to +6.5 and -0.5 to V _{DD} + 0.3	V
	SMV _{DD0} SMV _{DD1}	SMV _{DD0} = SMV _{DD1}	-0.5 to +6.5 and -0.5 to V _{DD} + 0.3	V
	V _{SS}	V _{SS}	-0.5 to +0.3	V
	EV _{SS0} EV _{SS1}	EV _{SS0} = EV _{SS1}	-0.5 to +0.3	V
	SMV _{SS0} SMV _{SS1}	SMV _{SS0} = SMV _{SS1}	-0.5 to +0.3	V
	Supply voltage up/down ramp	V _{DDRAMP}		≤50
REGC pin input voltage	V _{IREGC}	REGC	-0.3 to +2.8 and -0.3 to V _{DD} + 0.3 ^{Note1}	V
Input voltage	V _{I1}	Pin group 1	-0.3 to +6.5 and -0.3 to EV _{DD0} (EV _{DD1}) + 0.3	V
	V _{I2}	Pin group 2	-0.3 to +6.5 and -0.3 to V _{DD} + 0.3	V
	V _{I3}	Pin group 3	-0.3 to +6.5 and -0.3 to SMV _{DD0} (SMV _{DD1}) + 0.3	V
	V _{I4}	Pin group 4	-0.3 to +6.5 and -0.3 to V _{DD} + 0.3	V

(Continue to next page)

T_A = +25 °C

Parameter	Symbols	Conditions		Ratings	Unit	
Output voltage	V _{O1}	Pin group 1		-0.3 to EV _{DD0} (EV _{DD1}) + 0.3	V	
	V _{O2}	Pin group 2		-0.3 to V _{DD} + 0.3	V	
	V _{O3}	Pin group 3		-0.3 to SMV _{DD0} (SMV _{DD1}) + 0.3	V	
	V _{COM}	COM0 to COM3		-0.3 to V _{DD} + 0.3	V	
Output current, high	I _{OH1}	Per pin	Pin group 1	-20	mA	
		Total	Pin group 1	-150	mA	
			Pin group 1L	-60	mA	
			Pin group 1R	-55	mA	
			Pin group 1C	-40	mA	
	I _{OH2}	Per pin	Pin group 2		-0.5	mA
		Total			-2.0	mA
	I _{OH3}	Per pin	Pin group 3		-58	mA
		Total	Pin group 3	48-pin, 64-pin	-270	mA
				80-pin, 100-pin, 128-pin	-480	mA
			Pin group 3A	-120	mA	
			Pin group 3B	-120	mA	
			Pin group 3C	-120	mA	
			Pin group 3D	-120	mA	
			Pin group 3E	-150	mA	
I _{OHCOM}	Per pin	COM0 to COM3		-0.5	mA	
	Total	COM0 to COM3		-1.0	mA	
Output current, low	I _{OL1}	Per pin	Pin group 1	20	mA	
		Total	Pin group 1	150	mA	
			Pin group 1L	60	mA	
			Pin group 1R	50	mA	
			Pin group 1C	40	mA	
	I _{OL2}	Per pin	Pin group 2		1.0	mA
		Total			5.0	mA
	I _{OL3}	Per pin	Pin group 3		58	mA
		Total	Pin group 3	48-pin, 64-pin	270	mA
				80-pin, 100-pin, 128-pin	480	mA
			Pin group 3A	120	mA	
			Pin group 3B	120	mA	
			Pin group 3C	120	mA	
			Pin group 3D	120	mA	
	Pin group 3E	150	mA			
I _{OLCOM}	Per pin	COM0 to COM3		0.5	mA	
	Total	COM0 to COM3		1.0	mA	
Operating ambient temperature	T _A	for normal operation mode		-40 to +85	°C	
		for code flash programming		-40 to +85	°C	
		for data flash programming		-40 to +85	°C	
Storage temperature	T _{stg}			-65 to +150	°C	

Note Connect the REGC pin to V_{ss} via a capacitor (0.47 to 1 μF).

This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

3.2 Power consumption characteristics

3.2.1 Product group A

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, run mode	I _{DD1} ^{Note 1}	High speed MAIN RUN Note 2, 3, 4	f _{CLK} = 32 MHz	f _{HOCO} = 32 MHz	5.2	22	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	4.2	18	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
		f _{CLK} = 20 MHz	f _X = 20 MHz	3.8	16	mA	
		f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	2.1	11	mA	
f _X = 8 MHz							
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	1.6	9	mA			
	f _X = 4 MHz						
		SUB RUN Note 2, 3, 5	f _{CLK} = f _{XT} = 32.768 kHz	6	300	μA	

- Notes**
- The common condition for I_{DD1}:
 - I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
 - The program is running in the code flash.
 - The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.
 - The maximum value is that when all peripheral devices are operating. But the A/D converter, RTC, LCD circuit and stepper motor circuit are stopped, and the data flash and the code flash are stated to read mode. The 16-bit wakeup timer operates with f_{LOCO}.
 - Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.
 - f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, halt mode	I _{DD2} ^{Note 1}	High speed MAIN HALT ^{Note 3, 4, 5}	f _{CLK} = 32 MHz 2.7 V ≤ V _{DD}	f _{HOCO} = 32 MHz	1.0	8.1	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	0.8	6.9	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 20 MHz	f _X = 20 MHz	0.7	6.0	mA
			f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	0.4	4.3	mA
f _X = 8 MHz							
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	0.35	3.6	mA			
	f _X = 4 MHz						
SUB HALT ^{Note 3, 4, 6}	f _{CLK} = f _{XT} = 32.768 kHz	RTC is stopped	1.0	130	μA		
		RTC is operated by f _{XT} = 32.768KHz					
Supply current, stop mode	I _{DD3} ^{Note 2}	STOP ^{Note 3, 4}	RTC and f _{XT} are stopped	0.4	60	μA	
			RTC is operated by f _{XT} = 32.768KHz	0.8			

Notes 1. The common condition for I_{DD2}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The HALT instruction is executed by the program in the code flash.
- The specification shows the stable current during HALT mode.

2. The common condition for I_{DD3}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The STOP instruction is executed by the program in the code flash during MAIN RUN operation.
- The spec shows the stable current during STOP mode.

3. The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.

4. The maximum value is that when all peripheral devices are operating. But the A/D converter, LCD circuit, stepper motor circuit, the data flash and the code flash are stopped. The 16-bit wakeup timer operates with f_{LOCO}.

5. Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.

6. f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit
WDT operating current ^{Note 1}	I _{WDT}			0.25	1.0	μA
ADC operating current ^{Note 2}	I _{ADC}	Normal mode	V _{DD} = 5.0 V	1.3	1.7	mA
		Low voltage mode	V _{DD} = 3.0 V	0.5	0.7	mA
LCD operating Current ^{Note 3}	I _{LCD}	f _{LCD} = f _{SUB} , LCD clock = 512 Hz	V _{DD} = 5.0 V	100	140	μA
			V _{DD} = 3.0 V	90	130	μA
ZPD operating current ^{Note 4}	I _{ZPD}	One ZPD operated	V _{DD} = 5.0 V	150	600	μA
			V _{DD} = 3.0 V	100	500	μA
		Four ZPDs operated	V _{DD} = 5.0 V	500	2000	μA
			V _{DD} = 3.0 V	400	1600	μA

- Notes**
1. Current flowing only to the watchdog timer. The maximum specification of I_{DD1}, I_{DD2} and I_{DD3} include I_{WDT}.
 2. Current flowing only to the A/D converter. The current value of the RL78/D1A is the sum of I_{DD} and I_{ADC} when the A/D converter operates.
 3. Current flowing only to the LCD controller/driver circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{LCD} when the LCD controller/driver circuit operates.
 4. Current flowing only to the ZPD circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{ZPD} when the ZPD circuit operates.

3.2.2 Product group B

TA = -40 to +85 °C, 2.7 V ≤ VDD ≤ 5.5 V, VSS = 0 V

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, run mode	IDD1 ^{Note 1}	High speed MAIN RUN ^{Note 2, 3, 4, 5}	f _{CLK} = 32 MHz	f _{HOCO} = 32 MHz	5.7	24	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	4.7	20	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 20 MHz	f _X = 20 MHz	4.3	17.5	mA
			f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	2.4	12	mA
f _X = 8 MHz							
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	1.8	9.5	mA			
	f _X = 4 MHz						
	SUB RUN ^{Note 2, 3, 6}	f _{CLK} = f _{XT} = 32.768 kHz		7	360	μA	

Notes 1. The common condition for I_{DD1}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
 - The program is running in the code flash.
2. The typical value is that when Ta=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.
 3. The maximum value is that when all peripheral devices are operating. But the A/D converter, RTC, LCD circuit and stepper motor circuit are stopped, and the data flash and the code flash are stated to read mode. The 16-bit wakeup timer operates with f_{LOCO}.
 4. Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.
 5. At 128-pin products, the value of I_{DD1} does not include the LCDB (P11x, P46-7) pin toggle current.
I_{DD1} condition of LCDB macro is f_{CLK}=32MHz, mod8 mode, data rate=8MHz, 4cycle, 16bit write/read.
 6. f_X and f_{HOCO} are stopped.

T_A = -40 to +85 °C, 2.7 V ≤ V_{DD} ≤ 5.5 V, V_{SS} = 0 V

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, halt mode	I _{DD2} ^{Note 1}	High speed MAIN HALT ^{Note 3, 4, 5}	f _{CLK} = 32 MHz 2.7 V ≤ V _{DD}	f _{HOCO} = 32 MHz	1.0	8.9	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	0.8	7.5	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
			f _{CLK} = 20 MHz	f _X = 20 MHz	0.7	6.5	mA
			f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	0.4	4.5	mA
f _X = 8 MHz							
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	0.35	3.8	mA			
	f _X = 4 MHz						
SUB HALT ^{Note 3, 4, 6}	f _{CLK} = f _{XT} = 32.768 kHz	RTC is stopped	1.0	140	μA		
		RTC is operated by f _{XT} = 32.768KHz	1.2				
Supply current, stop mode	I _{DD3} ^{Note 2}	STOP ^{Note 3, 4}	RTC and f _{XT} are stopped	0.4	70	μA	
			RTC is operated by f _{XT} = 32.768KHz	0.8			

- Notes**
- The common condition for I_{DD2}:
 - I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
 - The HALT instruction is executed by the program in the code flash.
 - The specification shows the stable current during HALT mode.
 - The common condition for I_{DD3}:
 - I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
 - The STOP instruction is executed by the program in the code flash during MAIN RUN operation.
 - The spec shows the stable current during STOP mode.
 - The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.
 - The maximum value is that when all peripheral devices are operating. But the A/D converter, LCD circuit, stepper motor circuit, the data flash and the code flash are stopped. The 16-bit wakeup timer operates with f_{LOCO}.
 - Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.
 - f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit
WDT operating current ^{Note 1}	I _{WDT}			0.25	1.0	μA
ADC operating current ^{Note 2}	I _{ADC}	Normal mode	V _{DD} = 5.0 V	1.3	1.7	mA
		Low voltage mode	V _{DD} = 3.0 V	0.5	0.7	mA
LCD operating Current ^{Note 3}	I _{LCD}	f _{LCD} = f _{SUB} , LCD clock = 512 Hz	V _{DD} = 5.0 V	100	140	μA
			V _{DD} = 3.0 V	90	130	μA
ZPD operating current ^{Note 4}	I _{ZPD}	One ZPD operated	V _{DD} = 5.0 V	150	600	μA
			V _{DD} = 3.0 V	100	500	μA
		Four ZPDs operated	V _{DD} = 5.0 V	500	2000	μA
			V _{DD} = 3.0 V	400	1600	μA

- Notes**
1. Current flowing only to the watchdog timer. The maximum specification of I_{DD1}, I_{DD2} and I_{DD3} include I_{WDT}.
 2. Current flowing only to the A/D converter. The current value of the RL78/D1A is the sum of I_{DD} and I_{ADC} when the A/D converter operates.
 3. Current flowing only to the LCD controller/driver circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{LCD} when the LCD controller/driver circuit operates.
 4. Current flowing only to the ZPD circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{ZPD} when the ZPD circuit operates.

3.3 Oscillator characteristics

3.3.1 Main(X1) oscillator characteristics

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Main(X1) clock oscillation frequency	f _x	Ceramic resonator	1.0		20.0	MHz
		Crystal resonator	1.0		20.0	MHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

3.3.2 High speed on chip oscillator characteristics

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
HOCO oscillation frequency	f _{HOCO}	4 MHz mode	3.92	4.00	4.08	MHz
		8 MHz mode	7.84	8.00	8.16	MHz
		16 MHz mode	15.68	16.00	16.32	MHz
		24 MHz mode	23.52	24.00	24.48	MHz
		32 MHz mode	31.36	32.00	32.64	MHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

3.3.3 Low speed on chip oscillator characteristics

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
LOCO oscillation frequency	f _{LOCO}		12.75	15.0	17.25	kHz

3.3.4 Sub(XT1) oscillator characteristics

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Sub(XT1) clock oscillation frequency	f _{XT}	Possible to oscillate	29.0	32.768	35.0	kHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

3.4 DC characteristics

3.4.1 Pin group 1

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}$, $4.0 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = 0 \text{ V}$ (1/2)

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Output current, high ^{Note 1}	I _{OH1}	Per pin			-5.0	mA	
	I _{OH2}	Per pin, P73 or P135 (SG port)			-13.0	mA	
	I _{OHTOTAL}	Total (for duty factors ≤ 70% ^{Note 2})	Group 1L			-40.0	mA
			Group 1R			-40.0	mA
			Group 1C (128-pin, 100-pin)			-30.0	mA
			for 128-pin, 100-pin			-110.0	mA
		for 80-pin, 64-pin, 48-pin			-60.0	mA	
Output current, low	I _{OL1}	Per pin			8.5	mA	
	I _{OL2}	Per pin, P73 or P135 (SG ports)			13.0	mA	
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note 3})	Group 1L			40.0	mA
			Group 1R			35.0	mA
			Group 1C (128-pin, 100-pin)			40.0	mA
			for 128-pin, 100-pin			115.0	mA
		for 80-pin, 64-pin, 48-pin			60.0	mA	

- Notes**
- When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OH} = -30.0 \text{ mA}$

Total output current of pins = $(-30.0 \times 0.7)/(80 \times 0.01) \approx -26.2 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OL} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OL} = 40.0 \text{ mA}$

Total output current of pins = $(40.0 \times 0.7)/(80 \times 0.01) = 35.0 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq \text{EV}_{\text{DD}0} = \text{EV}_{\text{DD}1} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS}0} = \text{EV}_{\text{SS}1} = 0 \text{ V (2/2)}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high ^{Note 2}	V _{IH1}	Schmitt3 mode	0.8EV _{DD}		EV _{DD}	V
	V _{IH2}	Schmitt1 mode ^{Note 3}	0.65EV _{DD}		EV _{DD}	V
Input voltage, low ^{Note 2}	V _{IL1}	Schmitt3 mode	0		0.5EV _{DD}	V
	V _{IL2}	Schmitt1 mode ^{Note 3}	0		0.35EV _{DD}	V
Input hysteresis width ^{Note 2, 4}	V _{IHYS1}	Schmitt3 mode	0.1	0.19	0.29	V
	V _{IHYS2}	Schmitt1 mode ^{Note 3}	0.15	0.59	0.84	V
Output voltage, high ^{Note 1}	V _{OH1}	I _{OH} = -5.0 mA	EV _{DD} -1.0		EV _{DD}	V
		I _{OH} = -3.0 mA up to 6 pins	EV _{DD} -0.5		EV _{DD}	V
	V _{OH2}	I _{OH} = -13.0 mA, P73 or P135 (SG port)	EV _{DD} -0.7		EV _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 8.5 mA	0		0.7	V
		I _{OL} = 3.0 mA up to 6 pins	0		0.5	V
	V _{OL2}	I _{OL} = 13.0 mA, P73 or P135 (SG port)	0		0.7	V
Input leakage current, high	I _{LIH1}	V _I = EV _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = EV _{SS}			-1	μA
On chip pull-up resistance ^{Note 5}	R _U	V _I = EV _{SS}	10	20	100	kΩ
On chip pull-down resistance ^{Note 6}	R _D	V _I = EV _{DD}	100			kΩ

- Notes**
1. When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 2. Except P130 because it is output only port.
 3. P01, P10, P11, P17, P31, P40, P50 to P52, P55 to P57, P61, P63, P70, P110 to P117, P135 only.
 4. This value is defined by evaluation result.
 5. Except P130 and P137. Pull-up resistance is connected by software when pin is set to input mode.
 6. LCD segment shared pins only. Pull-down resistance is connected during reset.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}$, $2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq 4.0 \text{ V}$, $EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS} = 0 \text{ V}$ (1/2)

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Output current, high ^{Note 1}	IOH1	Per pin			-1.0	mA	
	IOH2	Per pin, P73 or P135 (SG port)			-7.5	mA	
	IOHTOTAL	Total (for duty factors $\leq 70\%$ ^{Note 2})	Group 1L			-15.0	mA
			Group 1R			-30.0	mA
			Group 1C (128-pin, 100-pin)			-7.0	mA
			for 128-pin, 100-pin			-52.0	mA
		for 80-pin, 64-pin, 48-pin			-33.0	mA	
Output current, low	IO_L1	Per pin			1.5	mA	
	IO_L2	Per pin, P73 or P135 (SG ports)			7.0	mA	
	IO_LTOTAL	Total (for duty factors $\leq 70\%$ ^{Note 3})	Group 1L			18.0	mA
			Group 1R			30.0	mA
			Group 1C (128-pin, 100-pin)			10.0	mA
			for 128-pin, 100-pin			58.0	mA
		for 80-pin, 64-pin, 48-pin			35.0	mA	

Notes 1. When P60 or P61 is set to Nch open drain mode, it does not drive high level output.

- 2.** These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OH} = -7.0 \text{ mA}$

Total output current of pins = $(-7.0 \times 0.7)/(80 \times 0.01) \approx -6.1 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

- 3.** These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins $(I_{OL} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OL} = 10.0 \text{ mA}$

Total output current of pins = $(10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}$, $2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq 4.0 \text{ V}$, $EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS} = 0 \text{ V}$ (2/2)

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high ^{Note 2}	V _{IH1}	Schmitt3 mode	0.8EV _{DD}		EV _{DD}	V
	V _{IH2}	Schmitt1 mode ^{Note 3}	0.7EV _{DD}		EV _{DD}	V
Input voltage, low ^{Note 2}	V _{IL1}	Schmitt3 mode	0		0.4EV _{DD}	V
	V _{IL2}	Schmitt1 mode ^{Note 3}	0		0.3EV _{DD}	V
Input hysteresis width ^{Note 2, 4}	V _{IHYS1}	Schmitt3 mode	0.05		0.21	V
	V _{IHYS2}	Schmitt1 mode ^{Note 3}	0.08		0.53	V
Output voltage, high ^{Note 1}	V _{OH1}	I _{OH} = -1.0 mA	EV _{DD} -0.5		EV _{DD}	V
	V _{OH2}	I _{OH} = -7.5 mA, P73 or P135 (SG port)	EV _{DD} -0.7		EV _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 1.5 mA	0		0.5	V
	V _{OL2}	I _{OL} = 7.0 mA, P73 or P135 (SG port)	0		0.7	V
Input leakage current, high	I _{LIH1}	V _I = EV _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = EV _{SS}			-1	μA
On chip pull-up resistance ^{Note 5}	R _U	V _I = EV _{SS}	10	20	100	kΩ
On chip pull-down resistance ^{Note 6}	R _D	V _I = EV _{DD}	100			kΩ

- Notes**
1. When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 2. Except P130 because it is output only port.
 3. P01, P10, P11, P17, P31, P40, P50 to P52, P55 to P57, P61, P63, P70, P110 to P117, P135 only.
 4. This value is defined by evaluation result.
 5. Except P130 and P137. Pull-up resistance is connected by software when pin is set to input mode.
 6. LCD segment shared pins only. Pull-down resistance is connected during reset.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

3.4.2 Pin group 2 (ANI pins)

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Output current, high	I _{OH1}	Per pin			-0.1	mA
	I _{OHTOTAL}	Total			-0.8	mA
Output current, low	I _{OL1}	Per pin			0.4	mA
	I _{OLTOTAL}	Total			3.2	mA
Input voltage, high	V _{IH1}		0.8V _{DD}		V _{DD}	V
Input voltage, low	V _{IL1}		0		0.5V _{DD}	V
Input hysteresis width Note	V _{IHYS1}		0.1	0.19	0.29	V
Output voltage, high	V _{OH1}	I _{OH} = -0.1 mA	V _{DD} -0.5		V _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 0.4 mA	0		0.4	V
Input leakage current, high	I _{LIH1}	V _I = V _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = V _{SS}			-1	μA

Note This specification is guaranteed by design. It is not tested when shipment.

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 4.0 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Output current, high	I _{OH1}	Per pin			-0.1	mA
	I _{OHTOTAL}	Total			-0.8	mA
Output current, low	I _{OL1}	Per pin			0.4	mA
	I _{OLTOTAL}	Total			3.2	mA
Input voltage, high	V _{IH1}		0.8V _{DD}		V _{DD}	V
Input voltage, low	V _{IL1}		0		0.4V _{DD}	V
Input hysteresis width Note	V _{IHYS1}		0.05		0.21	V
Output voltage, high	V _{OH1}	I _{OH} = -0.1 mA	V _{DD} -0.5		V _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 0.4 mA	0		0.4	V
Input leakage current, high	I _{LIH1}	V _I = V _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = V _{SS}			-1	μA

Note This specification is guaranteed by design. It is not tested when shipment.

3.4.3 Pin group 3 (SMC pins)

$T_A = -40$ to $+85$ °C, $4.0\text{ V} \leq V_{DD} = \text{SMV}_{DD0} = \text{SMV}_{DD1} \leq 5.5\text{ V}$, $V_{SS} = \text{SMV}_{SS0} = \text{SMV}_{SS1} = 0\text{ V}$ (1/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, high	I _{OH1}	Per pin		T _A = -40 °C			-52	mA		
				T _A = +25 °C			-39	mA		
				T _A = +85 °C			-32	mA		
	I _{OHTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C			-118	mA
						T _A = +25 °C			-118	mA
						T _A = +85 °C			-96	mA
				Group 3B		T _A = -40 °C			-118	mA
						T _A = +25 °C			-118	mA
						T _A = +85 °C			-96	mA
				Group 3C	128-pin, 100-pin	T _A = -40 °C			-118	mA
						T _A = +25 °C			-118	mA
					80-pin	T _A = +85 °C			-96	mA
						T _A = -40 °C			-118	mA
				64-pin 48-pin	T _A = +25 °C			-118	mA	
					T _A = +85 °C			-96	mA	
				Group 3D (128-pin, 100-pin, 80-pin)		T _A = -40 °C			-118	mA
						T _A = +25 °C			-118	mA
T _A = +85 °C			-96			mA				
Group 3E (64-pin, 48-pin)		T _A = -40 °C			-148	mA				
		T _A = +25 °C			-118	mA				
		T _A = +85 °C			-96	mA				

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.

The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OH} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OH} = -118.0 mA

Total output current of pins = (-118.0 × 0.7)/(80 × 0.01) ≈ -103.2 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40$ to $+85$ °C, $4.0\text{ V} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 5.5\text{ V}$, $V_{SS} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$ (2/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, low	I _{OL1}	Per pin		T _A = -40 °C		52	mA			
				T _A = +25 °C		39	mA			
				T _A = +85 °C		32	mA			
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		118	mA	
						T _A = +25 °C		118	mA	
						T _A = +85 °C		96	mA	
				Group 3B		T _A = -40 °C		118	mA	
						T _A = +25 °C		118	mA	
						T _A = +85 °C		96	mA	
				Group 3C	128-pin, 100-pin 80-pin 64-pin 48-pin		T _A = -40 °C		118	mA
							T _A = +25 °C		118	mA
							T _A = +85 °C		96	mA
							T _A = -40 °C		118	mA
							T _A = +25 °C		118	mA
							T _A = +85 °C		96	mA
Group 3D (128-pin, 100-pin, 80-pin)		T _A = -40 °C		118	mA					
		T _A = +25 °C		118	mA					
		T _A = +85 °C		96	mA					
Group 3E (64-pin, 48-pin)		T _A = -40 °C		148	mA					
		T _A = +25 °C		118	mA					
		T _A = +85 °C		96	mA					

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.
 The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OL} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OL} = 118.0 mA
 Total output current of pins = (118.0 × 0.7)/(80 × 0.01) ≈ 103.2 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 5.5 \text{ V}, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V (3/3)}$

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit
Input voltage, high	V_{IH1}			$0.8SMV_{DD}$		SMV_{DD}	V
Input voltage, low	V_{IL1}			0		$0.5SMV_{DD}$	V
Input hysteresis width Note 1	V_{IHYS1}			0.1	0.19	0.29	V
Output voltage, high	V_{OH1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OH} = -52 \text{ mA}$	SMV_{DD} - 0.5		SMV_{DD}	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OH} = -39 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OH} = -32 \text{ mA}$				
Output voltage, low	V_{OL1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OL} = 52 \text{ mA}$	0		0.5	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OL} = 39 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OL} = 32 \text{ mA}$				
Output voltage deviation Note 2	V_{DEV}			0		50	mV
Input leakage current, high	I_{LIH1}	$V_i = SMV_{DD}$				1	μA
Input leakage current, low	I_{LIL1}	$V_i = SMV_{SS}$				-1	μA
On chip pull-up resistance Note 3	R_U	$V_i = SMV_{SS}$		10	20	100	$\text{k}\Omega$
On chip pull-down resistance Note 4	R_D	$V_i = SMV_{DD}$		100			$\text{k}\Omega$

- Notes**
- This specification is guaranteed by design. It is not tested when shipment.
 - Output voltage deviation defines the difference of the outputs levels of the same stepper motor.
 $V_{DEV} = \max(|V_{OHx} - V_{OHy}|, |V_{OLx} - V_{OLy}|) @ I_{OHx} = I_{OHy}, I_{OLx} = I_{OLy}$.
 X and y denote any combination of two pins of the following pin groups: (P80-P83, P84-P87, P90-P93, P94-P97)
 - Pull-up resistance is connected by software when pin is set to input mode.
 - LCD segment shared pins only. Pull-down resistance is connected during reset.

$T_A = -40$ to $+85$ °C, $2.7\text{ V} \leq V_{DD} = \text{SMV}_{DD0} = \text{SMV}_{DD1} \leq 4.0\text{ V}$, $V_{SS} = \text{SMV}_{SS0} = \text{SMV}_{SS1} = 0\text{ V}$ (1/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, high	I _{OH1}	Per pin		T _A = -40 °C		-30	mA			
				T _A = +25 °C		-25	mA			
				T _A = +85 °C		-23	mA			
	I _{OH} TOTAL	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		-90	mA	
						T _A = +25 °C		-75	mA	
						T _A = +85 °C		-69	mA	
				Group 3B		T _A = -40 °C		-90	mA	
						T _A = +25 °C		-75	mA	
						T _A = +85 °C		-69	mA	
				Group 3C	128-pin, 100-pin 80-pin 64-pin 48-pin		T _A = -40 °C		-90	mA
							T _A = +25 °C		-75	mA
							T _A = +85 °C		-69	mA
							T _A = -40 °C		-90	mA
							T _A = +25 °C		-75	mA
							T _A = +85 °C		-69	mA
				Group 3D (128-pin, 100-pin, 80-pin)		T _A = -40 °C		-90	mA	
						T _A = +25 °C		-75	mA	
						T _A = +85 °C		-69	mA	
Group 3E (64-pin, 48-pin)		T _A = -40 °C		-90	mA					
		T _A = +25 °C		-75	mA					
		T _A = +85 °C		-69	mA					

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.
 The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins $(I_{OH} \times 0.7)/(n \times 0.01)$
 <Example> Where $n = 80\%$ and $I_{OH} = -75.0\text{ mA}$
 Total output current of pins = $(-75.0 \times 0.7)/(80 \times 0.01) \approx -65.6\text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40$ to $+85$ °C, $2.7\text{ V} \leq V_{DD} = \text{SMV}_{DD0} = \text{SMV}_{DD1} \leq 4.0\text{ V}$, $V_{SS} = \text{SMV}_{SS0} = \text{SMV}_{SS1} = 0\text{ V}$ (2/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, low	I _{OL1}	Per pin		T _A = -40 °C		30	mA			
				T _A = +25 °C		23	mA			
				T _A = +85 °C		20	mA			
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		90	mA	
						T _A = +25 °C		69	mA	
						T _A = +85 °C		60	mA	
				Group 3B		T _A = -40 °C		90	mA	
						T _A = +25 °C		69	mA	
						T _A = +85 °C		60	mA	
				Group 3C	128-pin, 100-pin 80-pin 64-pin 48-pin		T _A = -40 °C		90	mA
							T _A = +25 °C		69	mA
							T _A = +85 °C		60	mA
							T _A = -40 °C		90	mA
							T _A = +25 °C		69	mA
							T _A = +85 °C		60	mA
Group 3D (128-pin, 100-pin, 80-pin)		T _A = -40 °C		90	mA					
		T _A = +25 °C		69	mA					
		T _A = +85 °C		60	mA					
Group 3E (64-pin, 48-pin)		T _A = -40 °C		90	mA					
		T _A = +25 °C		69	mA					
		T _A = +85 °C		60	mA					

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.
 The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins $(I_{OL} \times 0.7)/(n \times 0.01)$
 <Example> Where n = 80% and I_{OL} = 69.0 mA
 Total output current of pins = $(69.0 \times 0.7)/(80 \times 0.01) \approx 60.3$ mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 4.0 \text{ V}, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V (3/3)}$

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit
Input voltage, high	V_{IH1}			$0.8SMV_{DD}$		SMV_{DD}	V
Input voltage, low	V_{IL1}			0		$0.4SMV_{DD}$	V
Input hysteresis width Note 1	V_{IHYS1}			0.05		0.21	V
Output voltage, high	V_{OH1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OH} = -30 \text{ mA}$	SMV_{DD} - 0.5		SMV_{DD}	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OH} = -25 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OH} = -23 \text{ mA}$				
Output voltage, low	V_{OL1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OL} = 30 \text{ mA}$	0		0.5	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OL} = 23 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OL} = 20 \text{ mA}$				
Output voltage deviation Note 2	V_{DEV}			0		50	mV
Input leakage current, high	I_{LIH1}	$V_I = SMV_{DD}$				1	μA
Input leakage current, low	I_{LIL1}	$V_I = SMV_{SS}$				-1	μA
On chip pull-up resistance Note 3	R_U	$V_I = SMV_{SS}$		10	20	100	$\text{k}\Omega$
On chip pull-down resistance Note 4	R_D	$V_I = SMV_{DD}$		100			$\text{k}\Omega$

- Notes**
- This specification is guaranteed by design. It is not tested when shipment.
 - Output voltage deviation defines the difference of the outputs levels of the same stepper motor.
 $V_{DEV} = \max(|V_{OHx} - V_{OHy}|, |V_{OLx} - V_{OLy}|) @ I_{OHx} = I_{OHy}, I_{OLx} = I_{OLy}$.
 X and y denote any combination of two pins of the following pin groups: (P80-P83, P84-P87, P90-P93, P94-P97)
 - Pull-up resistance is connected by software when pin is set to input mode.
 - LCD segment shared pins only. Pull-down resistance is connected during reset.

3.4.4 Pin group 4 (OSC, reset and P137 pins)

T_A = -40 to +85 °C, 4.0 V ≤ V_{DD} ≤ 5.5 V, V_{SS} = 0 V

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Input voltage, high	V _{IH1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.8V _{DD}		V _{DD}	V	
	V _{IH2}	$\overline{\text{RESET}}$	0.65V _{DD}		V _{DD}	V	
	V _{IH3}	P137	0.8V _{DD}		V _{DD}	V	
Input voltage, low	V _{IL1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0		0.2V _{DD}	V	
	V _{IL2}	$\overline{\text{RESET}}$	0		0.35V _{DD}	V	
	V _{IL3}	P137	0		0.5V _{DD}	V	
Input hysteresis width ^{Note 2}	V _{IHYS1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.1	0.7		V	
	V _{IHYS2}	$\overline{\text{RESET}}$	0.15	0.59	0.84	V	
Input leakage current, high	I _{LIH1}	P121, P122, P123, P124 V _I = V _{DD}	Port			1	μA
			EXCLK ^{Note 1}			1	μA
			OSC			10	μA
	I _{LIH2}	$\overline{\text{RESET}}$, V _I = V _{DD}				1	μA
	I _{LIH3}	P137, V _I = V _{DD}				1	μA
Input leakage current, low	I _{LIL1}	P121, P122, P123, P124 V _I = V _{SS}	Port			-1	μA
			EXCLK ^{Note 1}			-1	μA
			OSC			-10	μA
	I _{LIL2}	$\overline{\text{RESET}}$, V _I = V _{SS}				-1	μA
	I _{LIL3}	P137, V _I = V _{SS}				-1	μA

Notes 1. P122(EXCLK) only.

2. This specification is guaranteed by design. It is not tested when shipment.

T_A = -40 to +85 °C, 2.7 V ≤ V_{DD} ≤ 4.0 V, V_{SS} = 0 V

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high	V _{IH1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.8V _{DD}		V _{DD}	V
	V _{IH2}	$\overline{\text{RESET}}$	0.7V _{DD}		V _{DD}	V
	V _{IH3}	P137	0.8V _{DD}		V _{DD}	V
Input voltage, low	V _{IL1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0		0.2V _{DD}	V
	V _{IL2}	$\overline{\text{RESET}}$	0		0.3V _{DD}	V
	V _{IL3}	P137	0		0.4V _{DD}	V
Input hysteresis width ^{Note 2}	V _{IHYS1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.08			V
	V _{IHYS2}	$\overline{\text{RESET}}$	0.08			V
Input leakage current, high	I _{LIH1}	P121, P122, P123, P124 V _I = V _{DD}	Port		1	μA
			EXCLK ^{Note 1}		1	μA
			OSC		10	μA
	I _{LIH2}	$\overline{\text{RESET}}$, V _I = V _{DD}			1	μA
	I _{LIH3}	P137, V _I = V _{DD}			1	μA
Input leakage current, low	I _{LIL1}	P121, P122, P123, P124 V _I = V _{SS}	Port		-1	μA
			EXCLK ^{Note 1}		-1	μA
			OSC		-10	μA
	I _{LIL2}	$\overline{\text{RESET}}$, V _I = V _{SS}			-1	μA
	I _{LIL3}	P137, V _I = V _{SS}			-1	μA

Notes 1. P122(EXCLK) only.

2. This specification is guaranteed by design. It is not tested when shipment.

3.5 AC characteristics

3.5.1 Basic operation

$T_A = -40$ to $+85$ °C,

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Parameter	Symbols	Conditions			Min.	Typ.	Max.	Unit	
Instruction cycle (minimum instruction execution time)	t_{CY}	Main system clock operation (Including PLL)	High speed main run		0.03125 Note 1		1	μs	
		Sub system clock operation	SDIV = 0		1/ f_{XT} (Typ. 30.5)			μs	
External main system clock frequency	f_{EX}	Square wave input to EXCLK			2		20	MHz	
External main system clock (square wave) input high/low level width	t_{EXH}	Square wave input to EXCLK			24			ns	
	t_{EXL}								
Timer input high/low level width	t_{TIH} t_{TIL}	TI00 to TI07, TI10 to TI17, TI20 to TI27			1/ $f_{MCK}+10$ Note 2			ns	
Port output frequency	f_{GPO}	P80 to P87, P90 to P97	C = 30 pF	$4.0\text{ V} \leq SMV_{DD}$			2	MHz	
		P20 to P27, P150 to P152	C = 30 pF	$4.0\text{ V} \leq V_{DD}$			2	MHz	
		P73,P135	C = 30 pF	$4.0\text{ V} \leq EV_{DD}$			8	MHz	
		Other than the above	C = 30 pF	$4.0\text{ V} \leq EV_{DD}$ $2.7\text{ V} \leq EV_{DD} < 4.0\text{ V}$			16 8	MHz MHz	
External interrupt input high/low level width Note 3	t_{INIH} t_{INIL}	INTP0 to INTP5, INTPLR0, INTPLR1			1			μs	
RESET input low level width Note 3	t_{RSL}	RESET			10			μs	
Analog noise filter rejection pulse width Note 4	t_{WRJ}	INTP0 to INTP5, INTPLR0, INTPLR1, ADTRG			30	50	1000	ns	
ADTRG input high level width	t_{ATH}	Without noise filter	AWC = 0		1/ $f_{CLK}+10$			ns	
			AWC = 1		10			ns	
		With noise filter	AWC = 0		1/ $f_{CLK}+10$ or t_{WRJ} (Note 5)				ns
			AWC = 1		t_{WRJ} (Note 5)				ns

- Notes**
- Value is in case of f_{CLK} is 32.0 MHz. It is also allowed to exceed frequency up to +3%.
 - f_{MCK} shows the frequency value of operation clock for TAU. Usually, f_{MCK} is defined by MHz but this specification is defined by ns. It is not defined by μs , so please be careful.
 - Pulses longer than this value will pass the input filter.
 - Pulses shorter than this value do not pass the input filters.
 - If the value of "1/ $f_{CLK}+10$ [ns]" is less than t_{WRJ} , please use t_{WRJ} value instead of "1/ $f_{CLK}+10$ [ns]".

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 3-1. AC Timing Test Points

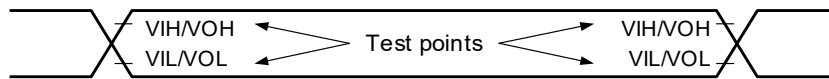


Figure 3-2. External Main System Clock Timing

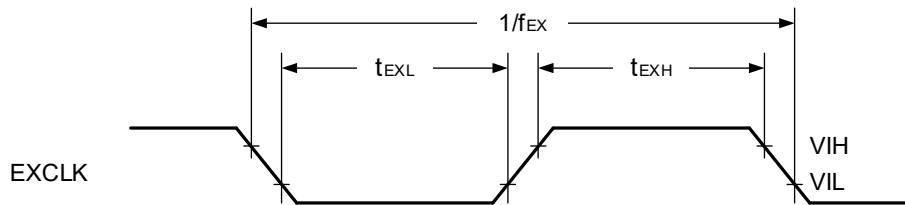


Figure 3-3. TI Timing

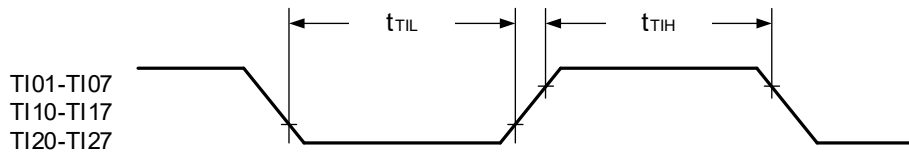


Figure 3-4. Interrupt Request Input Timing

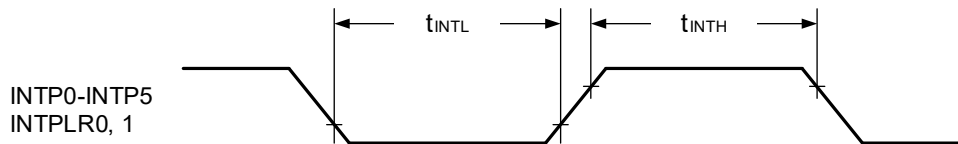
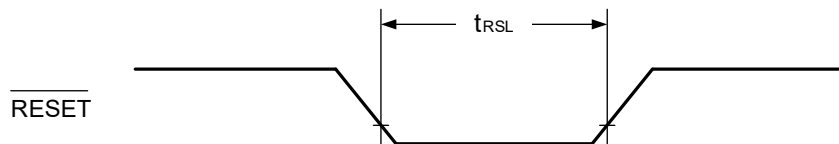


Figure 3-5. RESET Input Timing



3.5.2 Stepper motor controller/driver

T_A = -40 to +85 °C,2.7 V ≤ SMV_{DD0} = SMV_{DD1} = V_{DD} ≤ 5.5 V, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 V

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
Meter Controller/Driver input frequency	f _{MC} ^{Note 1}				32	MHz	
PWM output rise time	t _R	10%-90% ^{Note 2}	4.0 V ≤ SMV _{DD} ≤ 5.5 V	15	60	100	ns
			2.7 V ≤ SMV _{DD} ≤ 4.0 V	20		500	ns
PWM output fall time	t _F	10%-90% ^{Note 2}	4.0 V ≤ SMV _{DD} ≤ 5.5 V	15	60	100	ns
			2.7 V ≤ SMV _{DD} ≤ 4.0 V	20		500	ns
Peak Cross Current ^{Note 3}	I _{CROSS}				50	ns	
Output Pulse Width ^{Note 4}	t _{MO}	4.0 V ≤ SMV _{DD} ≤ 5.5 V	250			ns	
		2.7 V ≤ SMV _{DD} ≤ 5.5 V	5000			ns	
Output Pulse Length Deviation ^{Note 5}	t _{SMDEV}	4.0 V ≤ SMV _{DD} ≤ 5.5 V	-65	-12	+10	ns	
		2.7 V ≤ SMV _{DD} ≤ 5.5 V	-100		+400	ns	
Symmetry performance ^{Note 6}	ΔHSP _m _n	I _{OH} = -32 mA ΔHSP _m _n = V _{OH} [(SM _m) _{max} - (SM _m) _{min}]	2.7 V ≤ SMV _{DD} ≤ 5.5 V			50	mV
			4.0 V ≤ SMV _{DD} ≤ 5.5 V			50	mV
	ΔHSP _m _n	I _{OL} = 32 mA ΔHSP _m _n = V _{OL} [(SM _m) _{max} - (SM _m) _{min}]	2.7 V ≤ SMV _{DD} ≤ 5.5 V			100	mV

- Notes**
1. Source clock of the free-running counter.
 2. t_R, t_F is not tested in production, specified by design.
 3. The slew rate control generates a cross current in the output stage to control the energy of the external inductive load. The cross current flows only during the output transition time t_R, t_F. It flows in addition to the output current. The cross current is not tested, but derived from simulation.
 4. The output buffer can not generate high or low pulses shorter than this time, because of its slew rate control system. This value is not tested, but derived from simulation.
 5. The slew rate control function causes a deviation of output pulse time compared to the ideal selected output pulse setting. This value is not tested, but derived from simulation.
 6. Indicates the dispersion of 16 PWM output voltages. (4 buffers' output voltage differences in the state of I_{OH}(I_{OL}) at the same time.) Not tested in production, specified by design.

Remark m = 1 to 4, n = 1 to 4

3.5.3 Sound generator

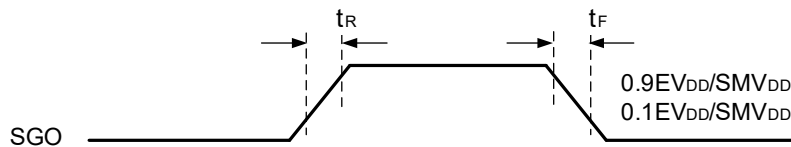
$T_A = -40$ to $+85$ °C,

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions		MIN.	TYP.	MAX.	Unit
Sound generator input frequency	f_{SG}					32	MHz
SGO output rise time	t_R	C = 100 pF	P73, P135			200	ns
			P93			500	ns
SGO output fall time	t_F	C = 100 pF	P73, P135			200	ns
			P93			500	ns

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Sound Generator Output Timing



3.5.4 Serial interface: CSI operation

<Master mode>

TA = -40 to +85 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
SCK cycle time	tkCY1	4.0 ≤ V _{DD}	125	tkCY1 ≥ 4/f _{CLK} ^{Note}	ns
		V _{DD} < 4.0 V	250		ns
SCK high/low level width	t _{KH1}	4.0 ≤ V _{DD}	tkCY1/2-12		ns
	t _{KL1}	V _{DD} < 4.0 V	tkCY1/2-18		ns
SI set up time	t _{SIK1}	4.0 ≤ V _{DD}	44		ns
		V _{DD} < 4.0 V	55		ns
SI hold time	t _{KS1}		19		ns
SO output delay time	t _{KSO1}	C = 30 pF		25	ns

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

<Slave mode>

TA = -40 to +85 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

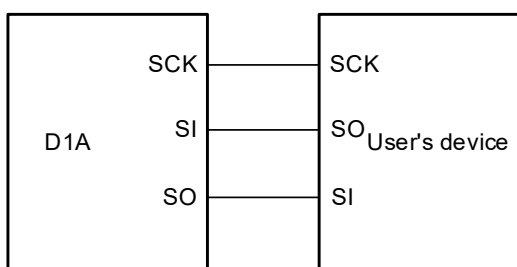
Items	Symbols	Conditions	Min.	Max.	Unit
SCK cycle time	tkCY2	4.0 ≤ EV _{DD}	20 MHz < f _{MCK}	8/f _{MCK} ^{Note}	ns
			f _{MCK} ≤ 20 MHz	6/f _{MCK} ^{Note}	ns
		EV _{DD} < 4.0 V	16 MHz < f _{MCK}	8/f _{MCK} ^{Note}	ns
			f _{MCK} ≤ 16 MHz	6/f _{MCK} ^{Note}	ns
SCK high/low level width	t _{KH2} t _{KL2}		tkCY2/2-8		ns
SI set up time	t _{SIK2}	2.7 ≤ EV _{DD}	1/f _{MCK} + 20		ns
SI hold time	t _{KS2}		1/f _{MCK} + 31		ns
SO output delay time	t _{KSO2}	C = 30 pF	4.0 ≤ EV _{DD}		2/f _{MCK} + 44
			EV _{DD} < 4.0 V		2/f _{MCK} + 57

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 3-6. CSI mode connection diagram

<master>



<slave>

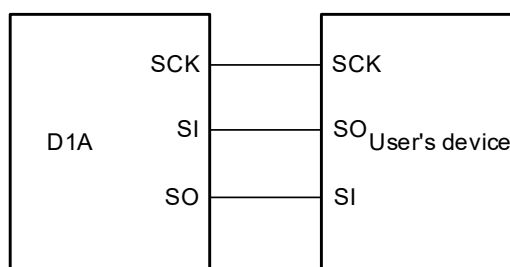


Figure 3-7. CSI mode serial transfer timing (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)

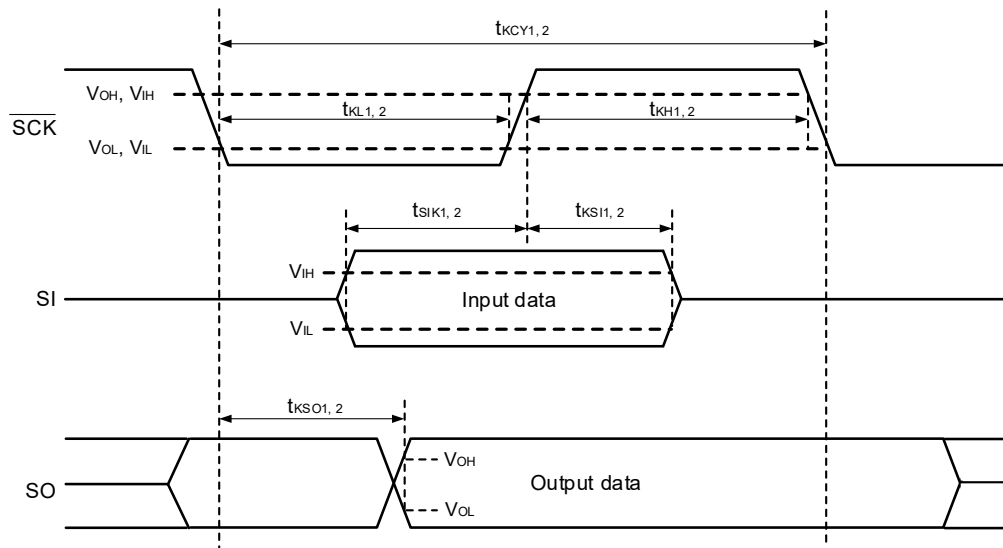
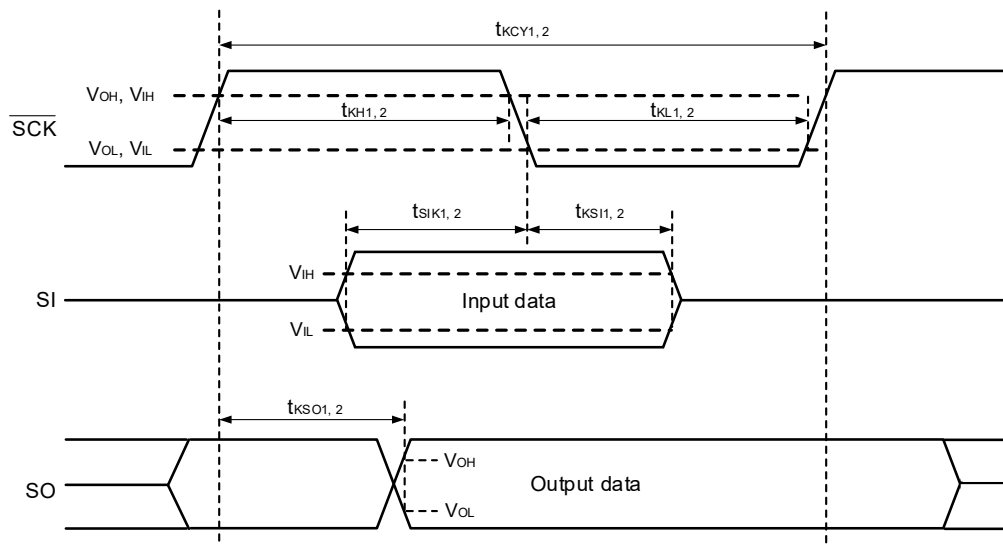


Figure 3-8. CSI mode serial transfer timing (When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)



3.5.5 Serial interface: UART operation (128-pin only)

$T_A = -40$ to $+85$ °C

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = 0\text{ V}$

Item	Symbol	Conditions	Min.	Max.	Unit
Transfer rate	T			$f_{MCK}/6$ ^{Note}	bps
		Theoretical value of the maximum transfer rate $f_{CLK} = 32\text{ MHz}$, $f_{MCK} = f_{CLK}$		5.3	Mbps

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 3-9 UART connection diagram

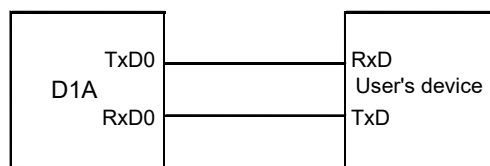
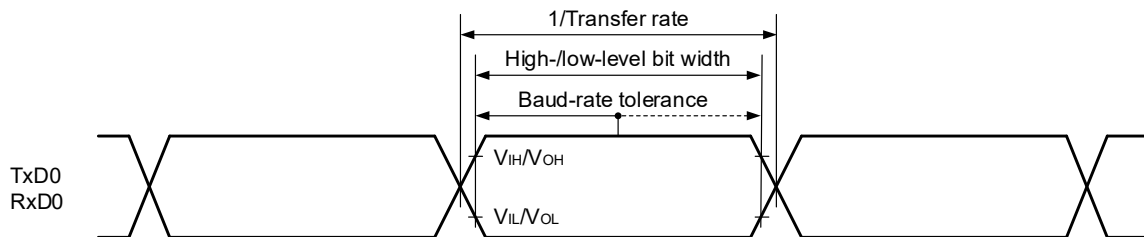


Figure 3-10. UART mode bit width (reference)



3.5.6 Serial interface: simplified I²C operation

T_A = -40 to +85 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
SCL clock frequency	f _{SCL}	R _b = 3 kΩ, C _b = 100 pF		400	kHz
Hold time during SCL = "L"	t _{LOW}	R _b = 3 kΩ, C _b = 100 pF	1150		ns
Hold time during SCL = "H"	t _{HIGH}	R _b = 3kΩ, C _b = 100 pF	1150		ns
Data set up time (reception)	t _{SU:DAT}	R _b = 3 kΩ, C _b = 100 pF	1/f _{MCK} +85		ns
Data hold time (transmission)	t _{HD:DAT}	R _b = 3 kΩ, C _b = 100 pF	0	305	ns

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 3-11 simplified I²C connection diagram

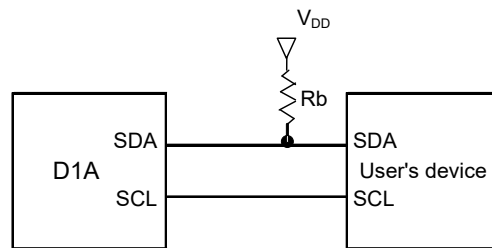
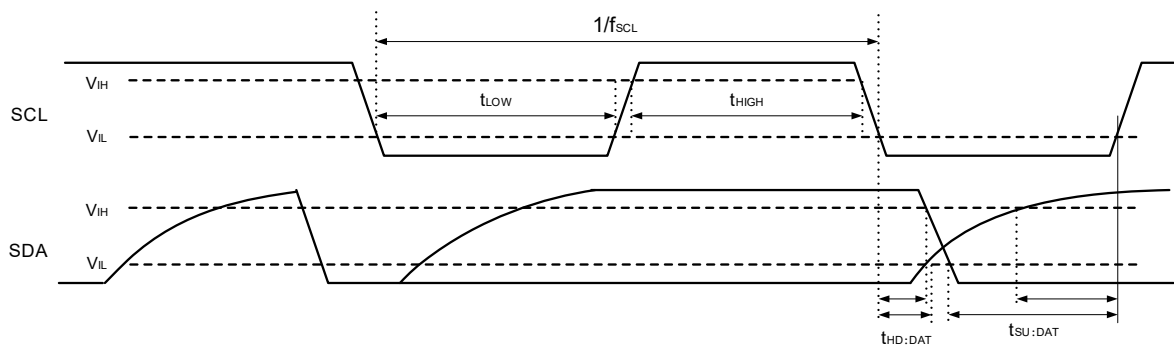


Figure 3-12. Simplified I²C mode serial transfer timing



3.5.7 Serial interface: LIN-UART(UARTF) operation

TA = -40 to +85 °C

2.7 V ≤ EVDD0 = EVDD1 ≤ VDD ≤ 5.5 V, VSS = EVSS0 = EVSS1 = 0 V

Item	Symbols	Conditions	Min.	Max.	Unit
Transfer rate	T			1.0	Mbps

Caution Different voltage between EVDD and VDD is allowed only when LCDM register is initial value.

3.5.8 Serial interface: CAN operation

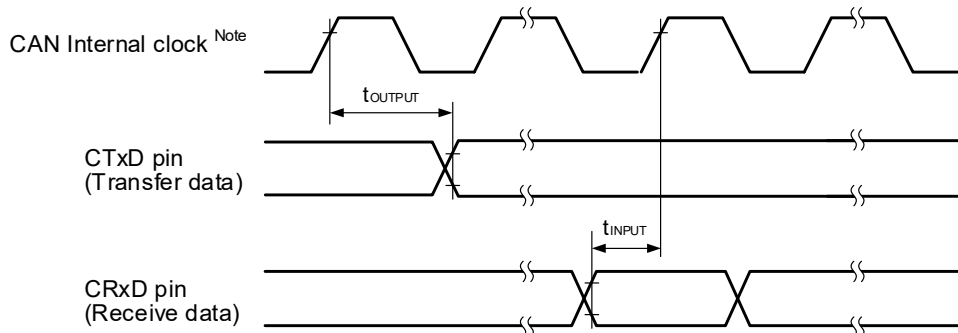
TA = -40 to +85 °C,

2.7 V ≤ EVDD0 = EVDD1 ≤ VDD ≤ 5.5 V, VSS = EVSS0 = EVSS1 = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
Transfer rate	T			1.0	Mbps
Internal delay time	t _{NODE}			100	ns
CRxD minimum pulse width for wake up	t _{CRXW}	Necessary width to detect wakeup signal	200		ns

Caution Different voltage between EVDD and VDD is allowed only when LCDM register is initial value.

Figure 3-13. Internal delay time of CAN



Internal delay time (t_{NODE}) = Internal Transfer Delay (t_{output}) + Internal Receive Delay (t_{input})

Note CAN Internal clock (f_{CAN}): CAN baud rate clock

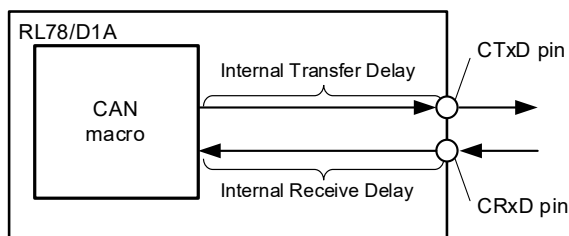


Image figure of Internal delay

3.6 LCD Bus Interface characteristics (128-pin products only)

$T_A = -40$ to $+85$ °C, $2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions	MIN.	MAX.	Unit
Transfer frequency	F			8	MHz
CycleTime	t _{CYC}		LBCYC x T		ns
Control low pulse width	t _{CL}		(LBWST + 1)T - 1		ns
Enable active pulse width	t _{ELH}		(LBWST + 1)T - 5		ns
Control setup time	t _{RWS}		0.5T _S - 8		ns
Control hold time	t _{RWH}		0.5T - 3		ns
Data output setup time	t _{DOS}		0.5T _S - 6	0.5T _S + 17	ns
Data output hold time	t _{DOH}		{LBCYC - (LBWST + 1.5)} T - 27		ns
Data input setup time	t _{DIS}		50		ns
Data input hold time	t _{DIH}		0		ns
Output disable time	t _{OD}		0.5T - 14		ns

Remarks 1. $T = (1/f_{CLK}) \times n$ (n: LCD Bus Interface clock n divider setting)

2. $T_S = (1/f_{CLK}) \times N$ (N: LCD Bus Interface no clock divider N = 1, n divider N = n - 1)

3. $F = 1/t_{CYC}$

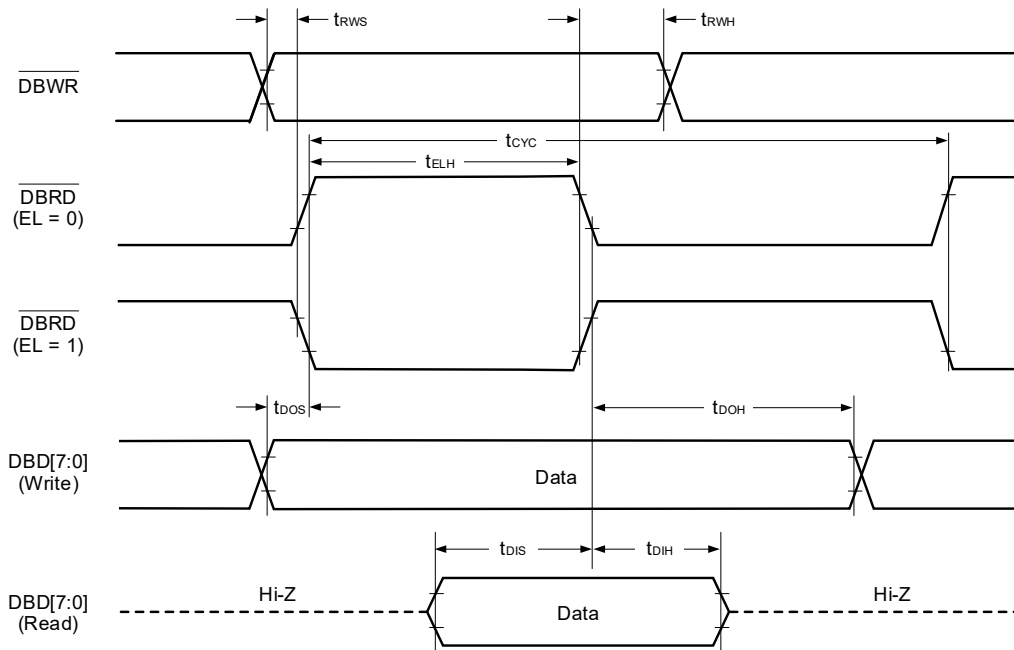
4. When $EV_{DDx} = SMV_{DDx} \leq V_{DD}$, LCD controller/driver related registers must be initial value (LCDON = 0, SCOC = 0, MDSET1 - 0 = 00, LCDPFx = 0).

5. The above table shows the timing of LCD bus interface with Schmitt1 input characteristic.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 3-14. LCD Bus Interface AC timing (1/2)

(a) LCDB mod68 mode timing



(b) mode68 turnaround timing

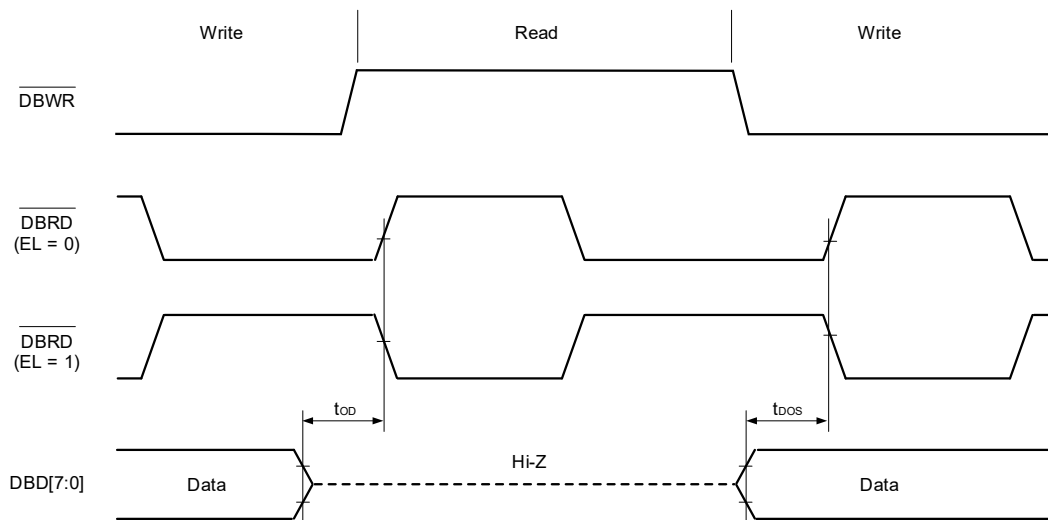
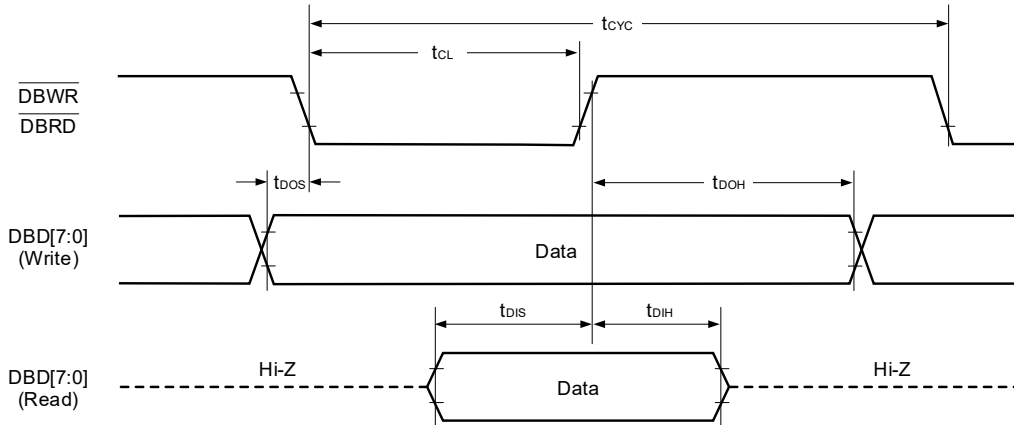
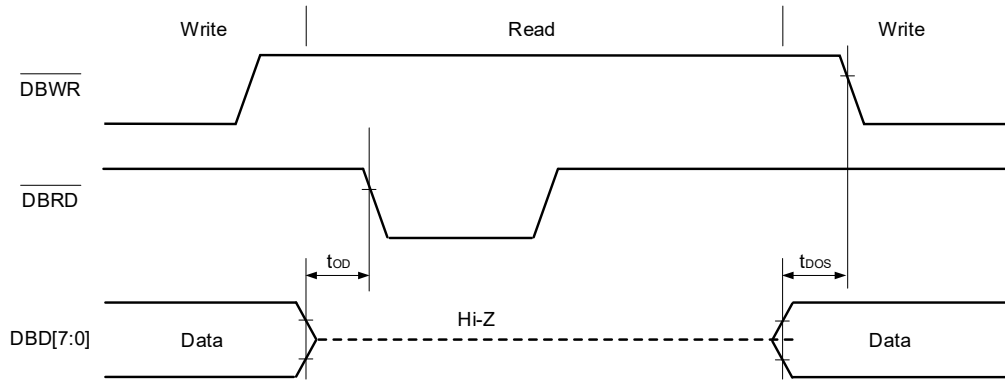


Figure 3-14. LCD Bus Interface AC timing (2/2)

(c) LCDB mod80 mode timing



(d) Mode80 turnaround timing



$T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}$, $3.2 \text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
LCD division resistance ^{Note 1}	R _{LCD}				3	kΩ
LCD Segment output voltage (unloaded)	V _{ODS}	I _o = ±1 μA	V _{LCDn} -0.05	V _{LCDn} ^{Note 2}	V _{LCDn} +0.05	V
LCD Common output voltage (unloaded)	V _{ODC}	I _o = ±1 μA	V _{LCDn} -0.05	V _{LCDn}	V _{LCDn} +0.05	V
LCD Segment Output Voltage (loaded)	V _{ODSL0}	I _o = ±10 μA, all segment pins at same time	V _{LCD0} -0.6	V _{LCD0}	V _{LCD0} +0.6	V
	V _{ODSL1}	I _o = ±10 μA, all segment pins at same time	V _{LCD1} -0.6	V _{LCD1}	V _{LCD1} +0.6	V
	V _{ODSL2}	I _o = ±10 μA, all segment pins at same time	V _{LCD2} -0.6	V _{LCD2}	V _{LCD2} +0.6	V
	V _{ODSL3}	I _o = ±10 μA, all segment pins at same time	V _{LCD3} -0.6	V _{LCD3}	V _{LCD3} +0.6	V
LCD Common Output Voltage (loaded)	V _{ODCL0}	I _o = ±40 μA, single pin	V _{LCD0} -0.2	V _{LCD0}	V _{LCD0} +0.2	V
	V _{ODCL1}	I _o = ±40 μA, single pin	V _{LCD1} -0.2	V _{LCD1}	V _{LCD1} +0.2	V
	V _{ODCL2}	I _o = ±40 μA, single pin	V _{LCD2} -0.2	V _{LCD2}	V _{LCD2} +0.2	V
	V _{ODCL3}	I _o = ±40 μA, single pin	V _{LCD3} -0.2	V _{LCD3}	V _{LCD3} +0.2	V
LCD split voltage drive capability ^{Note 1}	V _{LC0}	I _o = ±530 μA	V _{LCD0} -0.1	V _{LCD0}	V _{LCD0} +0.1	V
	V _{LC1}	I _o = ±530 μA	V _{LCD1} -0.1	V _{LCD1}	V _{LCD1} +0.1	V
	V _{LC2}	I _o = ±530 μA	V _{LCD2} -0.1	V _{LCD2}	V _{LCD2} +0.1	V
	V _{LC3}	I _o = ±530 μA	V _{LCD3} -0.1	V _{LCD3}	V _{LCD3} +0.1	V
LCD output resistance (COM) ^{Note 3}	R _{ODC}				8	kΩ
LCD output resistance (SEG) ^{Note 3}	R _{ODS}				8	kΩ

Notes 1. Only internal connection. The value is design specification.

- 2.** V_{LCDn} (n= 0..3) represents one of the four possible voltage levels at the LCD pins. See table below for reference.

V _{LCDn}	no step-down transforming	step-down transforming
V _{LCD0}	V _{DD}	3/5 V _{DD}
V _{LCD1}	2/3 V _{DD}	2/5 V _{DD}
V _{LCD2}	1/3 V _{DD}	1/5 V _{DD}
V _{LCD3}	V _{SS}	V _{SS}

- 3.** R_{ODC} is internal equivalent weight resistance from COM pin + COM IOBUF resistance.
R_{ODS} is internal equivalent weight resistance from SEG pin +SEG IOBUF resistance.

$T_A = -40$ to $+85$ °C, $2.7\text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
LCD division resistance <small>Note 1</small>	R_{LCD}				3	$k\Omega$
LCD Segment output voltage (unloaded)	V_{ODS}	$I_o = \pm 1\ \mu\text{A}$	$V_{LCDn}-0.05$	V_{LCDn} <small>Note 2</small>	$V_{LCDn}+0.05$	V
LCD Common output voltage (unloaded)	V_{ODC}	$I_o = \pm 1\ \mu\text{A}$	$V_{LCDn}-0.05$	V_{LCDn}	$V_{LCDn}+0.05$	V
LCD Segment Output Voltage (loaded)	V_{ODSL0}	$I_o = \pm 5\ \mu\text{A}$, all segment pins at same time	$V_{LCD0}-0.6$	V_{LCD0}	$V_{LCD0}+0.6$	V
	V_{ODSL1}	$I_o = \pm 5\ \mu\text{A}$, all segment pins at same time	$V_{LCD1}-0.6$	V_{LCD1}	$V_{LCD1}+0.6$	V
	V_{ODSL2}	$I_o = \pm 5\ \mu\text{A}$, all segment pins at same time	$V_{LCD2}-0.6$	V_{LCD2}	$V_{LCD2}+0.6$	V
	V_{ODSL3}	$I_o = \pm 5\ \mu\text{A}$, all segment pins at same time	$V_{LCD3}-0.6$	V_{LCD3}	$V_{LCD3}+0.6$	V
LCD Common Output Voltage (loaded)	V_{ODCL0}	$I_o = \pm 25\ \mu\text{A}$, single pin	$V_{LCD0}-0.2$	V_{LCD0}	$V_{LCD0}+0.2$	V
	V_{ODCL1}	$I_o = \pm 25\ \mu\text{A}$, single pin	$V_{LCD1}-0.2$	V_{LCD1}	$V_{LCD1}+0.2$	V
	V_{ODCL2}	$I_o = \pm 25\ \mu\text{A}$, single pin	$V_{LCD2}-0.2$	V_{LCD2}	$V_{LCD2}+0.2$	V
	V_{ODCL3}	$I_o = \pm 25\ \mu\text{A}$, single pin	$V_{LCD3}-0.2$	V_{LCD3}	$V_{LCD3}+0.2$	V
LCD split voltage drive capability	V_{LC0}	$I_o = \pm 530\ \mu\text{A}$	$V_{LCD0}-0.1$	V_{LCD0}	$V_{LCD0}+0.1$	V
	V_{LC1}	$I_o = \pm 530\ \mu\text{A}$	$V_{LCD1}-0.1$	V_{LCD1}	$V_{LCD1}+0.1$	V
	V_{LC2}	$I_o = \pm 530\ \mu\text{A}$	$V_{LCD2}-0.1$	V_{LCD2}	$V_{LCD2}+0.1$	V
	V_{LC3}	$I_o = \pm 530\ \mu\text{A}$	$V_{LCD3}-0.1$	V_{LCD3}	$V_{LCD3}+0.1$	V
LCD output resistance (COM) <small>Note 3</small>	R_{ODC}				10	$k\Omega$
LCD output resistance (SEG) <small>Note 3</small>	R_{ODS}				10	$k\Omega$

Notes 1. V_{LCDn} ($n= 0..3$) represents one of the four possible voltage levels at the LCD pins. See table below for reference.

V_{LCDn}	no step-down transforming
V_{LCD0}	V_{DD}
V_{LCD1}	$2/3\ V_{DD}$
V_{LCD2}	$1/3\ V_{DD}$
V_{LCD3}	V_{SS}

- Only internal connection. The value is design specification.
- R_{ODC} is internal equivalent weight resistance from COM pin + COM IOBUF resistance.
 R_{ODS} is internal equivalent weight resistance from SEG pin +SEG IOBUF resistance.

3.7 Analog characteristics

3.7.1 A/D converter characteristics

 $T_A = -40 \text{ to } +85 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

 Reference voltage (+) = AV_{REFP} , Reference voltage(-) = AV_{REFM}

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
Resolution	RES		8		10	Bit	
Overall error ^{Note 1,2}	AINL	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$		1.2	± 3.5	LSB	
Conversion time	T _{conv}	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$	$3.6 \text{ V} \leq V_{DD} < 5.5 \text{ V}$	2.125		39	μs
			$2.7 \text{ V} \leq V_{DD} < 5.5 \text{ V}$	3.1875		39	μs
Zero-scale error ^{Note 1, 2}	E _{ZS}	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$			0.25	%FSR	
Full-scale error ^{Note 1, 2}	E _{FS}	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$			0.25	%FSR	
Integral non-linearity error ^{Note 1}	ILE	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$			± 2.5	LSB	
Differential non-linearity error ^{Note 1}	DLE	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0 \text{ V}$			± 1.5	LSB	
REF voltage(+)	AV_{REFP}		2.7		V_{DD}	V	
REF voltage(-)	AV_{REFM}		V_{SS}			V	
Analog input voltage	V_{AIN}		AV_{REFM}		AV_{REFP}	V	
REF supply Current	I _{REF}	$AV_{REFP} = 3 \text{ V}$		38	60	μA	
		$AV_{REFP} = 5 \text{ V}$		63	100	μA	

Notes 1. Excludes quantization error ($\pm 1/2$ LSB).

2. This value is indicated as a ratio (%FSR) to the full-scale value.

3. Minimum $V_{DD} - 0.5 \text{ V}$ is allowed for AV_{REFP} to keep characteristic values

Remark When reference voltage(+) is not AV_{REFP} pin or reference voltage(-) is not AV_{REFM} pin, the accuracy will become worse.

Renesas recommends to use A/D converter with AV_{REFP} and AV_{REFM} though other reference can be functionally selected.

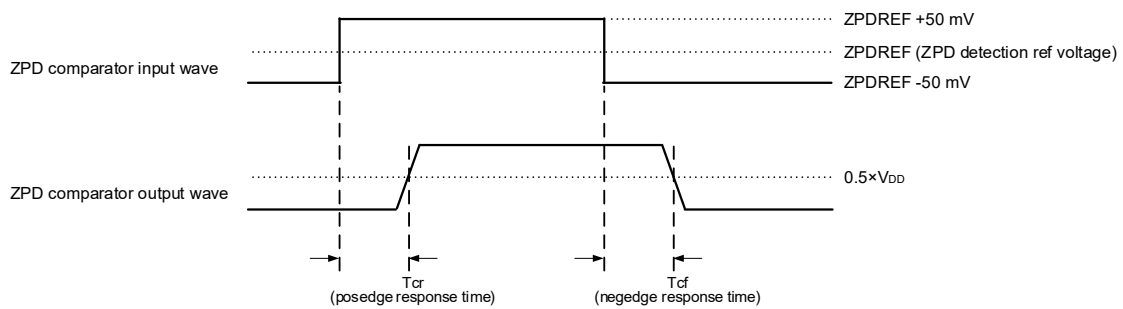
3.7.2 ZPD characteristics

$T_A = -40$ to $+85$ °C,

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Threshold voltage	V_{ZPD}	0 Point detection voltage set = 000	6/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 001	10/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 010	14/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 011	18/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 100	22/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 101	9/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 110	11/200*SMV _{DD} ±40 mv			V
Detection delay	T_{ZPDD}	100 mV Step, 50 mV Overdrive (refer to the below figure)	$SMV_{DD} = 4.75\text{ V to }5.25\text{ V}$		100	ns
			$SMV_{DD} = 2.7\text{ V to }5.5\text{ V}$		100	ns
Operation Stabilization wait time	T_{ZPDW}	Ref voltage Stabilization +ZPD comparator Stabilization			1+5 = 6	μs

Figure 3-15. ZPD timing



3.7.3 POR characteristics

$T_A = -40$ to $+85$ °C

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	V _{POR}		1.45	1.51	1.57	V
	V _{PDR}		1.44	1.5	1.56	V
Detection delay	T _{PD}				300	μs
Minimum pulse width	T _{PW}	Necessary width of internal voltage drop down below V _{PDR}	300			μs

Caution LVD reset or external RESET must be used during power supply rising up to 2.7 V.

3.7.4 LVD characteristics

$T_A = -40$ to $+85$ °C, V_{PDR} ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
RESET and INTMODE	V _{LVI5}	V _{POC0,1,2} = 0,1,1 Power down Reset Voltage: 2.7 V	2.70	2.75	2.81	V	
	V _{LVI4}	LVIS _{0,1} = 1,0 (+0.1 V)	Power on Reset Release Voltage	2.86	2.92	2.97	V
			Power down Interrupt Voltage	2.80	2.86	2.91	V
	V _{LVI3}	LVIS _{0,1} = 0,1 (+0.2 V)	Power on Reset Release Voltage	2.96	3.02	3.08	V
			Power down Interrupt Voltage	2.90	2.96	3.02	V
	V _{LVI0}	LVIS _{0,1} = 0,0 (+1.2 V)	Power on Reset Release Voltage	3.98	4.06	4.14	V
Power down Interrupt Voltage			3.90	3.98	4.06	V	
Detection delay time	T _{LD}				300	μs	
Minimum pulse width	T _{LW}	Necessary width of V _{DD} drop down below selected V _{LVIx} (x = 0, 3 to 5)	300			μs	

Caution LVD reset or external RESET must be used during power supply rising up to 2.7 V.

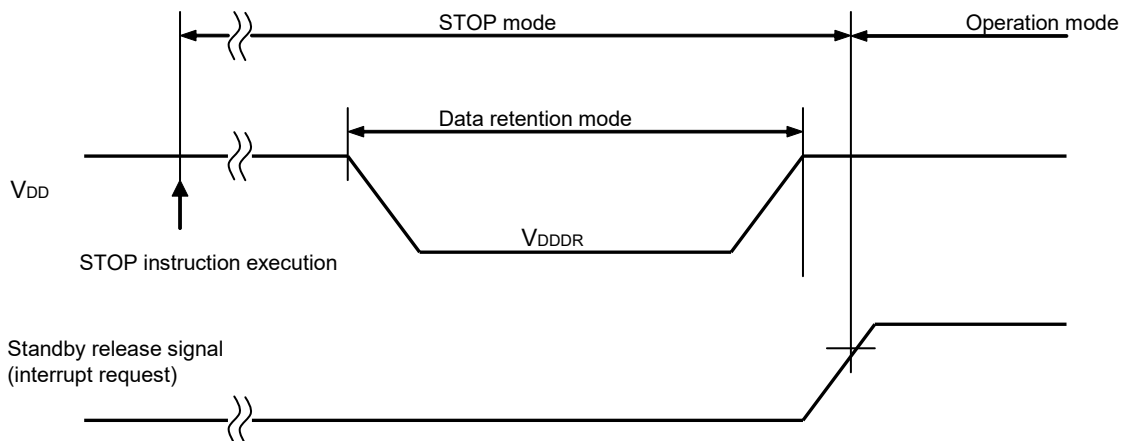
3.8 RAM Data Retention Characteristics

$T_A = -40$ to $+85$ °C

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	V _{DDDR}		1.44 ^{Note1}		5.5	V

Note The value depends on the POR detection voltage. When the voltage drops, the data is retained until a POR reset is effected, but data is not retained when a POR reset is effected.

Figure 3-16. STOP Mode Data Retention timing



3.9 Capacitance Connected to REGCT_A = -40 to +85 °C

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Capacitance	C _{REG}		0.47		1.0	μF

3.10 Flash programming characteristicsT_A = -40 to +85 °C, 2.7 ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
V _{DD} supply current	I _{DD}	Programming current			12.2	mA
System Clcok frequency	f _{CLK}	2.7 V ≤ V _{DD} ≤ 5.5 V	2		32	MHz
Number of Code Flash rewrites ^{Notes 1, 2, 3}	Cerwr	Retained for 20 years	1000			Times
Number of Data Flash rewrites ^{Notes 1, 2, 3}	Cerwr	Retained for 20 years	10000			Times

- Notes 1.** 1 erase + 1 write after the erase is regarded as 1 rewrite.
The retaining years are until next rewrite after the rewrite.
- 2.** When using flash memory programmer and Renesas Electronics self programming library
- 3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

4. ELECTRICAL SPECIFICATIONS (L GRADE PRODUCT)

- Cautions**
1. These specifications show target values, which may change after device evaluation.
 2. The RL78/D1A has an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.

Definition of Pin Groups

Definition of pin groups described in this chapter is shown in the following table.

Pin groups		Pin names				
		48-pin products	64-pin products	80-pin products	100-pin products	128-pin products
Pin group 1	Group 1R	P40	P40, P70, P71	P40, P70, P71	P40, P70, P71, P130 to P135, P140	P40 to P44, P70, P71, P100 to P103, P130 to P135, P140
	Group 1L	P00 to P01, P10 to P14, P30 to P33, P54 to P57, P60, P61, P72 to P75	P00 to P05, P07, P10 to P15, P17, P30 to P33, P54 to P57, P60, P61, P72 to P75	P00 to P07, P10 to P17, P30 to P37, P54 to P57, P60, P61, P65, P66, P72 to P75	P00 to P07, P10 to P17, P30 to P37, P50 to P57, P72 to P75, P136	P00 to P07, P10 to P17, P30 to P37, P45 to P47, P50 to P57, P72 to P75, P104 to P107, P110 to P117, P125 to P127 P136
	Group 1C	-	-	-	P60 to P66	P60 to P66
Pin group 2 (ANI pins)		P20 to P23, P27	P20 to P23, P27	P20 to P27	P20 to P27, P150	P20 to P27, P150 to P152
Pin group 3 (SMC pins)	Group 3A	P80 to P83	P80 to P83	P80 to P83	P80 to P83	P80 to P83
	Group 3B	-	P84 to P87	P84 to P87	P84 to P87	P84 to P87
	Group 3C	P90 to P94	P90 to P94	P90 to P93	P90 to P93	P90 to P93
	Group 3D	-	-	P94 to P97	P94 to P97	P94 to P97
	Group 3E	P90 to P94	P84 to P87, P90 to P94	-	-	-
Pin group 4 (System pins)		P121 to P122, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137	P121 to P124, RESET, P137

Definition of Product Groups

Definition of product groups described in this chapter is shown in the following table.

Product groups	Product names				
	48-pin products	64-pin products	80-pin products	100-pin products	128-pin products
Product Group A	R5F10CGBLFB R5F10CGCLFB R5F10CGDLFB R5F10DGCLFB R5F10DGDLFB R5F10DGELFB	R5F10CLDLFB R5F10DLDLFB R5F10DLELFB	R5F10CMDLFB R5F10CMELFB R5F10DMDLFB R5F10DMELFB R5F10DMFLFB R5F10DMGLFB R5F10DMJLFB	R5F10DPELFB R5F10DPFLFB R5F10DPGLFB R5F10DPJLFB R5F10TPJLFB	-
Product Group B	-	-	-	R5F10DPKLFB R5F10DPLLFB	R5F10DSJLFB R5F10DSKLFB R5F10DSLLFB

4.1 Absolute Maximum Ratings

T_A = +25 °C

Parameter	Symbols	Conditions	Ratings	Unit
Supply voltage	V _{DD}	V _{DD}	-0.5 to +6.5	V
	EV _{DD0} EV _{DD1}	EV _{DD0} = EV _{DD1}	-0.5 to +6.5 and -0.5 to V _{DD} + 0.3	V
	SMV _{DD0} SMV _{DD1}	SMV _{DD0} = SMV _{DD1}	-0.5 to +6.5 and -0.5 to V _{DD} + 0.3	V
	V _{SS}	V _{SS}	-0.5 to +0.3	V
	EV _{SS0} EV _{SS1}	EV _{SS0} = EV _{SS1}	-0.5 to +0.3	V
	SMV _{SS0} SMV _{SS1}	SMV _{SS0} = SMV _{SS1}	-0.5 to +0.3	V
	Supply voltage up/down ramp	V _{DDRAMP}		≤50
REGC pin input voltage	V _{IREGC}	REGC	-0.3 to +2.8 and -0.3 to V _{DD} + 0.3 ^{Note1}	V
Input voltage	V _{I1}	Pin group 1	-0.3 to +6.5 and -0.3 to EV _{DD0} (EV _{DD1}) + 0.3	V
	V _{I2}	Pin group 2	-0.3 to +6.5 and -0.3 to V _{DD} + 0.3	V
	V _{I3}	Pin group 3	-0.3 to +6.5 and -0.3 to SMV _{DD0} (SMV _{DD1}) + 0.3	V
	V _{I4}	Pin group 4	-0.3 to +6.5 and -0.3 to V _{DD} + 0.3	V

(Continue to next page)

T_A = +25 °C

Parameter	Symbols	Conditions		Ratings	Unit	
Output voltage	V _{O1}	Pin group 1		-0.3 to EV _{DD0} (EV _{DD1}) + 0.3	V	
	V _{O2}	Pin group 2		-0.3 to V _{DD} + 0.3	V	
	V _{O3}	Pin group 3		-0.3 to SMV _{DD0} (SMV _{DD1}) + 0.3	V	
	V _{COM}	COM0 to COM3		-0.3 to V _{DD} + 0.3	V	
Output current, high	I _{OH1}	Per pin	Pin group 1		-20	mA
			Total	Pin group 1		-150
		Pin group 1L		-60	mA	
		Pin group 1R		-55	mA	
		Pin group 1C		-40	mA	
	I _{OH2}	Per pin	Pin group 2		-0.5	mA
		Total			-2.0	mA
	I _{OH3}	Per pin	Pin group 3		-58	mA
			Total	Pin group 3	48-pin, 64-pin	-270
		80-pin, 100-pin, 128-pin			-480	mA
		Pin group 3A		-120	mA	
		Pin group 3B		-120	mA	
		Pin group 3C		-120	mA	
		Pin group 3D		-120	mA	
		Pin group 3E		-150	mA	
I _{OHCOM}	Per pin	COM0 to COM3		-0.5	mA	
	Total	COM0 to COM3		-1.0	mA	
Output current, low	I _{OL1}	Per pin	Pin group 1		20	mA
			Total	Pin group 1		150
		Pin group 1L		60	mA	
		Pin group 1R		50	mA	
		Pin group 1C		40	mA	
	I _{OL2}	Per pin	Pin group 2		1.0	mA
		Total			5.0	mA
	I _{OL3}	Per pin	Pin group 3		58	mA
			Total	Pin group 3	48-pin, 64-pin	270
		80-pin, 100-pin, 128-pin			480	mA
		Pin group 3A		120	mA	
		Pin group 3B		120	mA	
		Pin group 3C		120	mA	
		Pin group 3D		120	mA	
	Pin group 3E		150	mA		
	I _{OLCOM}	Per pin	COM0 to COM3		0.5	mA
		Total	COM0 to COM3		1.0	mA
Operating ambient temperature	T _A	for normal operation mode		-40 to +105	°C	
		for code flash programming		-40 to +105	°C	
		for data flash programming		-40 to +105	°C	
Storage temperature	T _{stg}			-65 to +150	°C	

Note Connect the REGC pin to V_{ss} via a capacitor (0.47 to 1 μF).

This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

4.2 Power consumption characteristics

4.2.1 Product group A

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, run mode	I _{DD1} ^{Note 1}	High speed MAIN RUN Note 2, 3, 4	f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	4.2	18	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
		f _{CLK} = 20 MHz	f _X = 20 MHz	3.8	16	mA	
		f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	2.1	11	mA	
			f _X = 8 MHz				
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	1.6	9	mA			
	f _X = 4 MHz						
		SUB RUN Note 2, 3, 5	f _{CLK} = f _{XT} = 32.768 kHz	6	500	μA	

- Notes**
- The common condition for I_{DD1}:
 - I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
 - The program is running in the code flash.
 - The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.
 - The maximum value is that when all peripheral devices are operating. But the A/D converter, RTC, LCD circuit and stepper motor circuit are stopped, and the data flash and the code flash are stated to read mode. The 16-bit wakeup timer operates with f_{LOCO}.
 - In case of I_{DD1} of "f_X = 4/8 MHz with PLL", the high speed on-chip oscillator (HOCO) is stopped.
 - f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, halt mode	I _{DD2} ^{Note 1}	High speed MAIN HALT <small>Note 3, 4, 5</small>	f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	0.8	6.9	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
		f _{CLK} = 20 MHz	f _X = 20 MHz	0.7	6.0	mA	
		f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	0.4	4.3	mA	
			f _X = 8 MHz				
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	0.35	3.6	mA			
	f _X = 4 MHz						
SUB HALT <small>Note 3, 4, 6</small>	f _{CLK} = f _{XT} = 32.768 kHz	RTC is stopped	1.0	190	μA		
		RTC is operated by f _{XT} = 32.768 kHz	1.2				
Supply current, stop mode	I _{DD3} ^{Note 2}	STOP ^{Note 3, 4}	RTC and f _{XT} are stopped	0.4	120	μA	
			RTC is operated by f _{XT} = 32.768 kHz	0.8			

Notes 1. The common condition for I_{DD2}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The HALT instruction is executed by the program in the code flash.
- The specification shows the stable current during HALT mode.

2. The common condition for I_{DD3}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The STOP instruction is executed by the program in the code flash during MAIN RUN operation.
- The spec shows the stable current during STOP mode.

3. The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.

4. The maximum value is that when all peripheral devices are operating. But the A/D converter, LCD circuit, stepper motor circuit, the data flash and the code flash are stopped. The 16-bit wakeup timer operates with f_{LOCO}.

5. Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.

6. f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit
WDT operating current ^{Note 1}	I _{WDT}			0.25	2.0	μA
ADC operating current ^{Note 2}	I _{ADC}	Normal mode	V _{DD} = 5.0 V	1.3	1.7	mA
		Low voltage mode	V _{DD} = 3.0 V	0.5	0.7	mA
LCD operating Current ^{Note 3}	I _{LCD}	f _{LCD} = f _{SUB} , LCD clock = 512 Hz	V _{DD} = 5.0 V	100	210	μA
			V _{DD} = 3.0 V	90	200	μA
ZPD operating current ^{Note 4}	I _{ZPD}	One ZPD operated	V _{DD} = 5.0 V	150	600	μA
			V _{DD} = 3.0 V	100	500	μA
		Four ZPDs operated	V _{DD} = 5.0 V	500	2000	μA
			V _{DD} = 3.0 V	400	1600	μA

- Notes**
1. Current flowing only to the watchdog timer. The maximum specification of I_{DD1}, I_{DD2} and I_{DD3} include I_{WDT}.
 2. Current flowing only to the A/D converter. The current value of the RL78/D1A is the sum of I_{DD} and I_{ADC} when the A/D converter operates.
 3. Current flowing only to the LCD controller/driver circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{LCD} when the LCD controller/driver circuit operates.
 4. Current flowing only to the ZPD circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{ZPD} when the ZPD circuit operates.

4.2.2 Product group B

TA = -40 to +105 °C, 2.7 V ≤ VDD ≤ 5.5 V, VSS = 0 V

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, run mode	IDD1 ^{Note 1}	High speed MAIN RUN <small>Note 2, 3, 4, 5</small>	f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	4.7	20	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
		f _{CLK} = 20 MHz	f _X = 20 MHz	4.3	17.5	mA	
		f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	2.4	12	mA	
			f _X = 8 MHz				
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	1.8	9.5	mA			
	f _X = 4 MHz						
SUB RUN <small>Note 2, 3, 6</small>	f _{CLK} = f _{XT} = 32.768 kHz	7	560	μA			

- Notes**
- The common condition for IDD1:
 - IDD includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to VDD or VSS.
 - The program is running in the code flash.
 - The typical value is that when Ta=+25deg.C and VDD=5.0 V. Peripheral devices and the data flash are stopped.
 - The maximum value is that when all peripheral devices are operating. But the A/D converter, RTC, LCD circuit and stepper motor circuit are stopped, and the data flash and the code flash are stated to read mode. The 16-bit wakeup timer operates with f_{LOCO}.
 - In case of IDD1 of "f_X = 4/8 MHz with PLL", the high speed on-chip oscillator (HOCO) is stopped.
 - At 128-pin products, the value of IDD1 does not include the LCDB (P11x, P46-7) pin toggle current.
IDD1 condition of LCDB macro is f_{CLK}=24MHz, mod8 mode, data rate=6MHz, 4cycle, 16bit write/read.
 - f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit	
Supply current, halt mode	I _{DD2} ^{Note 1}	High speed MAIN HALT ^{Note 3, 4, 5}	f _{CLK} = 24 MHz	f _{HOCO} = 24 MHz	0.8	7.5	mA
				f _{HOCO} = 4 MHz with PLL			
				f _X = 4 MHz with PLL			
				f _X = 8 MHz with PLL			
		f _{CLK} = 20 MHz	f _X = 20 MHz	0.7	6.5	mA	
		f _{CLK} = 8 MHz	f _{HOCO} = 8 MHz	0.4	4.5	mA	
			f _X = 8 MHz				
f _{CLK} = 4 MHz	f _{HOCO} = 4 MHz	0.35	3.8	mA			
	f _X = 4 MHz						
Supply current, stop mode	I _{DD3} ^{Note 2}	SUB HALT ^{Note 3, 4, 6}	f _{CLK} = f _{XT} = 32.768 kHz	RTC is stopped	1.0	200	μA
				RTC is operated by f _{XT} = 32.768 kHz			
Supply current, stop mode	I _{DD3} ^{Note 2}	STOP ^{Note 3, 4}	RTC and f _{XT} are stopped		0.4	130	μA
			RTC is operated by f _{XT} = 32.768 kHz				

Notes 1. The common condition for I_{DD2}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The HALT instruction is executed by the program in the code flash.
- The specification shows the stable current during HALT mode.

2. The common condition for I_{DD3}:

- I_{DD} includes the total current flowing into whole power pins, including the input leakage current flowing when the level of the input pin is fixed to V_{DD} or V_{SS}.
- The STOP instruction is executed by the program in the code flash during MAIN RUN operation.
- The spec shows the stable current during STOP mode.

3. The typical value is that when T_a=+25deg.C and V_{DD}=5.0 V. Peripheral devices and the data flash are stopped.

4. The maximum value is that when all peripheral devices are operating. But the A/D converter, LCD circuit, stepper motor circuit, the data flash and the code flash are stopped. The 16-bit wakeup timer operates with f_{LOCO}.

5. Either f_X or f_{HOCO} which is selected for f_{CLK} is operated. The other is stopped.

6. f_X and f_{HOCO} are stopped.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions		Typ.	Max.	Unit
WDT operating current ^{Note 1}	I _{WDT}			0.25	1.0	μA
ADC operating current ^{Note 2}	I _{ADC}	Normal mode	V _{DD} = 5.0 V	1.3	1.7	mA
		Low voltage mode	V _{DD} = 3.0 V	0.5	0.7	mA
LCD operating Current ^{Note 3}	I _{LCD}	f _{LCD} = f _{SUB} , LCD clock = 512 Hz	V _{DD} = 5.0 V	100	140	μA
			V _{DD} = 3.0 V	90	130	μA
ZPD operating current ^{Note 4}	I _{ZPD}	One ZPD operated	V _{DD} = 5.0 V	150	600	μA
			V _{DD} = 3.0 V	100	500	μA
		Four ZPDs operated	V _{DD} = 5.0 V	500	2000	μA
			V _{DD} = 3.0 V	400	1600	μA

- Notes**
1. Current flowing only to the watchdog timer. The maximum specification of I_{DD1}, I_{DD2} and I_{DD3} include I_{WDT}.
 2. Current flowing only to the A/D converter. The current value of the RL78/D1A is the sum of I_{DD} and I_{ADC} when the A/D converter operates.
 3. Current flowing only to the LCD controller/driver circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{LCD} when the LCD controller/driver circuit operates.
 4. Current flowing only to the ZPD circuit. The current value of the RL78/D1A is the sum of I_{DD} and I_{ZPD} when the ZPD circuit operates.

4.3 Oscillator characteristics

4.3.1 Main(X1) oscillator characteristics

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Main(X1) clock oscillation frequency	f _x	Ceramic resonator	1.0		20.0	MHz
		Crystal resonator	1.0		20.0	MHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

4.3.2 High speed on chip oscillator characteristics

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
HOCO oscillation frequency	f _{HOCO}	4 MHz mode	3.88	4.00	4.12	MHz
		8 MHz mode	7.76	8.00	8.24	MHz
		16 MHz mode	15.52	16.00	16.48	MHz
		24 MHz mode	23.28	24.00	24.72	MHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

4.3.3 Low speed on chip oscillator characteristics

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
LOCO oscillation frequency	f _{LOCO}		12.75	15.0	17.25	kHz

4.3.4 Sub(XT1) oscillator characteristics

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = 0 \text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Sub(XT1) clock oscillation frequency	f _{XT}	Possible to oscillate	29.0	32.768	35.0	kHz

Remark Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

4.4 DC characteristics

4.4.1 Pin group 1

$$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq \text{EV}_{\text{DD}0} = \text{EV}_{\text{DD}1} \leq V_{\text{DD}} \leq 5.5 \text{ V}, V_{\text{SS}} = \text{EV}_{\text{SS}0} = \text{EV}_{\text{SS}1} = 0 \text{ V (1/2)}$$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Output current, high ^{Note 1}	I _{OH1}	Per pin			-5.0	mA	
	I _{OH2}	Per pin, P73 or P135 (SG port)			-13.0	mA	
	I _{OHTOTAL}	Total (for duty factors ≤ 70% ^{Note 2})	Group 1L			-40.0	mA
			Group 1R			-40.0	mA
			Group 1C (128-pin, 100-pin)			-30.0	mA
			for 128-pin, 100-pin			-110.0	mA
for 80-pin, 64-pin, 48-pin			-60.0	mA			
Output current, low	I _{OL1}	Per pin			8.5	mA	
	I _{OL2}	Per pin, P73 or P135 (SG ports)			13.0	mA	
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note 3})	Group 1L			40.0	mA
			Group 1R			35.0	mA
			Group 1C (128-pin, 100-pin)			40.0	mA
			for 128-pin, 100-pin			115.0	mA
for 80-pin, 64-pin, 48-pin			60.0	mA			

- Notes**
- When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OH} = -30.0 \text{ mA}$

$$\text{Total output current of pins} = (-30.0 \times 0.7)/(80 \times 0.01) \approx -26.2 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OL} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OL} = 40.0 \text{ mA}$

$$\text{Total output current of pins} = (40.0 \times 0.7)/(80 \times 0.01) = 35.0 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq \text{EV}_{\text{DD}0} = \text{EV}_{\text{DD}1} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS}0} = \text{EV}_{\text{SS}1} = 0 \text{ V (2/2)}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high ^{Note 2}	V _{IH1}	Schmitt3 mode	0.8EV _{DD}		EV _{DD}	V
	V _{IH2}	Schmitt1 mode ^{Note 3}	0.65EV _{DD}		EV _{DD}	V
Input voltage, low ^{Note 2}	V _{IL1}	Schmitt3 mode	0		0.5EV _{DD}	V
	V _{IL2}	Schmitt1 mode ^{Note 3}	0		0.35EV _{DD}	V
Input hysteresis width ^{Note 2, 4}	V _{IHYS1}	Schmitt3 mode	0.1	0.19	0.29	V
	V _{IHYS2}	Schmitt1 mode ^{Note 3}	0.15	0.59	0.84	V
Output voltage, high ^{Note 1}	V _{OH1}	I _{OH} = -5.0 mA	EV _{DD} -1.0		EV _{DD}	V
		I _{OH} = -3.0 mA up to 6 pins	EV _{DD} -0.5		EV _{DD}	V
	V _{OH2}	I _{OH} = -13.0 mA, P73 or P135 (SG port)	EV _{DD} -0.7		EV _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 8.5 mA	0		0.7	V
		I _{OL} = 3.0 mA up to 6 pins	0		0.5	V
	V _{OL2}	I _{OL} = 13.0 mA, P73 or P135 (SG port)	0		0.7	V
Input leakage current, high	I _{LIH1}	V _I = EV _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = EV _{SS}			-1	μA
On chip pull-up resistance ^{Note 5}	R _U	V _I = EV _{SS}	10	20	100	kΩ
On chip pull-down resistance ^{Note 6}	R _D	V _I = EV _{DD}	100			kΩ

- Notes**
1. When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 2. Except P130 because it is output only port.
 3. P01, P10, P11, P17, P31, P40, P50 to P52, P55 to P57, P61, P63, P70, P110 to P117, P135 only.
 4. This value is defined by evaluation result.
 5. Except P130 and P137. Pull-up resistance is connected by software when pin is set to input mode.
 6. LCD segment shared pins only. Pull-down resistance is connected during reset.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$, $2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq 4.0 \text{ V}$, $EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS} = 0 \text{ V}$ (1/2)

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Output current, high ^{Note 1}	IOH1	Per pin			-1.0	mA	
	IOH2	Per pin, P73 or P135 (SG port)			-7.5	mA	
	IOHTOTAL	Total (for duty factors $\leq 70\%$ ^{Note 2})	Group 1L			-15.0	mA
			Group 1R			-30.0	mA
			Group 1C (128-pin, 100-pin)			-7.0	mA
			for 128-pin, 100-pin			-52.0	mA
		for 80-pin, 64-pin, 48-pin			-33.0	mA	
Output current, low	IOL1	Per pin			1.5	mA	
	IOL2	Per pin, P73 or P135 (SG ports)			7.0	mA	
	IOLTOTAL	Total (for duty factors $\leq 70\%$ ^{Note 3})	Group 1L			18.0	mA
			Group 1R			30.0	mA
			Group 1C (128-pin, 100-pin)			10.0	mA
			for 128-pin, 100-pin			58.0	mA
		for 80-pin, 64-pin, 48-pin			35.0	mA	

- Notes**
- When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OH} = -7.0 \text{ mA}$

Total output current of pins = $(-7.0 \times 0.7)/(80 \times 0.01) \approx -6.1 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.
 - These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).
 - Total output current of pins $(I_{OL} \times 0.7)/(n \times 0.01)$

<Example> Where $n = 80\%$ and $I_{OL} = 10.0 \text{ mA}$

Total output current of pins = $(10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$, $2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq 4.0 \text{ V}$, $EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS} = 0 \text{ V}$ (2/2)

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high ^{Note 2}	V _{IH1}	Schmitt3 mode	0.8EV _{DD}		EV _{DD}	V
	V _{IH2}	Schmitt1 mode ^{Note 3}	0.7EV _{DD}		EV _{DD}	V
Input voltage, low ^{Note 2}	V _{IL1}	Schmitt3 mode	0		0.4EV _{DD}	V
	V _{IL2}	Schmitt1 mode ^{Note 3}	0		0.3EV _{DD}	V
Input hysteresis width ^{Note 2, 4}	V _{IHYS1}	Schmitt3 mode	0.05		0.21	V
	V _{IHYS2}	Schmitt1 mode ^{Note 3}	0.08		0.53	V
Output voltage, high ^{Note 1}	V _{OH1}	I _{OH} = -1.0 mA	EV _{DD} -0.5		EV _{DD}	V
	V _{OH2}	I _{OH} = -7.5 mA, P73 or P135 (SG port)	EV _{DD} -0.7		EV _{DD}	V
Output voltage, low	V _{OL1}	I _{OL} = 1.5 mA	0		0.5	V
	V _{OL2}	I _{OL} = 7.0 mA, P73 or P135 (SG port)	0		0.7	V
Input leakage current, high	I _{LIH1}	V _I = EV _{DD}			1	μA
Input leakage current, low	I _{LIL1}	V _I = EV _{SS}			-1	μA
On chip pull-up resistance ^{Note 5}	R _U	V _I = EV _{SS}	10	20	100	kΩ
On chip pull-down resistance ^{Note 6}	R _D	V _I = EV _{DD}	100			kΩ

- Notes**
1. When P60 or P61 is set to Nch open drain mode, it does not drive high level output.
 2. Except P130 because it is output only port.
 3. P01, P10, P11, P17, P31, P40, P50 to P52, P55 to P57, P61, P63, P70, P110 to P117, P135 only.
 4. This value is defined by evaluation result.
 5. Except P130 and P137. Pull-up resistance is connected by software when pin is set to input mode.
 6. LCD segment shared pins only. Pull-down resistance is connected during reset.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

4.4.2 Pin group 2 (ANI pins)

 $T_A = -40$ to $+105$ °C, $4.0\text{ V} \leq V_{DD} \leq 5.5\text{ V}$, $V_{SS} = 0\text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Output current, high	I_{OH1}	Per pin			-0.1	mA
	$I_{OHTOTAL}$	Total			-0.8	mA
Output current, low	I_{OL1}	Per pin			0.4	mA
	$I_{OLTOTAL}$	Total			3.2	mA
Input voltage, high	V_{IH1}		$0.8V_{DD}$		V_{DD}	V
Input voltage, low	V_{IL1}		0		$0.5V_{DD}$	V
Input hysteresis width ^{Note}	V_{IHYS1}		0.1	0.19	0.29	V
Output voltage, high	V_{OH1}	$I_{OH} = -0.1\text{ mA}$	$V_{DD}-0.5$		V_{DD}	V
Output voltage, low	V_{OL1}	$I_{OL} = 0.4\text{ mA}$	0		0.4	V
Input leakage current, high	I_{LIH1}	$V_i = V_{DD}$			1	μA
Input leakage current, low	I_{LIL1}	$V_i = V_{SS}$			-1	μA

Note This specification is guaranteed by design. It is not tested when shipment. $T_A = -40$ to $+105$ °C, $2.7\text{ V} \leq V_{DD} \leq 4.0\text{ V}$, $V_{SS} = 0\text{ V}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Output current, high	I_{OH1}	Per pin			-0.1	mA
	$I_{OHTOTAL}$	Total			-0.8	mA
Output current, low	I_{OL1}	Per pin			0.4	mA
	$I_{OLTOTAL}$	Total			3.2	mA
Input voltage, high	V_{IH1}		$0.8V_{DD}$		V_{DD}	V
Input voltage, low	V_{IL1}		0		$0.4V_{DD}$	V
Input hysteresis width ^{Note}	V_{IHYS1}		0.05		0.21	V
Output voltage, high	V_{OH1}	$I_{OH} = -0.1\text{ mA}$	$V_{DD}-0.5$		V_{DD}	V
Output voltage, low	V_{OL1}	$I_{OL} = 0.4\text{ mA}$	0		0.4	V
Input leakage current, high	I_{LIH1}	$V_i = V_{DD}$			1	μA
Input leakage current, low	I_{LIL1}	$V_i = V_{SS}$			-1	μA

Note This specification is guaranteed by design. It is not tested when shipment.

4.4.3 Pin group 3 (SMC pins)

$T_A = -40$ to $+105$ °C, $4.0\text{ V} \leq V_{DD} = \text{SMV}_{DD0} = \text{SMV}_{DD1} \leq 5.5\text{ V}$, $V_{SS} = \text{SMV}_{SS0} = \text{SMV}_{SS1} = 0\text{ V}$ (1/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit		
Output current, high	I _{OH1}	Per pin		T _A = -40 °C		-52	mA		
				T _A = +25 °C		-39	mA		
				T _A = +85 °C		-32	mA		
				T _A = +105 °C		-32	mA		
	I _{OHTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		-118	mA
				Group 3A		T _A = +25 °C		-118	mA
				Group 3A		T _A = +85 °C		-96	mA
				Group 3A		T _A = +105 °C		-96	mA
				Group 3B		T _A = -40 °C		-118	mA
				Group 3B		T _A = +25 °C		-118	mA
				Group 3B		T _A = +85 °C		-96	mA
				Group 3B		T _A = +105 °C		-96	mA
				Group 3C	128-pin, 100-pin, 80-pin	T _A = -40 °C		-118	mA
						T _A = +25 °C		-118	mA
						T _A = +85 °C		-96	mA
						T _A = +105 °C		-96	mA
				Group 3C	64-pin, 48-pin	T _A = -40 °C		-118	mA
						T _A = +25 °C		-118	mA
						T _A = +85 °C		-96	mA
						T _A = +105 °C		-96	mA
Group 3D (128-pin, 100-pin, 80-pin)				T _A = -40 °C		-118	mA		
Group 3D (128-pin, 100-pin, 80-pin)				T _A = +25 °C		-118	mA		
Group 3D (128-pin, 100-pin, 80-pin)				T _A = +85 °C		-96	mA		
Group 3D (128-pin, 100-pin, 80-pin)				T _A = +105 °C		-96	mA		
Group 3E (64-pin, 48-pin)		T _A = -40 °C		-148	mA				
Group 3E (64-pin, 48-pin)		T _A = +25 °C		-118	mA				
Group 3E (64-pin, 48-pin)		T _A = +85 °C		-96	mA				
Group 3E (64-pin, 48-pin)		T _A = +105 °C		-96	mA				

Note These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OH} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OH} = -118.0 mA

Total output current of pins = (-118.0 × 0.7)/(80 × 0.01) ≈ -103.2 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

T_A = -40 to +105 °C, 4.0 V ≤ V_{DD} = SMV_{DD0} = SMV_{DD1} ≤ 5.5 V, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 V (2/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, low	I _{OL1}	Per pin		T _A = -40 °C		52	mA			
				T _A = +25 °C		39	mA			
				T _A = +85 °C		32	mA			
				T _A = +105 °C		32	mA			
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		118	mA	
						T _A = +25 °C		118	mA	
						T _A = +85 °C		96	mA	
						T _A = +105 °C		96	mA	
				Group 3B		T _A = -40 °C		118	mA	
						T _A = +25 °C		118	mA	
						T _A = +85 °C		96	mA	
						T _A = +105 °C		96	mA	
				Group 3C	128-pin, 100-pin 80-pin		T _A = -40 °C		118	mA
							T _A = +25 °C		118	mA
							T _A = +85 °C		96	mA
							T _A = +105 °C		96	mA
					64-pin 48-pin		T _A = -40 °C		118	mA
							T _A = +25 °C		118	mA
							T _A = +85 °C		96	mA
							T _A = +105 °C		96	mA
Group 3D (128-pin, 100-pin, 80-pin)				T _A = -40 °C		118	mA			
				T _A = +25 °C		118	mA			
				T _A = +85 °C		96	mA			
				T _A = +105 °C		96	mA			
Group 3E (64-pin, 48-pin)		T _A = -40 °C		-148	mA					
		T _A = +25 °C		-118	mA					
		T _A = +85 °C		-96	mA					
		T _A = +105 °C		96	mA					

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.
 The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OL} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OL} = 118.0 mA
 Total output current of pins = (118.0 × 0.7)/(80 × 0.01) ≈ 103.2 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 4.0 \text{ V} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 5.5 \text{ V}, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V (3/3)}$

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit
Input voltage, high	V_{IH1}			$0.8SMV_{DD}$		SMV_{DD}	V
Input voltage, low	V_{IL1}			0		$0.5SMV_{DD}$	V
Input hysteresis width Note 1	V_{IHYS1}			0.1	0.19	0.29	V
Output voltage, high	V_{OH1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OH} = -52 \text{ mA}$	SMV_{DD} - 0.5		SMV_{DD}	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OH} = -39 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OH} = -32 \text{ mA}$				
		$T_A = +105 \text{ }^\circ\text{C}$	$I_{OH} = -32 \text{ mA}$				
Output voltage, low	V_{OL1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OL} = 52 \text{ mA}$	0		0.5	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OL} = 39 \text{ mA}$				
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OL} = 32 \text{ mA}$				
		$T_A = +105 \text{ }^\circ\text{C}$	$I_{OL} = 32 \text{ mA}$				
Output voltage deviation Note 2	V_{DEV}			0		50	mV
Input leakage current, high	I_{LIH1}	$V_i = SMV_{DD}$				1	μA
Input leakage current, low	I_{LIL1}	$V_i = SMV_{SS}$				-1	μA
On chip pull-up resistance Note 3	R_U	$V_i = SMV_{SS}$		10	20	100	$\text{k}\Omega$
On chip pull-down resistance Note 4	R_D	$V_i = SMV_{DD}$		100			$\text{k}\Omega$

- Notes**
- This specification is guaranteed by design. It is not tested when shipment.
 - Output voltage deviation defines the difference of the outputs levels of the same stepper motor.
 $V_{DEV} = \max(|V_{OHx} - V_{OHy}|, |V_{OLx} - V_{OLy}|) @ I_{OHx} = I_{OHy}, I_{OLx} = I_{OLy}$.
 X and y denote any combination of two pins of the following pin groups: (P80-P83, P84-P87, P90-P93, P94-P97)
 - Pull-up resistance is connected by software when pin is set to input mode.
 - LCD segment shared pins only. Pull-down resistance is connected during reset.

T_A = -40 to +105 °C, 2.7 V ≤ V_{DD} = SMV_{DD0} = SMV_{DD1} ≤ 4.0 V, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 V (1/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit			
Output current, high	I _{OH1}	Per pin		T _A = -40 °C		-30	mA			
				T _A = +25 °C		-25	mA			
				T _A = +85 °C		-23	mA			
				T _A = +105 °C		-22	mA			
	I _{OHTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		-90	mA	
				Group 3A		T _A = +25 °C		-75	mA	
				Group 3A		T _A = +85 °C		-69	mA	
				Group 3A		T _A = +105 °C		-66	mA	
				Group 3B		T _A = -40 °C		-90	mA	
				Group 3B		T _A = +25 °C		-75	mA	
				Group 3B		T _A = +85 °C		-69	mA	
				Group 3B		T _A = +105 °C		-66	mA	
				Group 3C	128-pin,		T _A = -40 °C		-90	mA
					100-pin		T _A = +25 °C		-75	mA
					80-pin		T _A = +85 °C		-69	mA
					80-pin		T _A = +105 °C		-66	mA
				Group 3C	64-pin		T _A = -40 °C		-90	mA
					48-pin		T _A = +25 °C		-75	mA
					48-pin		T _A = +85 °C		-69	mA
					48-pin		T _A = +105 °C		-66	mA
Group 3D				(128-pin, 100-pin, 80-pin)		T _A = -40 °C		-90	mA	
Group 3D				(128-pin, 100-pin, 80-pin)		T _A = +25 °C		-75	mA	
Group 3D				(128-pin, 100-pin, 80-pin)		T _A = +85 °C		-69	mA	
Group 3D				(128-pin, 100-pin, 80-pin)		T _A = +105 °C		-66	mA	
Group 3E		(64-pin, 48-pin)		T _A = -40 °C		-90	mA			
Group 3E		(64-pin, 48-pin)		T _A = +25 °C		-75	mA			
Group 3E		(64-pin, 48-pin)		T _A = +85 °C		-69	mA			
Group 3E		(64-pin, 48-pin)		T _A = +105 °C		-66	mA			

Note These output current values are obtained under the condition that the duty factor is no greater than 70%. The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OH} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OH} = -75.0 mA

Total output current of pins = (-75.0 × 0.7)/(80 × 0.01) ≈ -65.6 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

T_A = -40 to +105 °C, 2.7 V ≤ V_{DD} = SMV_{DD0} = SMV_{DD1} ≤ 4.0 V, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 V (2/3)

Parameter	Symbols	Conditions		Min.	Typ.	Max.	Unit		
Output current, low	I _{OL1}	Per pin		T _A = -40 °C		30	mA		
				T _A = +25 °C		23	mA		
				T _A = +85 °C		20	mA		
				T _A = +105 °C		17	mA		
	I _{OLTOTAL}	Total (for duty factors ≤ 70% ^{Note})		Group 3A		T _A = -40 °C		90	mA
						T _A = +25 °C		69	mA
						T _A = +85 °C		60	mA
						T _A = +105 °C		51	mA
				Group 3B		T _A = -40 °C		90	mA
						T _A = +25 °C		69	mA
						T _A = +85 °C		60	mA
						T _A = +105 °C		51	mA
				Group 3C	128-pin, 100-pin	T _A = -40 °C		90	mA
						T _A = +25 °C		69	mA
					80-pin	T _A = +85 °C		60	mA
						T _A = +105 °C		51	mA
				64-pin 48-pin	T _A = -40 °C		90	mA	
					T _A = +25 °C		69	mA	
					T _A = +85 °C		60	mA	
					T _A = +105 °C		51	mA	
Group 3D (128-pin, 100-pin, 80-pin)				T _A = -40 °C		90	mA		
				T _A = +25 °C		69	mA		
				T _A = +85 °C		60	mA		
				T _A = +105 °C		51	mA		
Group 3E (64-pin, 48-pin)		T _A = -40 °C		90	mA				
		T _A = +25 °C		69	mA				
		T _A = +85 °C		60	mA				
		T _A = +105 °C		51	mA				

Note These output current values are obtained under the condition that the duty factor is no greater than 70%.
 The output current values when the duty factor is changed to a value greater than 70% can be calculated from the following expression (when the duty factor is changed to n%).

- Total output current of pins (I_{OL} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OL} = 69.0 mA
 Total output current of pins = (69.0 × 0.7)/(80 × 0.01) ≈ 60.3 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq V_{DD} = SMV_{DD0} = SMV_{DD1} \leq 4.0 \text{ V}, V_{SS} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V (3/3)}$

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high	V_{IH1}		$0.8SMV_{DD}$		SMV_{DD}	V
Input voltage, low	V_{IL1}		0		$0.4SMV_{DD}$	V
Input hysteresis width Note 1	V_{IHYS1}		0.05		0.21	V
Output voltage, high	V_{OH1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OH} = -30 \text{ mA}$	SMV_{DD} -0.5	SMV_{DD}	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OH} = -25 \text{ mA}$			
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OH} = -23 \text{ mA}$			
		$T_A = +105 \text{ }^\circ\text{C}$	$I_{OH} = -22 \text{ mA}$			
Output voltage, low	V_{OL1}	$T_A = -40 \text{ }^\circ\text{C}$	$I_{OL} = 30 \text{ mA}$	0	0.5	V
		$T_A = +25 \text{ }^\circ\text{C}$	$I_{OL} = 23 \text{ mA}$			
		$T_A = +85 \text{ }^\circ\text{C}$	$I_{OL} = 20 \text{ mA}$			
		$T_A = +105 \text{ }^\circ\text{C}$	$I_{OL} = 17 \text{ mA}$			
Output voltage deviation Note 2	V_{DEV}		0		50	mV
Input leakage current, high	I_{LIH1}	$V_i = SMV_{DD}$			1	μA
Input leakage current, low	I_{LIL1}	$V_i = SMV_{SS}$			-1	μA
On chip pull-up resistance Note 3	R_U	$V_i = SMV_{SS}$	10	20	100	$\text{k}\Omega$
On chip pull-down resistance Note 4	R_D	$V_i = SMV_{DD}$	100			$\text{k}\Omega$

- Notes**
- This specification is guaranteed by design. It is not tested when shipment.
 - Output voltage deviation defines the difference of the outputs levels of the same stepper motor.
 $V_{DEV} = \max(|V_{OHx} - V_{OHy}|, |V_{OLx} - V_{OLy}|) @ I_{OHx} = I_{OHy}, I_{OLx} = I_{OLy}$.
 X and y denote any combination of two pins of the following pin groups: (P80-P83, P84-P87, P90-P93, P94-P97)
 - Pull-up resistance is connected by software when pin is set to input mode.
 - LCD segment shared pins only. Pull-down resistance is connected during reset.

4.4.4 Pin group 4 (OSC, reset and P137 pins)

T_A = -40 to +105 °C, 4.0 V ≤ V_{DD} ≤ 5.5 V, V_{SS} = 0 V

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit	
Input voltage, high	V _{IH1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.8V _{DD}		V _{DD}	V	
	V _{IH2}	$\overline{\text{RESET}}$	0.65V _{DD}		V _{DD}	V	
	V _{IH3}	P137	0.8V _{DD}		V _{DD}	V	
Input voltage, low	V _{IL1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0		0.2V _{DD}	V	
	V _{IL2}	$\overline{\text{RESET}}$	0		0.35V _{DD}	V	
	V _{IL3}	P137	0		0.5V _{DD}	V	
Input hysteresis width ^{Note 2}	V _{IHYS1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.1	0.7		V	
	V _{IHYS2}	$\overline{\text{RESET}}$	0.15	0.59	0.84	V	
Input leakage current, high	I _{LIH1}	P121, P122, P123, P124 V _I = V _{DD}	Port			1	μA
			EXCLK ^{Note 1}			1	μA
			OSC			10	μA
	I _{LIH2}	$\overline{\text{RESET}}$, V _I = V _{DD}				1	μA
	I _{LIH3}	P137, V _I = V _{DD}				1	μA
Input leakage current, low	I _{LIL1}	P121, P122, P123, P124 V _I = V _{SS}	Port			-1	μA
			EXCLK ^{Note 1}			-1	μA
			OSC			-10	μA
	I _{LIL2}	$\overline{\text{RESET}}$, V _I = V _{SS}				-1	μA
	I _{LIL3}	P137, V _I = V _{SS}				-1	μA

Notes 1. P122(EXCLK) only.

2. This specification is guaranteed by design. It is not tested when shipment.

T_A = -40 to +105 °C, 2.7 V ≤ V_{DD} ≤ 4.0 V, V_{SS} = 0 V

Parameter	Symbols	Conditions	Min.	Typ.	Max.	Unit
Input voltage, high	V _{IH1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.8V _{DD}		V _{DD}	V
	V _{IH2}	$\overline{\text{RESET}}$	0.7V _{DD}		V _{DD}	V
	V _{IH3}	P137	0.8V _{DD}		V _{DD}	V
Input voltage, low	V _{IL1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0		0.2V _{DD}	V
	V _{IL2}	$\overline{\text{RESET}}$	0		0.3V _{DD}	V
	V _{IL3}	P137	0		0.4V _{DD}	V
Input hysteresis width ^{Note 2}	V _{IHYS1}	P121, P122, P123, P124 (Port or EXCLK ^{Note 1})	0.08			V
	V _{IHYS2}	$\overline{\text{RESET}}$	0.08		0.53	V
Input leakage current, high	I _{LIH1}	P121, P122, P123, P124 V _I = V _{DD}	Port		1	μA
			EXCLK ^{Note 1}		1	μA
			OSC		10	μA
	I _{LIH2}	$\overline{\text{RESET}}$, V _I = V _{DD}			1	μA
	I _{LIH3}	P137, V _I = V _{DD}			1	μA
Input leakage current, low	I _{LIL1}	P121, P122, P123, P124 V _I = V _{SS}	Port		-1	μA
			EXCLK ^{Note 1}		-1	μA
			OSC		-10	μA
	I _{LIL2}	$\overline{\text{RESET}}$, V _I = V _{SS}			-1	μA
	I _{LIL3}	P137, V _I = V _{SS}			-1	μA

Notes 1. P122(EXCLK) only.

2. This specification is guaranteed by design. It is not tested when shipment.

4.5 AC characteristics

4.5.1 Basic operation

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$,

 $2.7 \text{ V} \leq \text{EV}_{\text{DD}0} = \text{EV}_{\text{DD}1} \leq \text{V}_{\text{DD}} = \text{SMV}_{\text{DD}0} = \text{SMV}_{\text{DD}1} \leq 5.5 \text{ V}$, $\text{V}_{\text{SS}} = \text{EV}_{\text{SS}0} = \text{EV}_{\text{SS}1} = \text{SMV}_{\text{SS}0} = \text{SMV}_{\text{SS}1} = 0 \text{ V}$

Parameter	Symbols	Conditions			Min.	Typ.	Max.	Unit
Instruction cycle (minimum instruction execution time)	t_{CY}	Main system clock operation (Including PLL)	High speed main run		0.04166 Note 1		1	μs
		Sub system clock operation	SDIV = 0		1/ f_{XT} (Typ. 30.5)			μs
External main system clock frequency	f_{EX}	Square wave input to EXCLK			2		20	MHz
External main system clock (square wave) input high/low level width	t_{EXH}	Square wave input to EXCLK			24			ns
	t_{EXL}							
Timer input high/low level width	t_{TIH} t_{TIL}	TI00 to TI07, TI10 to TI17, TI20 to TI27			1/ $f_{\text{MCK}}+10$ Note 2			ns
Port output frequency	f_{GPO}	P80 to P87, P90 to P97	C = 30 pF	$4.0 \text{ V} \leq \text{SMV}_{\text{DD}}$			2	MHz
		P20 to P27, P150 to P152	C = 30 pF	$4.0 \text{ V} \leq \text{V}_{\text{DD}}$			2	MHz
		P73, P135	C = 30 pF	$4.0 \text{ V} \leq \text{EV}_{\text{DD}}$			8	MHz
		Other than the above	C = 30 pF	$4.0 \text{ V} \leq \text{EV}_{\text{DD}}$ $2.7 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$			16 8	MHz MHz
External interrupt input high/low level width Note 3	t_{INIH} t_{INIL}	INTP0 to INTP5, INTPLR0, INTPLR1			1			μs
RESET input low level width Note 3	t_{RSL}	RESET			10			μs
Analog noise filter rejection pulse width Note 4	t_{WRJ}	INTP0 to INTP5, INTPLR0, INTPLR1, ADTRG			30	50	1000	ns
ADTRG input high level width	t_{ATH}	Without noise filter	AWC=0		1/ $f_{\text{CLK}}+10$			ns
			AWC=1		10			ns
		With noise filter	AWC=0		1/ $f_{\text{CLK}}+10$ or t_{WRJ} (Note 5)			ns
			AWC=1		t_{WRJ} (Note 5)			ns

- Notes**
- Value is in case of f_{CLK} is 24.0 MHz. It is also allowed to exceed frequency up to +3%.
 - f_{MCK} shows the frequency value of operation clock for TAU. Usually, f_{MCK} is defined by MHz but this specification is defined by ns. It is not defined by μs , so please be careful.
 - Pulses longer than this value will pass the input filter.
 - Pulses shorter than this value do not pass the input filters.
 - If the value of "1/ $f_{\text{CLK}}+10$ [ns]" is less than t_{WRJ} , please use t_{WRJ} value instead of "1/ $f_{\text{CLK}}+10$ [ns]".

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 4-1. AC Timing Test Points

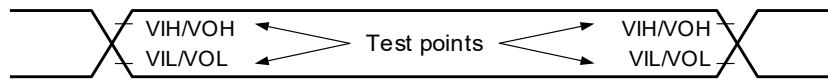


Figure 4-2. External Main System Clock Timing

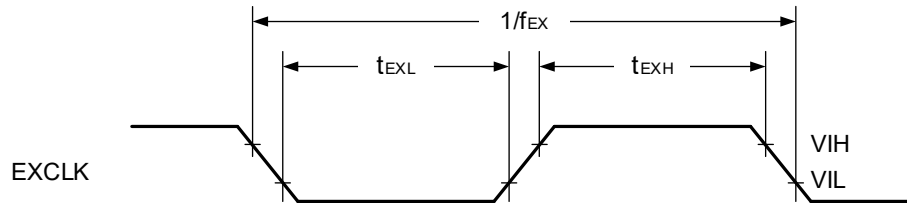


Figure 4-3. TI Timing

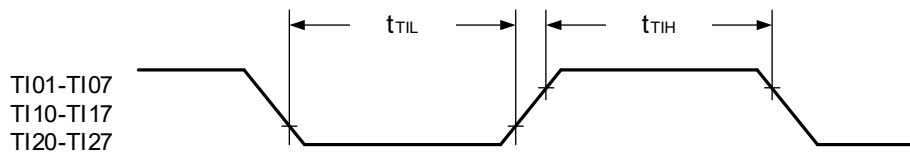


Figure 4-4. Interrupt Request Input Timing

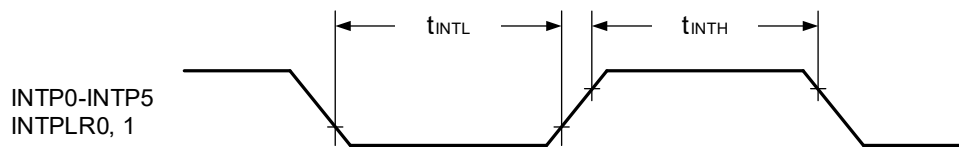
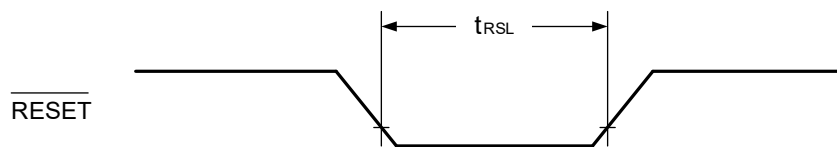


Figure 4-5. RESET Input Timing



4.5.2 Stepper motor controller/driver

 $T_A = -40$ to $+105$ °C, $2.7\text{ V} \leq \text{SMV}_{DD0} = \text{SMV}_{DD1} = V_{DD} \leq 5.5\text{ V}$, $V_{SS} = \text{SMV}_{SS0} = \text{SMV}_{SS1} = 0\text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
Meter Controller/Driver input frequency	f_{MC} ^{Note 1}				24	MHz	
PWM output rise time	t_R	10%-90% ^{Note 2}	$4.0\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	15	60	100	ns
			$2.7\text{ V} \leq \text{SMV}_{DD} \leq 4.0\text{ V}$	20		500	ns
PWM output fall time	t_F	10%-90% ^{Note 2}	$4.0\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	15	60	100	ns
			$2.7\text{ V} \leq \text{SMV}_{DD} \leq 4.0\text{ V}$	20		500	ns
Peak Cross Current ^{Note 3}	I_{CROSS}				50	ns	
Output Pulse Width ^{Note 4}	t_{MO}	$4.0\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	250			ns	
		$2.7\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	5000			ns	
Output Pulse Length Deviation ^{Note 5}	t_{SMDEV}	$4.0\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	-65	-12	+10	ns	
		$2.7\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$	-100		+400	ns	
Symmetry performance ^{Note 6}	ΔHSP_{mn}	$I_{OH} = -32\text{ mA}$ $\Delta\text{HSP}_{mn} = V_{OH}[(\text{SM}_{mn})_{\text{max}} - (\text{SM}_{mn})_{\text{min}}] $	$2.7\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$			50	mV
			$4.0\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$			50	mV
	ΔHSP_{mn}	$I_{OL} = 32\text{ mA}$ $\Delta\text{HSP}_{mn} = V_{OL}[(\text{SM}_{mn})_{\text{max}} - (\text{SM}_{mn})_{\text{min}}] $	$2.7\text{ V} \leq \text{SMV}_{DD} \leq 5.5\text{ V}$			100	mV

- Notes**
1. Source clock of the free-running counter.
 2. t_R, t_F is not tested in production, specified by design.
 3. The slew rate control generates a cross current in the output stage to control the energy of the external inductive load. The cross current flows only during the output transition time t_R, t_F . It flows in addition to the output current. The cross current is not tested, but derived from simulation.
 4. The output buffer can not generate high or low pulses shorter than this time, because of its slew rate control system. This value is not tested, but derived from simulation.
 5. The slew rate control function causes a deviation of output pulse time compared to the ideal selected output pulse setting. This value is not tested, but derived from simulation.
 6. Indicates the dispersion of 16 PWM output voltages. (4 buffers' output voltage differences in the state of $I_{OH}(I_{OL})$ at the same time.) Not tested in production, specified by design.

Remark m = 1 to 4, n = 1 to 4

4.5.3 Sound generator

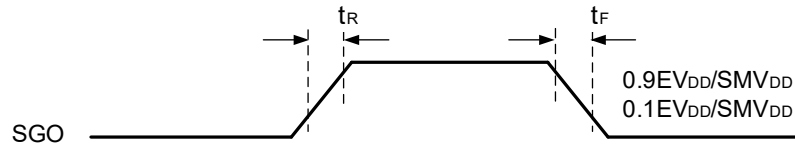
$T_A = -40$ to $+105$ °C,

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions		MIN.	TYP.	MAX.	Unit
Sound generator input frequency	f_{SG}					24	MHz
SGO output rise time	t_R	C = 100 pF	P73, P135			200	ns
			P93			500	ns
SGO output fall time	t_F	C = 100 pF	P73, P135			200	ns
			P93			500	ns

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Sound Generator Output Timing



4.5.4 Serial interface: CSI operation

<Master mode>

TA = -40 to +105 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
SCK cycle time	tkCY1	4.0 ≤ V _{DD}	167	tkCY1 ≥ 4/f _{CLK} ^{Note}	ns
		V _{DD} < 4.0 V	250		ns
SCK high/low level width	t _{KH1}	4.0 ≤ V _{DD}	tkCY1/2-12		ns
	t _{KL1}	V _{DD} < 4.0 V	tkCY1/2-18		ns
SI set up time	t _{SIK1}	4.0 ≤ V _{DD}	44		ns
		V _{DD} < 4.0 V	55		Ns
SI hold time	t _{KS1}		19		ns
SO output delay time	t _{KSO1}	C = 30 pF		25	ns

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

<Slave mode>

TA = -40 to +105 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

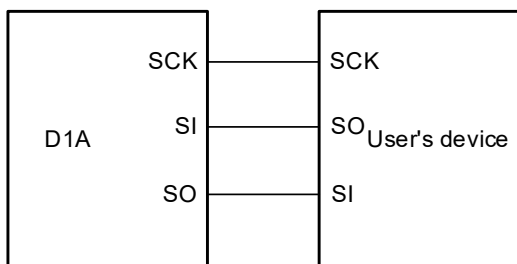
Items	Symbols	Conditions	Min.	Max.	Unit
SCK cycle time	tkCY2	4.0 ≤ EV _{DD}	20 MHz < f _{MCK}	8/f _{MCK}	ns
			f _{MCK} ≤ 20 MHz	6/f _{MCK}	ns
		EV _{DD} < 4.0 V	16 MHz < f _{MCK}	8/f _{MCK}	ns
			f _{MCK} ≤ 16 MHz	6/f _{MCK}	ns
SCK high/low level width	t _{KH2} t _{KL2}		tkCY2/2		ns
SI set up time	t _{SIK2}	2.7 ≤ EV _{DD}	1/f _{MCK} + 40		ns
SI hold time	t _{KSI2}		1/f _{MCK} + 62		ns
SO output delay time	t _{KSO2}	C = 30 pF		2/f _{MCK} + 44	ns
			4.0 ≤ EV _{DD} EV _{DD} < 4.0 V		2/f _{MCK} + 57 ns

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 4-6. CSI mode connection diagram

<master>



<slave>

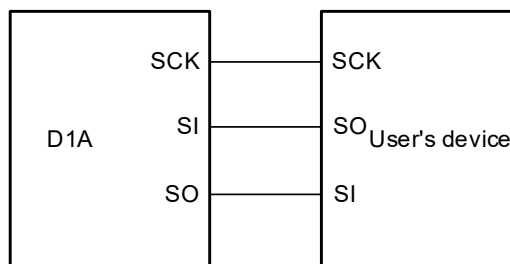


Figure 4-7. CSI mode serial transfer timing (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)

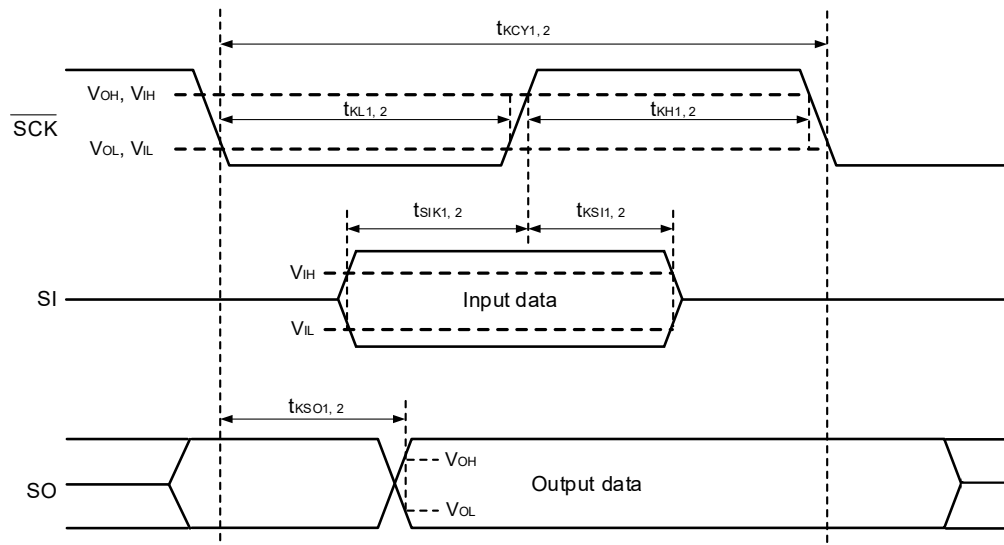
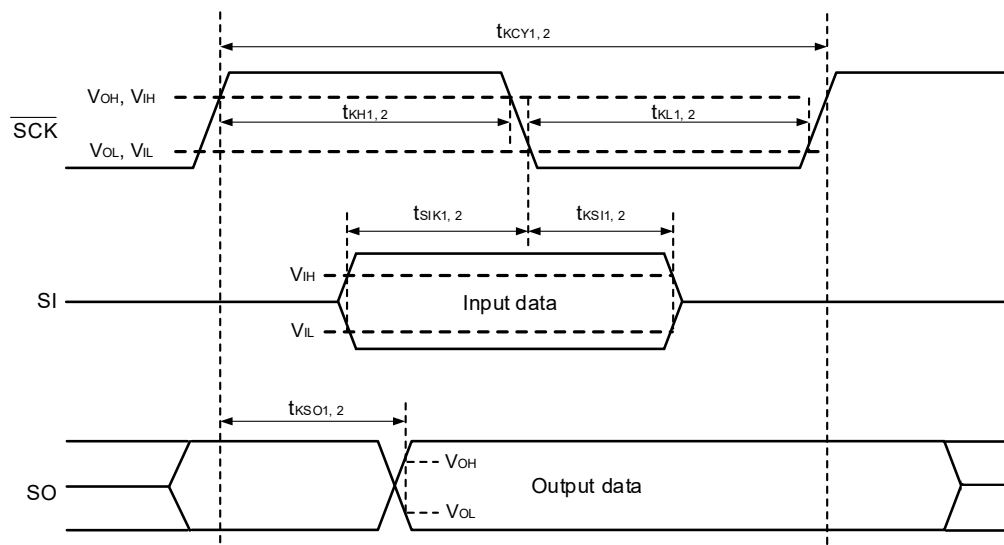


Figure 4-8. CSI mode serial transfer timing (When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)



4.5.5 Serial interface: UART operation (128-pin only)

$T_A = -40$ to $+105$ °C

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5\text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = 0\text{ V}$

Item	Symbol	Conditions	Min.	Max.	Unit
Transfer rate	T			$f_{MCK}/12$ ^{Note}	bps
		Theoretical value of the maximum transfer rate $f_{CLK} = 24\text{ MHz}$, $f_{MCK} = f_{CLK}$		2	Mbps

Note When CSI transfer is operated by DMA, it is necessary to consider DMA response time to decide cycle time.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 4-9 UART connection diagram

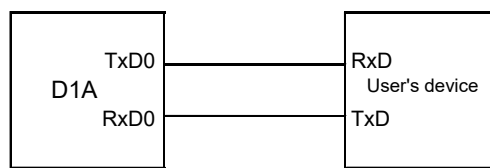
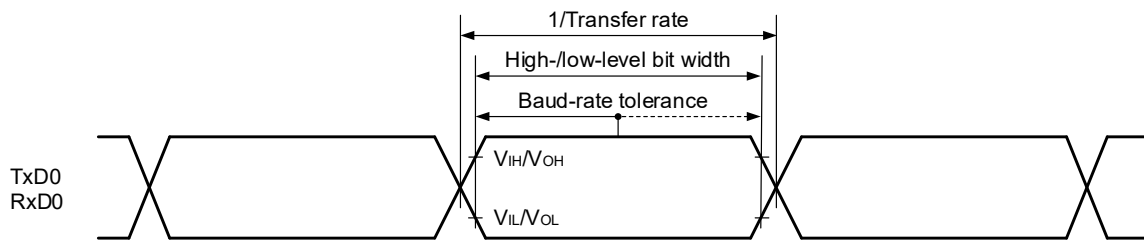


Figure 4-10. UART mode bit width (reference)



4.5.6 Serial interface: simplified I²C operation

T_A = -40 to +105 °C

2.7 V ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
SCL clock frequency	f _{SCL}	R _b = 3 kΩ, C _b = 100 pF		400	kHz
Hold time during SCL = "L"	t _{LOW}	R _b = 3 kΩ, C _b = 100 pF	1150		ns
Hold time during SCL = "H"	t _{HIGH}	R _b = 3 kΩ, C _b = 100 pF	1150		ns
Data set up time (reception)	t _{SU:DAT}	R _b = 3 kΩ, C _b = 100 pF	1/f _{MCK} +270		ns
Data hold time (transmission)	t _{HD:DAT}	R _b = 3 kΩ, C _b = 100 pF	0	355	ns

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 4-11 simplified I²C connection diagram

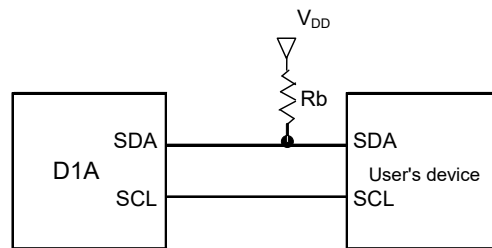
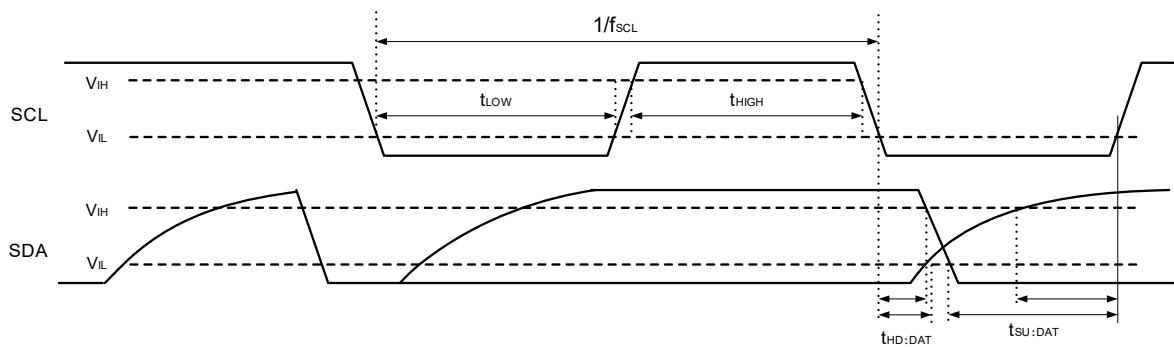


Figure 4-12. Simplified I²C mode serial transfer timing



4.5.7 Serial interface: LIN-UART(UARTF) operation

TA = -40 to +105 °C

2.7 V ≤ EVDD0 = EVDD1 ≤ VDD ≤ 5.5 V, VSS = EVSS0 = EVSS1 = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
Transfer rate	T			1.0	Mbps

Caution Different voltage between EVDD and VDD is allowed only when LCDM register is initial value.

4.5.8 Serial interface: CAN operation

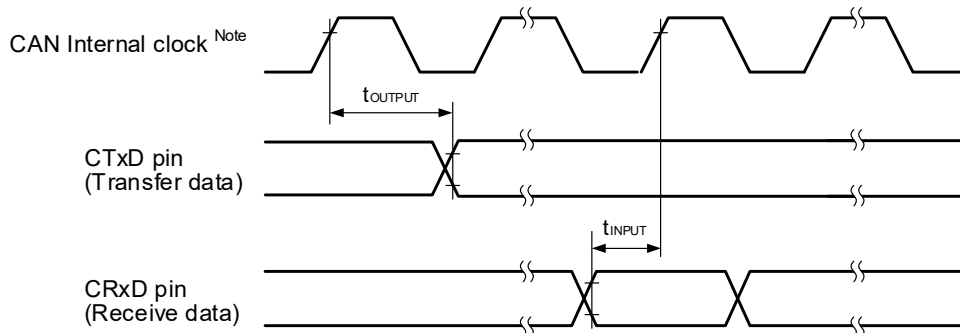
TA = -40 to +105 °C,

2.7 V ≤ EVDD0 = EVDD1 ≤ VDD ≤ 5.5 V, VSS = EVSS0 = EVSS1 = 0 V

Items	Symbols	Conditions	Min.	Max.	Unit
Transfer rate	T			1.0	Mbps
Internal delay time	t _{NODE}			100	ns
CRxD minimum pulse width for wake up	t _{CRXW}	Necessary width to detect wakeup signal	200		ns

Caution Different voltage between EVDD and VDD is allowed only when LCDM register is initial value.

Figure 4-13. Internal delay time of CAN



Internal delay time (t_{NODE}) = Internal Transfer Delay (t_{output}) + Internal Receive Delay (t_{input})

Note CAN Internal clock (f_{CAN}): CAN baud rate clock

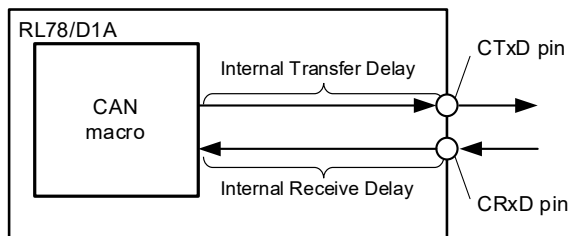


Image figure of Internal delay

4.6 LCD Bus Interface characteristics (128-pin products only)
 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq \text{EV}_{\text{DD}0} = \text{EV}_{\text{DD}1} \leq \text{V}_{\text{DD}} \leq 5.5 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS}0} = \text{EV}_{\text{SS}1} = 0 \text{ V}$

Items	Symbols	Conditions	MIN.	MAX.	Unit
Transfer frequency	F			8	MHz
CycleTime	t _{CYC}		LBCYC x T		ns
Control low pulse width	t _{CL}		(LBWST + 1)T - 1		ns
Enable active pulse width	t _{ELH}		(LBWST + 1)T - 5		ns
Control setup time	t _{RWS}		0.5T _s - 8		ns
Control hold time	t _{RWH}		0.5T - 3		ns
Data output setup time	t _{DOS}		0.5T _s - 6	0.5T _s + 17	ns
Data output hold time	t _{DOH}		{LBCYC - (LBWST + 1.5)} T - 27		ns
Data input setup time	t _{DIS}		50		ns
Data input hold time	t _{DIH}		0		ns
Output disable time	t _{OD}		0.5T - 14		ns

Remarks 1. $T = (1/f_{\text{CLK}}) \times n$ (n: LCD Bus Interface clock n divider setting)

2. $T_s = (1/f_{\text{CLK}}) \times N$ (N: LCD Bus Interface no clock divider N = 1, n divider N = n - 1)

3. $F = 1/t_{\text{CYC}}$

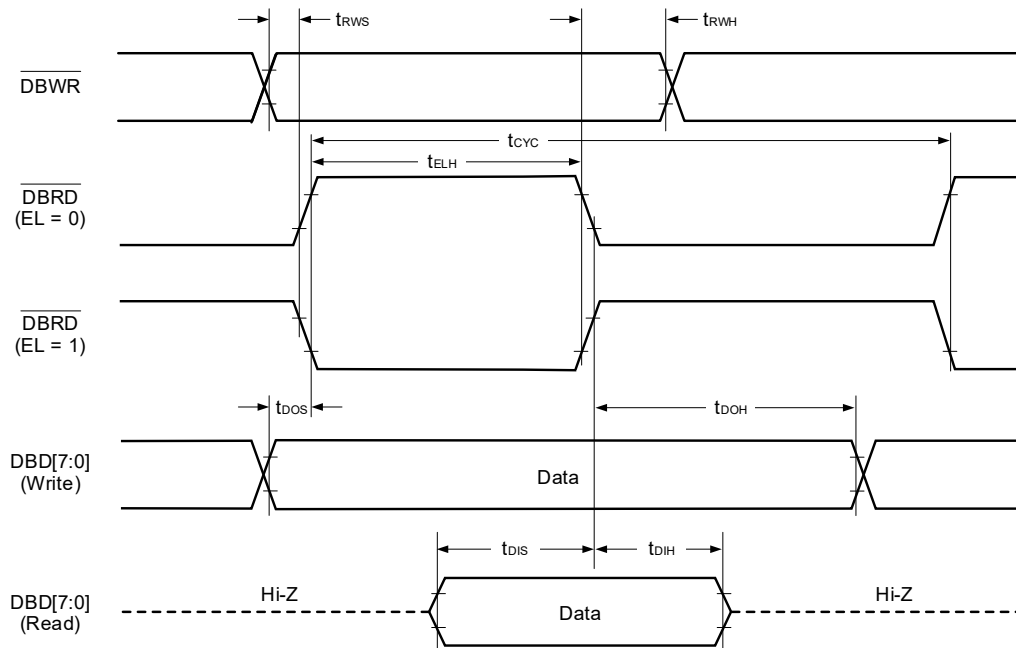
4. When $\text{EV}_{\text{DD}x} = \text{SMV}_{\text{DD}x} \leq \text{V}_{\text{DD}}$, LCD controller/driver related registers must be initial value (LCDON = 0, SCOC = 0, MDSET1 - 0 = 00, LCDPFx = 0).

5. The above table shows the timing of LCD bus interface with Schmitt1 input characteristic.

Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

Figure 4-14. LCD Bus Interface AC timing (1/2)

(a) LCDB mod68 mode timing



(b) mode68 turnaround timing

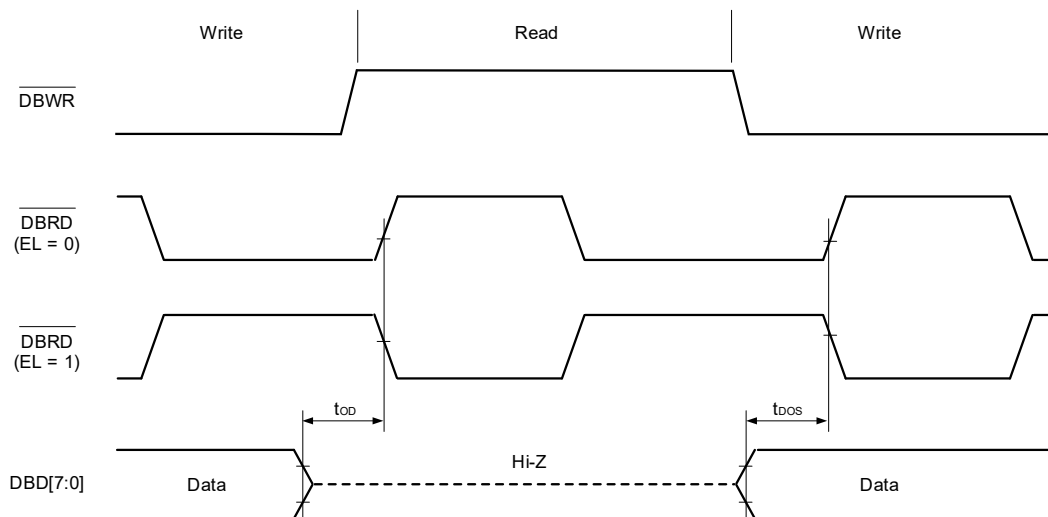
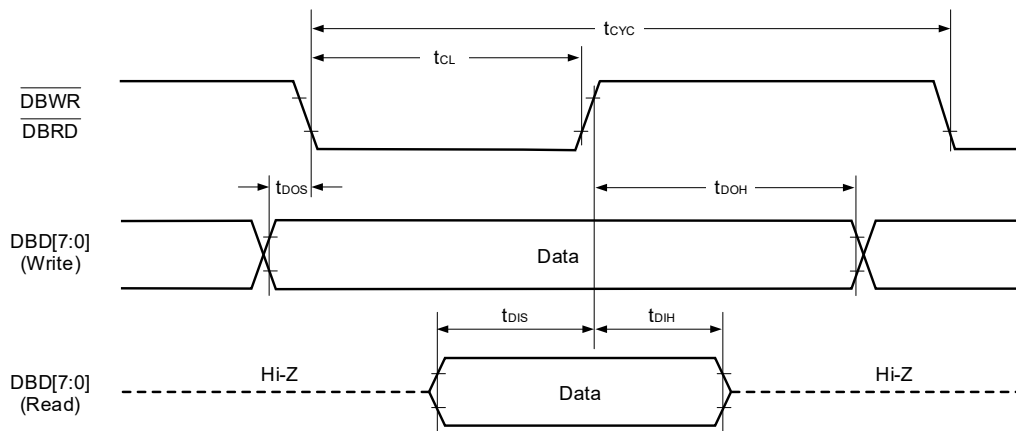
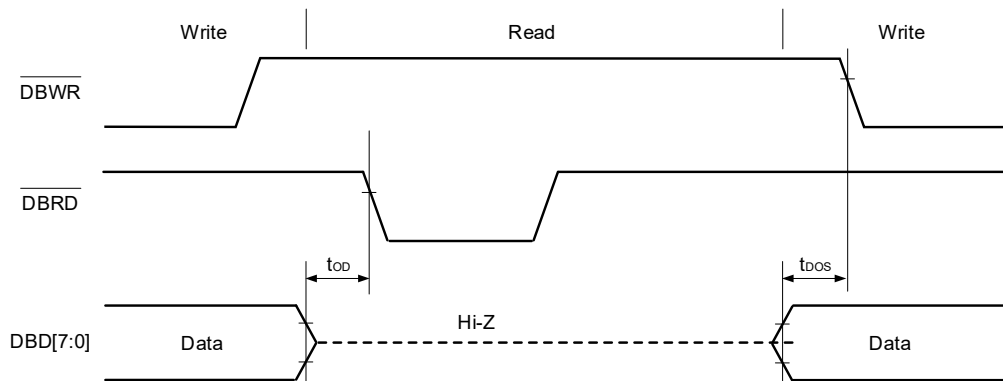


Figure 4-14. LCD Bus Interface AC timing (2/2)

(c) LCDB mod80 mode timing



(d) Mode80 turnaround timing



$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$, $3.2 \text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
LCD division resistance ^{Note 1}	R _{LCD}				3	kΩ
LCD Segment output voltage (unloaded)	V _{ODS}	I _o = ±1 μA	V _{LCDn} -0.05	V _{LCDn} ^{Note 2}	V _{LCDn} +0.05	V
LCD Common output voltage (unloaded)	V _{ODC}	I _o = ±1 μA	V _{LCDn} -0.05	V _{LCDn}	V _{LCDn} +0.05	V
LCD Segment Output Voltage (loaded)	V _{ODSL0}	I _o = ±10 μA, all segment pins at same time	V _{LCD0} -0.6	V _{LCD0}	V _{LCD0} +0.6	V
	V _{ODSL1}	I _o = ±10 μA, all segment pins at same time	V _{LCD1} -0.6	V _{LCD1}	V _{LCD1} +0.6	V
	V _{ODSL2}	I _o = ±10 μA, all segment pins at same time	V _{LCD2} -0.6	V _{LCD2}	V _{LCD2} +0.6	V
	V _{ODSL3}	I _o = ±10 μA, all segment pins at same time	V _{LCD3} -0.6	V _{LCD3}	V _{LCD3} +0.6	V
LCD Common Output Voltage (loaded)	V _{ODCL0}	I _o = ±40 μA, single pin	V _{LCD0} -0.2	V _{LCD0}	V _{LCD0} +0.2	V
	V _{ODCL1}	I _o = ±40 μA, single pin	V _{LCD1} -0.2	V _{LCD1}	V _{LCD1} +0.2	V
	V _{ODCL2}	I _o = ±40 μA, single pin	V _{LCD2} -0.2	V _{LCD2}	V _{LCD2} +0.2	V
	V _{ODCL3}	I _o = ±40 μA, single pin	V _{LCD3} -0.2	V _{LCD3}	V _{LCD3} +0.2	V
LCD split voltage drive capability ^{Note 1}	V _{LC0}	I _o = ±530 μA	V _{LCD0} -0.1	V _{LCD0}	V _{LCD0} +0.1	V
	V _{LC1}	I _o = ±530 μA	V _{LCD1} -0.1	V _{LCD1}	V _{LCD1} +0.1	V
	V _{LC2}	I _o = ±530 μA	V _{LCD2} -0.1	V _{LCD2}	V _{LCD2} +0.1	V
	V _{LC3}	I _o = ±530 μA	V _{LCD3} -0.1	V _{LCD3}	V _{LCD3} +0.1	V
LCD output resistance (COM) ^{Note 3}	R _{ODC}				8	kΩ
LCD output resistance (SEG) ^{Note 3}	R _{ODS}				8	kΩ

Notes 1. Only internal connection. The value is design specification.

- 2.** V_{LCDn} (n= 0..3) represents one of the four possible voltage levels at the LCD pins. See table below for reference.

V _{LCDn}	no step-down transforming	step-down transforming
V _{LCD0}	V _{DD}	3/5 V _{DD}
V _{LCD1}	2/3 V _{DD}	2/5 V _{DD}
V _{LCD2}	1/3 V _{DD}	1/5 V _{DD}
V _{LCD3}	V _{SS}	V _{SS}

- 3.** R_{ODC} is internal equivalent weight resistance from COM pin + COM IOBUF resistance.
R_{ODS} is internal equivalent weight resistance from SEG pin +SEG IOBUF resistance.

$T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$, $2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5 \text{ V}$, $V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0 \text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
LCD division resistance <small>Note 1</small>	R _{LCD}				3	kΩ
LCD Segment output voltage (unloaded)	V _{ODS}	$I_o = \pm 1 \mu\text{A}$	$V_{LCDn}-0.05$	V_{LCDn} <small>Note 2</small>	$V_{LCDn}+0.05$	V
LCD Common output voltage (unloaded)	V _{ODC}	$I_o = \pm 1 \mu\text{A}$	$V_{LCDn}-0.05$	V_{LCDn}	$V_{LCDn}+0.05$	V
LCD Segment Output Voltage (loaded)	V _{ODSL0}	$I_o = \pm 5 \mu\text{A}$, all segment pins at same time	$V_{LCD0}-0.6$	V_{LCD0}	$V_{LCD0}+0.6$	V
	V _{ODSL1}	$I_o = \pm 5 \mu\text{A}$, all segment pins at same time	$V_{LCD1}-0.6$	V_{LCD1}	$V_{LCD1}+0.6$	V
	V _{ODSL2}	$I_o = \pm 5 \mu\text{A}$, all segment pins at same time	$V_{LCD2}-0.6$	V_{LCD2}	$V_{LCD2}+0.6$	V
	V _{ODSL3}	$I_o = \pm 5 \mu\text{A}$, all segment pins at same time	$V_{LCD3}-0.6$	V_{LCD3}	$V_{LCD3}+0.6$	V
LCD Common Output Voltage (loaded)	V _{ODCL0}	$I_o = \pm 25 \mu\text{A}$, single pin	$V_{LCD0}-0.2$	V_{LCD0}	$V_{LCD0}+0.2$	V
	V _{ODCL1}	$I_o = \pm 25 \mu\text{A}$, single pin	$V_{LCD1}-0.2$	V_{LCD1}	$V_{LCD1}+0.2$	V
	V _{ODCL2}	$I_o = \pm 25 \mu\text{A}$, single pin	$V_{LCD2}-0.2$	V_{LCD2}	$V_{LCD2}+0.2$	V
	V _{ODCL3}	$I_o = \pm 25 \mu\text{A}$, single pin	$V_{LCD3}-0.2$	V_{LCD3}	$V_{LCD3}+0.2$	V
LCD split voltage drive capability	V _{LC0}	$I_o = \pm 530 \mu\text{A}$	$V_{LCD0}-0.1$	V_{LCD0}	$V_{LCD0}+0.1$	V
	V _{LC1}	$I_o = \pm 530 \mu\text{A}$	$V_{LCD1}-0.1$	V_{LCD1}	$V_{LCD1}+0.1$	V
	V _{LC2}	$I_o = \pm 530 \mu\text{A}$	$V_{LCD2}-0.1$	V_{LCD2}	$V_{LCD2}+0.1$	V
	V _{LC3}	$I_o = \pm 530 \mu\text{A}$	$V_{LCD3}-0.1$	V_{LCD3}	$V_{LCD3}+0.1$	V
LCD output resistance (COM) <small>Note 3</small>	R _{ODC}				10	kΩ
LCD output resistance (SEG) <small>Note 3</small>	R _{ODS}				10	kΩ

Notes 1. V_{LCDn} ($n= 0..3$) represents one of the four possible voltage levels at the LCD pins. See table below for reference.

V_{LCDn}	no step-down transforming
V_{LCD0}	V_{DD}
V_{LCD1}	$2/3 V_{DD}$
V_{LCD2}	$1/3 V_{DD}$
V_{LCD3}	V_{SS}

- Only internal connection. The value is design specification.
- R_{ODC} is internal equivalent weight resistance from COM pin + COM IOBUF resistance.
R_{ODS} is internal equivalent weight resistance from SEG pin +SEG IOBUF resistance.

4.7 Analog characteristics

4.7.1 A/D converter characteristics

$T_A = -40$ to $+105$ °C, $2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$, $V_{SS} = 0\text{ V}$
Reference voltage (+) = AV_{REFP} , Reference voltage(-) = AV_{REFM}

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
Resolution	RES		8		10	Bit	
Overall error ^{Note 1,2}	AINL	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$		1.2	± 3.5	LSB	
Conversion time	Tconv	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$	$3.6\text{ V} \leq V_{DD} < 5.5\text{ V}$	2.125		39	μs
			$2.7\text{ V} \leq V_{DD} < 5.5\text{ V}$	3.1875		39	μs
Zero-scale error ^{Note 1, 2}	Ezs	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$			0.25	%FSR	
Full-scale error ^{Note 1, 2}	Efs	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$			0.25	%FSR	
Integral non-linearity error ^{Note 1}	ILE	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$			± 2.5	LSB	
Differential non-linearity error ^{Note 1}	DLE	10 bit Resolution $AV_{REFP} = V_{DD}$ ^{Note 3} $AV_{REFM} = 0\text{ V}$			± 1.5	LSB	
REF voltage(+)	AV_{REFP}		2.7		V_{DD}	V	
REF voltage(-)	AV_{REFM}		V_{SS}			V	
Analog input voltage	V_{AIN}		AV_{REFM}		AV_{REFP}	V	
REF supply Current	I_{REF}	$AV_{REFP} = 3\text{ V}$		38	60	μA	
		$AV_{REFP} = 5\text{ V}$		63	100	μA	

- Notes**
1. Excludes quantization error ($\pm 1/2$ LSB).
 2. This value is indicated as a ratio (%FSR) to the full-scale value.
 3. Minimum $V_{DD} - 0.5\text{ V}$ is allowed for AV_{REFP} to keep characteristic values

Remark When reference voltage(+) is not AV_{REFP} pin or reference voltage(-) is not AV_{REFM} pin, the accuracy will become worse.
Renesas recommends to use A/D converter with AV_{REFP} and AV_{REFM} though other reference can be functionally selected.

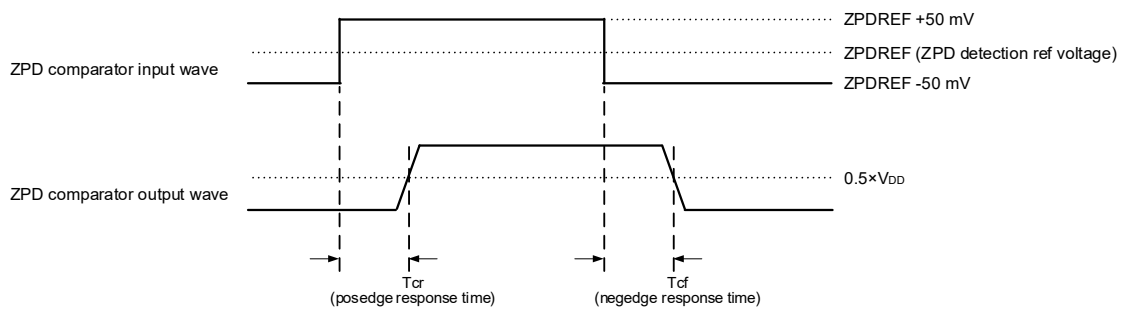
4.7.2 ZPD characteristics

$T_A = -40$ to $+105$ °C,

$2.7\text{ V} \leq EV_{DD0} = EV_{DD1} = SMV_{DD0} = SMV_{DD1} = V_{DD} \leq 5.5\text{ V}, V_{SS} = EV_{SS0} = EV_{SS1} = SMV_{SS0} = SMV_{SS1} = 0\text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Threshold voltage	V_{ZPD}	0 Point detection voltage set = 000	6/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 001	10/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 010	14/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 011	18/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 100	22/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 101	9/200*SMV _{DD} ±40 mv			V
		0 Point detection voltage set = 110	11/200*SMV _{DD} ±40 mv			V
Detection delay	T_{ZPDD}	100 mV Step, 50 mV Overdrive (refer to the below figure)	$SMV_{DD} = 4.75\text{ V to } 5.25\text{ V}$		100	ns
			$SMV_{DD} = 2.7\text{ V to } 5.5\text{ V}$		100	ns
Operation Stabilization wait time	T_{ZPDW}	Ref voltage Stabilization +ZPD comparator Stabilization			1+5 = 6	μs

Figure 4-15. ZPD timing



4.7.3 POR characteristics

T_A = -40 to +105 °C

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	V _{POR}		1.45	1.51	1.57	V
	V _{PDR}		1.44	1.5	1.56	V
Detection delay	T _{PD}				300	μs
Minimum pulse width	T _{PW}	Necessary width of internal voltage drop down below V _{PDR}	300			μs

Caution LVD reset or external RESET must be used during power supply rising up to 2.7 V.

4.7.4 LVD characteristics

T_A = -40 to +105 °C, V_{PDR} ≤ EV_{DD0} = EV_{DD1} ≤ V_{DD} ≤ 5.5 V, V_{SS} = EV_{SS0} = EV_{SS1} = 0 V

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit	
RESET and INTMODE	V _{LV15}	VPOC0,1,2 = 0,1,1 Power down Reset Voltage: 2.7 V	2.70	2.75	2.81	V	
	V _{LV14}	LVIS0,1 = 1,0 (+0.1 V)	Power on Reset Release Voltage	2.86	2.92	2.97	V
			Power down Interrupt Voltage	2.80	2.86	2.91	V
	V _{LV13}	LVIS0,1 = 0,1 (+0.2 V)	Power on Reset Release Voltage	2.96	3.02	3.08	V
			Power down Interrupt Voltage	2.90	2.96	3.02	V
	V _{LV10}	LVIS0,1 = 0,0 (+1.2 V)	Power on Reset Release Voltage	3.98	4.06	4.14	V
Power down Interrupt Voltage			3.90	3.98	4.06	V	
Detection Delay time	T _{LD}				200	μs	
Minimum pulse width	T _{LW}	Necessary width of V _{DD} drop down below selected V _{LVix} (x = 0, 3 to 5)	300			μs	

Caution LVD reset or external RESET must be used during power supply rising up to 2.7 V.

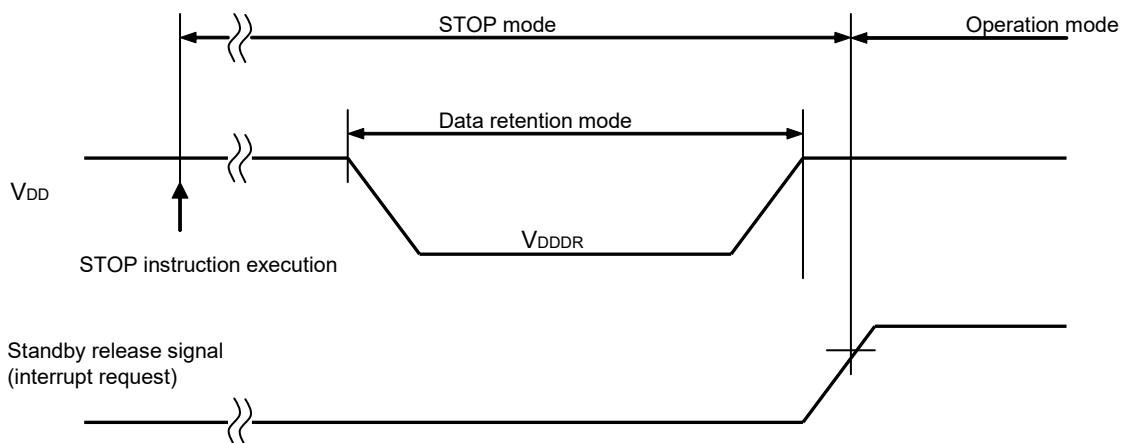
4.8 Data Retention Characteristics

T_A = -40 to +105 °C

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	V _{DDDR}		1.44 ^{Note1}		5.5	V

Note The value depends on the POR detection voltage. When the voltage drops, the data is retained until a POR reset is effected, but data is not retained when a POR reset is effected.

Figure 4-16. STOP Mode Data Retention timing



4.9 Capacitance Connected to REGC

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
Capacitance	C _{REG}		0.47		1.0	μF

4.10 Flash programming characteristics

 $T_A = -40 \text{ to } +105 \text{ }^\circ\text{C}, 2.7 \text{ V} \leq EV_{DD0} = EV_{DD1} \leq V_{DD} \leq 5.5 \text{ V}, V_{SS} = EV_{SS0} = EV_{SS1} = 0 \text{ V}$

Items	Symbols	Conditions	MIN.	TYP.	MAX.	Unit
V _{DD} supply current	I _{DD}	Programming current			12.2	mA
System Clcok frequency	f _{CLK}	2.7 V ≤ V _{DD} ≤ 5.5 V	2		24	MHz
Number of Code Flash rewrites ^{Notes 1, 2, 3}	Cerwr	Retained for 20 years, T _A = +85 °C ^{Note 4}	1000			Times
Number of Data Flash rewrites ^{Notes 1, 2, 3}	Cerwr	Retained for 20 years, T _A = +85 °C ^{Note 4}	10000			Times

- Notes 1.** 1 erase + 1 write after the erase is regarded as 1 rewrite.
The retaining years are until next rewrite after the rewrite.
- 2.** When using flash memory programmer and Renesas Electronics self programming library
- 3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.
- 4.** The specified data retention time is given under the condition that the average temperature (T_A) is 85°C or below.

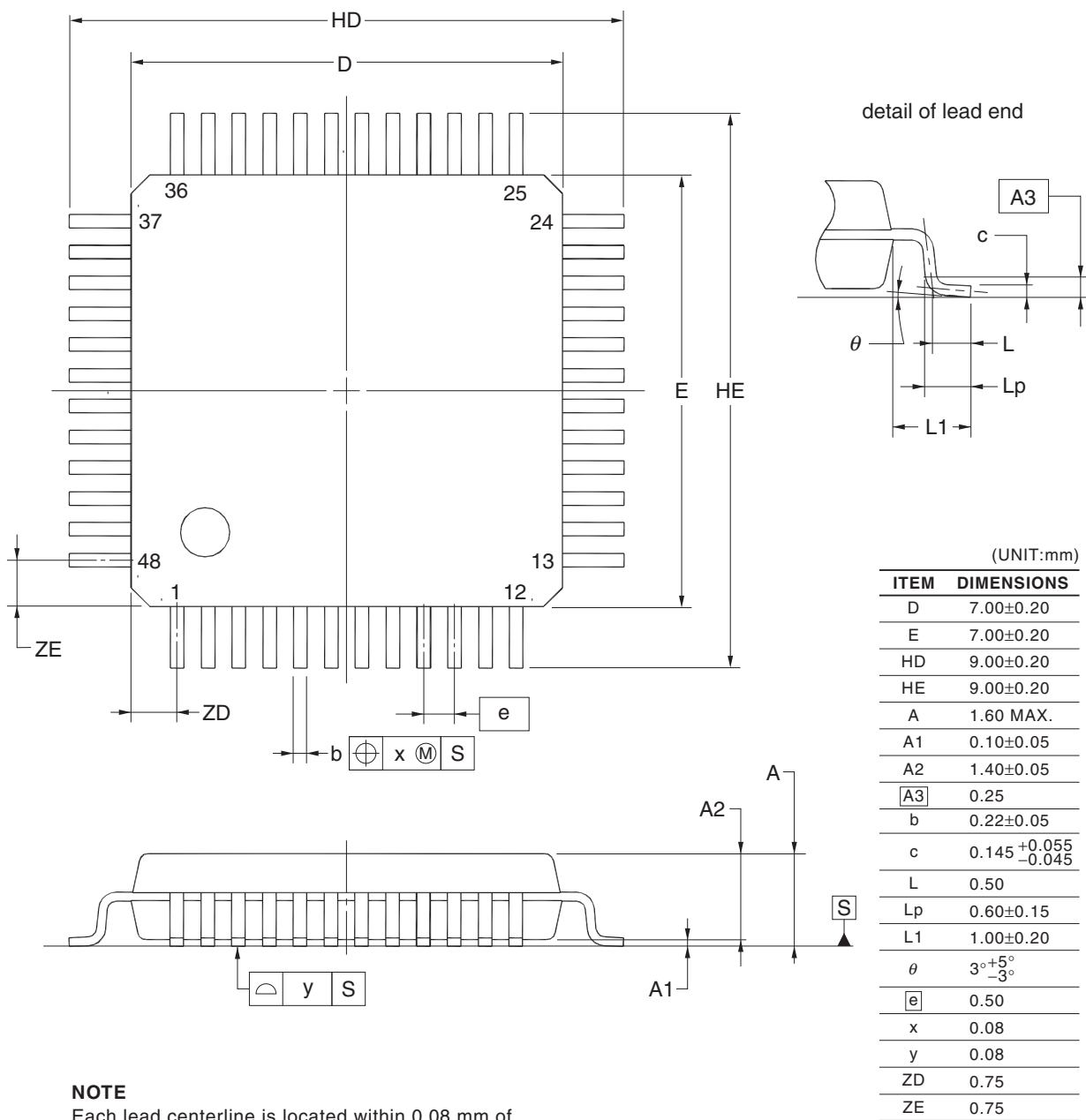
Caution Different voltage between EV_{DD} and V_{DD} is allowed only when LCDM register is initial value.

5. PACKAGE DRAWINGS

5.1 48-pin products

R5F10CGBxFB, R5F10CGCxFB, R5F10CGDxFB, R5F10DGCxFB, R5F10DGDxFB, R5F10DGExFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP48-7x7-0.50	PLQP0048KF-A	P48GA-50-8EU-1	0.16

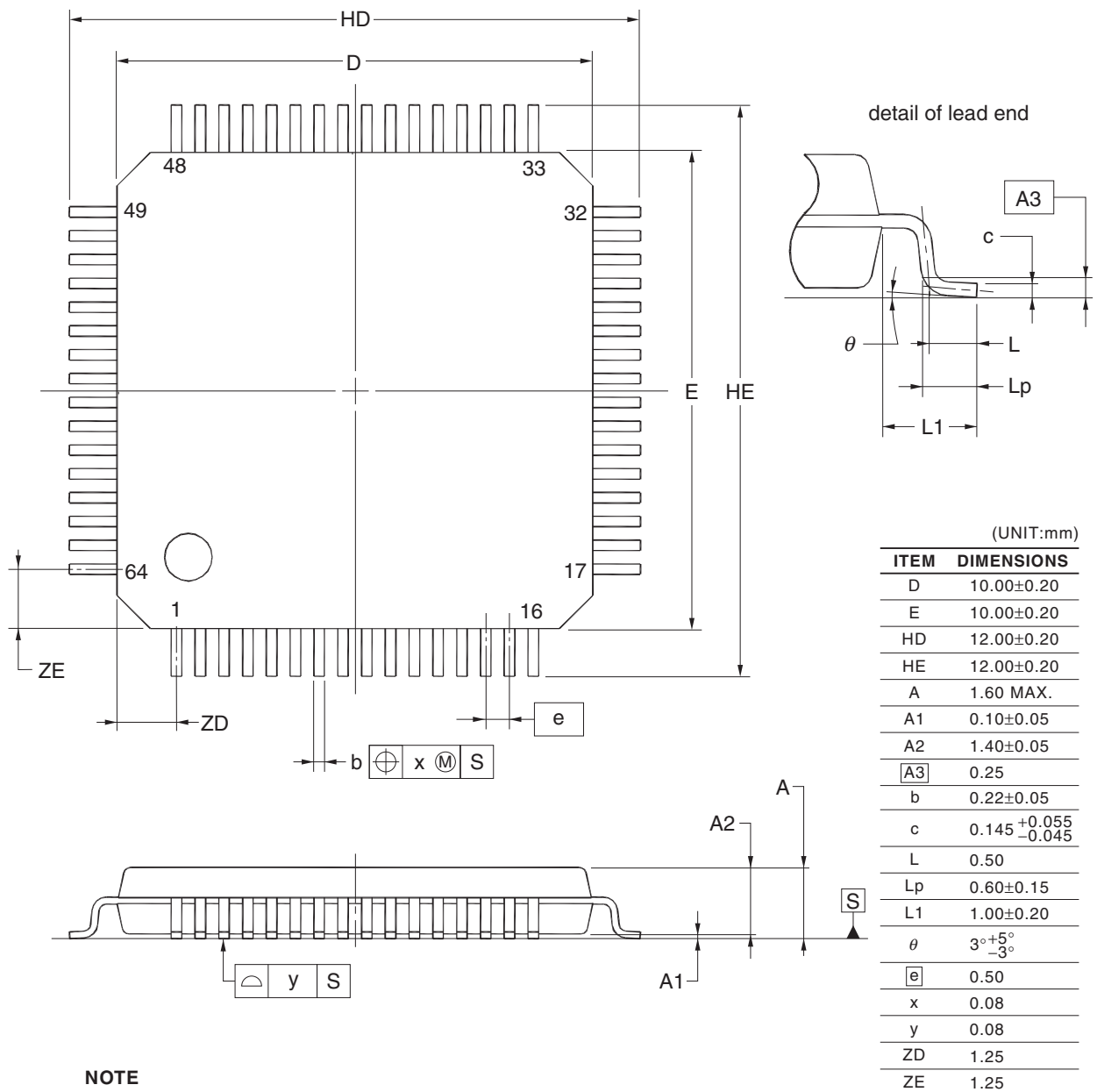


NOTE
Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

5.2 64-pin products

R5F10CLDxFB, R5F10DLDxFB, R5F10DLExFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP64-10x10-0.50	PLQP0064KF-A	P64GB-50-UEU-2	0.35

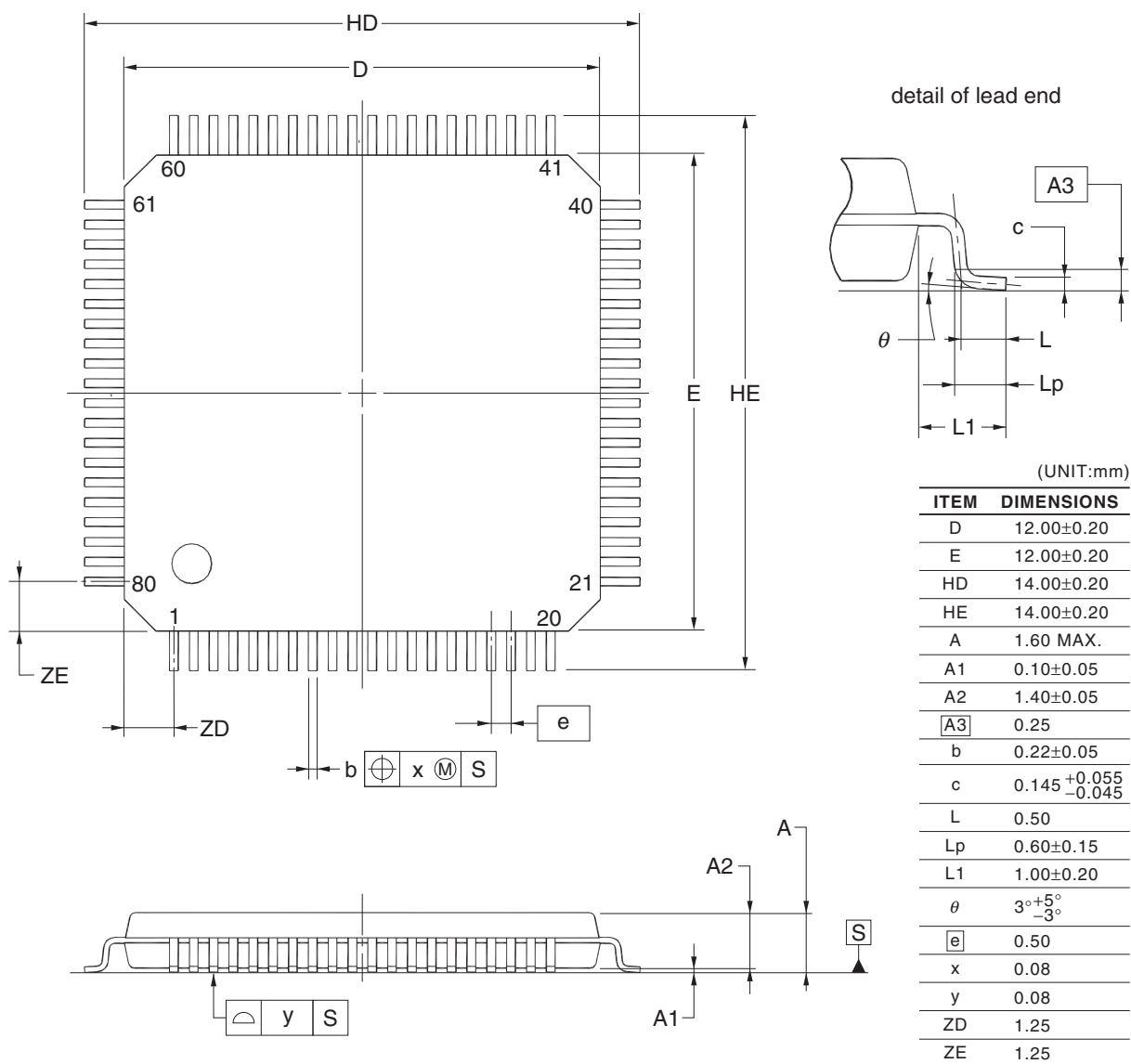


NOTE
Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

5.3 80-pin products

R5F10CMDxFB, R5F10CMExFB, R5F10DMDxFB, R5F10DMExFB, R5F10DMFxFB, R5F10DMGxFB, R5F10DMJxFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP80-12x12-0.50	PLQP0080KE-A	P80GK-50-8EU-2	0.53

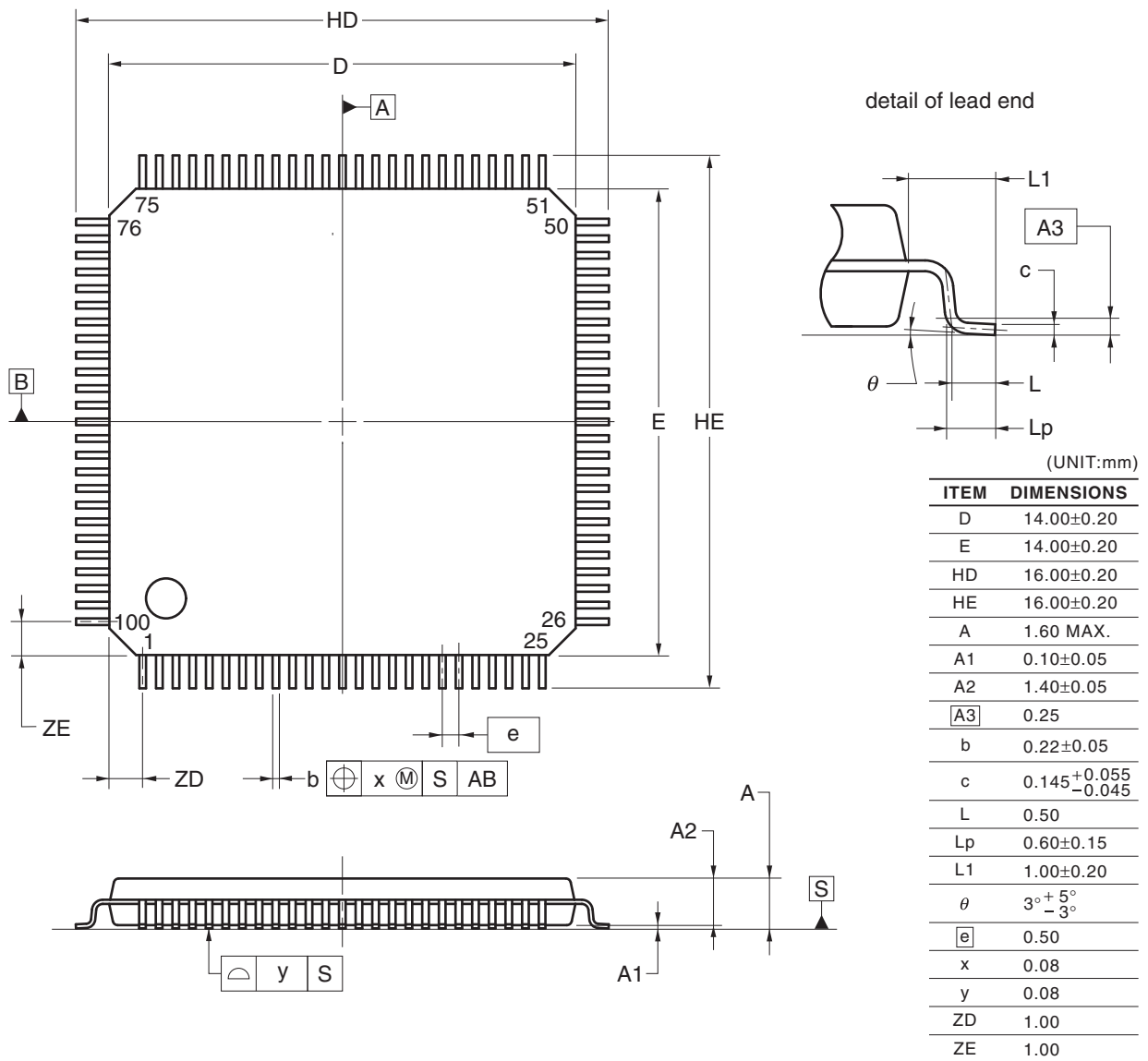


NOTE
Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

5.4 100-pin products

R5F10DPExFB, R5F10DPFxFB, R5F10DPGxFB, R5F10TPJxFB, R5F10DPJxFB, R5F10DPLxFB, R5F10DPKxFB

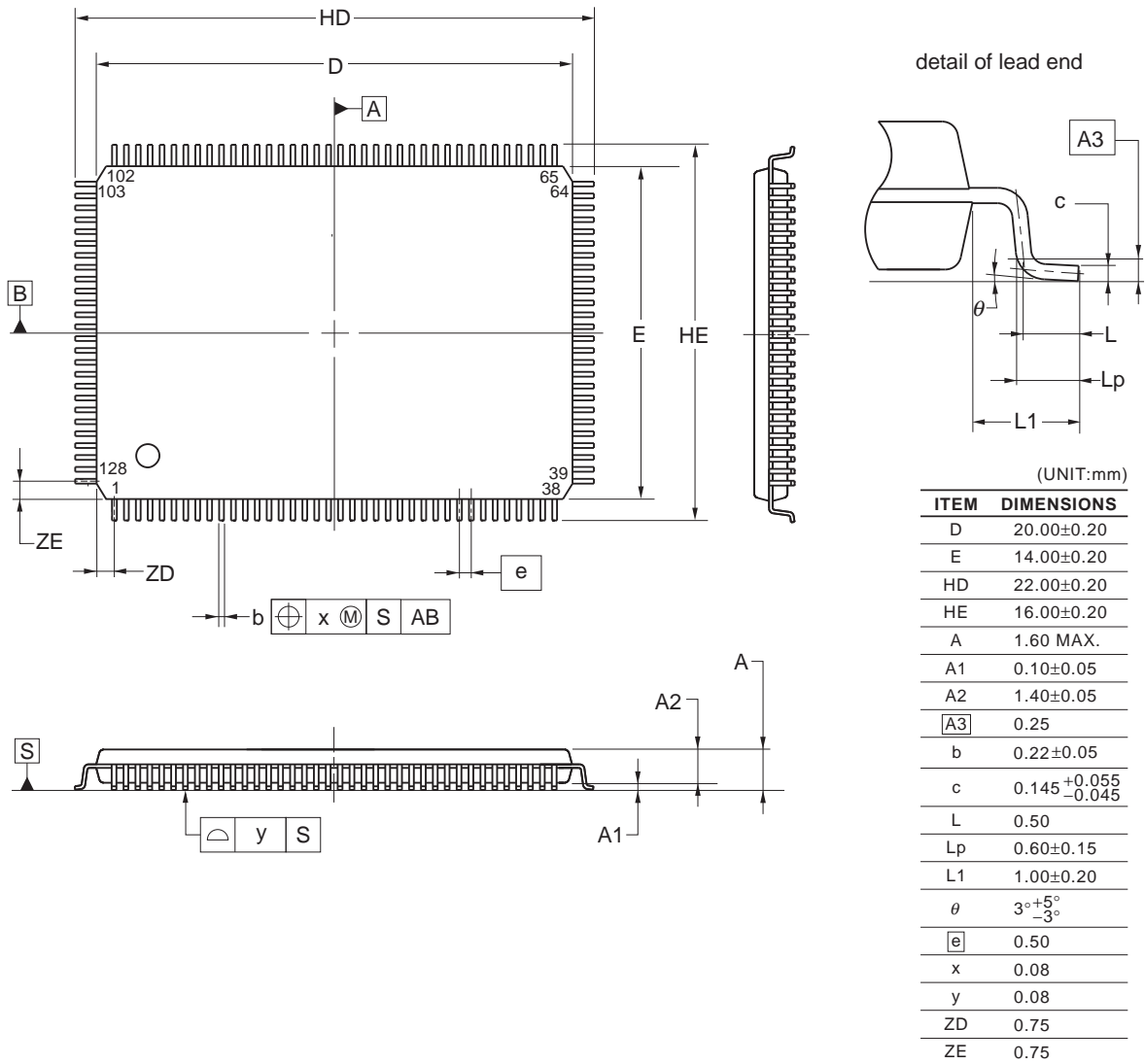
JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP100-14x14-0.50	PLQP0100KE-A	P100GC-50-GBR-1	0.69



5.5 128-pin products

R5F10DSJxFB, R5F10DSKxFB, R5F10DSLxFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP128-14x20-0.50	PLQP0128KD-A	P128GF-50-GBP-1	0.92



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REVISION HISTORY	RL78/D1A Datasheet
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Rev	Date	Description	
		Page	Summary
1.10	Dec 27, 2024	-	First edition issued.

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General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity.

Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (Max.) and V_{IH} (Min.).

7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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